RENESAS

RL78/G1A RENESAS MCU

R01DS0151EJ0210 Rev.2.10 Nov 30, 2016

Combines Multi-channel 12-Bit A/D Converter, True Low Power Platform (as low as 66 μ A/MHz, and 0.57 μ A for RTC + LVD), 1.6 V to 3.6 V operation, 16 to 64 Kbyte Flash, 41 DMIPS at 32 MHz

1. OUTLINE

1.1 Features

Ultra-Low Power Technology

- 1.6 V to 3.6 V operation from a single supply
- Stop (RAM retained): 0.23 μ A, (LVD enabled): 0.31 μ A
- Halt (RTC + LVD): 0.57 μA
- Snooze: 0.7 mA (UART), 0.6 mA (ADC)
- Operating: 66 µA/MHz

16-bit RL78 CPU Core

- Delivers 41 DMIPS at maximum operating frequency of 32 MHz
- Instruction Execution: 86% of instructions can be executed in 1 to 2 clock cycles
- CISC Architecture (Harvard) with 3-stage pipeline
- Multiply Signed & Unsigned: 16 x 16 to 32-bit result in 1 clock cycle
- MAC: 16 x 16 to 32-bit result in 2 clock cycles
- 16-bit barrel shifter for shift & rotate in 1 clock cycle
- 1-wire on-chip debug function

Code Flash Memory

- Density: 16 KB to 64 KB
- Block size: 1 KB
- On-chip single voltage flash memory with protection from block erase/writing
- Self-programming with secure boot swap function and flash shield window function

Data Flash Memory

- Data Flash with background operation
- Data flash size: 4 KB
- Erase Cycles: 1 Million (typ.)
- Erase/programming voltage: 1.8 V to 3.6 V

RAM

- 2 KB to 4 KB size options
- Supports operands or instructions
- Back-up retention in all modes

High-speed On-chip Oscillator

- 32 MHz with +/- 1% accuracy over voltage (1.8 V to 3.6 V) and temperature (-20 °C to +85 °C)
- Pre-configured settings: 32 MHz, 24 MHz, 16 MHz, 12 MHz, 8 MHz, 6 MHz, 4 MHz, 3 MHz, 2 MHz, and 1 MHz

Reset and Supply Management

- Power-on reset (POR) monitor/generator
- Low voltage detection (LVD) with 12 setting options (Interrupt and/or reset function)

Data Memory Access (DMA) Controller

- Up to 2 fully programmable channels
- Transfer unit: 8- or 16-bit

Multiple Communication Interfaces

- Up to 6 x I²C master
- Up to 1 x I²C multi-master
- Up to 6 x CSI/SPI (7-, 8-bit)
- Up to 3 x UART (7-, 8-, 9-bit)
- Up to 1 x LIN

Extended-Function Timers

- Multi-function 16-bit timers: Up to 8 channels
- Real-time clock (RTC): 1 channel (full calendar and alarm function with watch correction function)
- Interval Timer: 12-bit, 1 channel
- 15 kHz watchdog timer: 1 channel (window function)

Rich Analog

- ADC: Up to 28 channels, 12-bit resolution, 3.375 μ s conversion time
- Supports 1.6 V
- Internal voltage reference (1.45 V)
- On-chip temperature sensor

Safety Features (IEC or UL 60730 compliance)

- Flash memory CRC calculation
- RAM parity error check
- RAM write protection
- SFR write protection
- Illegal memory access detection
- Clock stop/ frequency detection
 ADC self-test

General Purpose I/O

- 3.6 V tolerant, high-current (up to 20 mA per pin)
- Open-Drain, Internal Pull-up support

Operating Ambient Temperature

- Standard: –40 °C to +85 °C
- Extended: -40 °C to +105 °C

Package Type and Pin Count

From 3 mm x 3 mm to 10 mm x 10 mm QFP: 48, 64 QFN: 32, 48 LGA: 25 BGA: 64



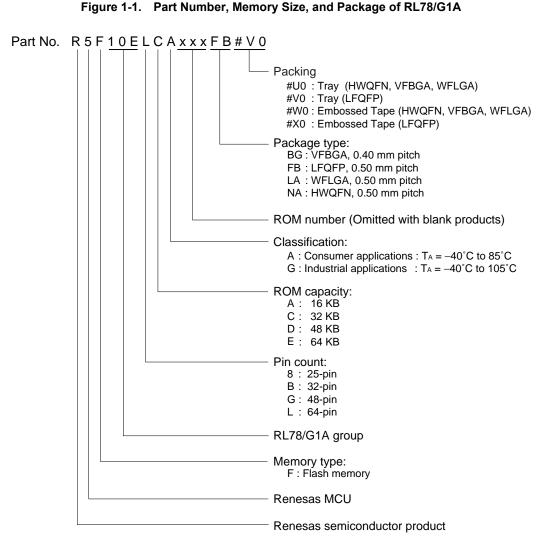
O ROM, RAM capacities

| Flash ROM | Data flash | RAM | RL78/G1A | | | | |
|-----------|------------|----------------------|----------|----------|----------|----------|--|
| | | | 25 pins | 32 pins | 48 pins | 64 pins | |
| 64 KB | 4 KB | 4 KB ^{Note} | R5F10E8E | R5F10EBE | R5F10EGE | R5F10ELE | |
| 48 KB | 4 KB | 3 KB | R5F10E8D | R5F10EBD | R5F10EGD | R5F10ELD | |
| 32 KB | 4 KB | 2 KB | R5F10E8C | R5F10EBC | R5F10EGC | R5F10ELC | |
| 16 KB | 4 KB | 2 KB | R5F10E8A | R5F10EBA | R5F10EGA | _ | |

Note This is about 3 KB when the self-programming function and data flash function are used. (For details, see
 3. ELECTRICAL SPECIFICATIONS (G: INDUSTRIAL APPLICATIONS TA = -40 to +105°C))



1.2 List of Part Numbers



Caution The part number above is valid as of when this manual was issued. For the latest part number, see the web page of the target product on the Renesas Electronics website.



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| Pin count | Package | Fields of Application ^{Note} | Ordering Part Number |
|-----------|--|--|---|
| 25 pins | 25-pin plastic WFLGA (3 × 3 mm, 0.5 mm pitch) | A | R5F10E8AALA#U0, R5F10E8CALA#U0, R5F10E8DALA#U0, R5F10E8EALA#U0, R5F10E8AALA#W0, R5F10E8CALA#W0, R5F10E8DALA#W0, R5F10E8EALA#W0 |
| | | G | R5F10E8AGLA#U0, R5F10E8CGLA#U0, R5F10E8DGLA#U0, R5F10E8EGLA#U0, R5F10E8AGLA#W0, R5F10E8CGLA#W0, R5F10E8DGLA#W0, R5F10E8EGLA#W0 |
| 32 pins | 32-pin plastic HWQFN (5 × 5 mm, 0.5 mm pitch) | A | R5F10EBAANA#U0, R5F10EBCANA#U0, R5F10EBDANA#U0, R5F10EBEANA#U0, R5F10EBAANA#W0, R5F10EBCANA#W0, R5F10EBDANA#W0, R5F10EBEANA#W0 |
| | | G | R5F10EBAGNA#U0, R5F10EBCGNA#U0, R5F10EBDGNA#U0, R5F10EBEGNA#U0, R5F10EBAGNA#W0, R5F10EBCGNA#W0, R5F10EBDGNA#W0, R5F10EBEGNA#W0 |
| 48 pins | 48-pin plastic LFQFP (7 × 7 mm, 0.5 mm pitch) | A | R5F10EGAAFB#V0, R5F10EGCAFB#V0, R5F10EGDAFB#V0, R5F10EGEAFB#V0, R5F10EGAAFB#X0, R5F10EGCAFB#X0, R5F10EGDAFB#X0, R5F10EGEAFB#X0 |
| | | G | R5F10EBAGNA#V0, R5F10EBCGNA#V0, R5F10EBDGNA#V0, R5F10EBEGNA#V0, R5F10EBAGNA#X0, R5F10EBCGNA#X0, R5F10EBDGNA#X0, R5F10EBEGNA#X0 |
| | 48-pin plastic HWQFN (7 × 7 mm, 0.5 mm pitch) | A | R5F10EGAANA#U0, R5F10EGCANA#U0, R5F10EGDANA#U0, R5F10EGEANA#U0, R5F10EGAANA#W0, R5F10EGCANA#W0, R5F10EGDANA#W0, R5F10EGEANA#W0 |
| | | G | R5F10EGAGNA#U0, R5F10EGCGNA#U0, R5F10EGDGNA#U0, R5F10EGEGNA#U0, R5F10EGAGNA#W0, R5F10EGCGNA#W0, R5F10EGDGNA#W0, R5F10EGEGNA#W0 |
| 64 pins | 64-pin plastic LFQFP (10 \times 10 mm, 0.5 mm | A | R5F10ELCAFB#V0, R5F10ELDAFB#V0, R5F10ELEAFB#V0, R5F10ELCAFB#X0, R5F10ELDAFB#X0, R5F10ELEAFB#X0 |
| | pitch) | G | R5F10ELCGFB#V0, R5F10ELDGFB#V0, R5F10ELEGFB#V0, R5F10ELCGFB#X0, R5F10ELDGFB#X0, R5F10ELEGFB#X0 |
| | 64-pin plastic VFBGA (4 × 4 mm, 0.4 mm pitch) | A | R5F10ELCABG#U0, R5F10ELDABG#U0, R5F10ELEABG#U0, R5F10ELCABG#W0, R5F10ELDABG#W0, R5F10ELEABG#W0 |
| | | G | R5F10ELCGBG#U0, R5F10ELDGBG#U0, R5F10ELEGBG#U0, R5F10ELCGBG#W0, R5F10ELDGBG#W0, R5F10ELEGBG#W0 |

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Note For the fields of application, see Figure 1-1 Part Number, Memory Size, and Package of RL78/G1A.

Caution The part number above is valid as of when this manual was issued. For the latest part number, see the web page of the target product on the Renesas Electronics website.

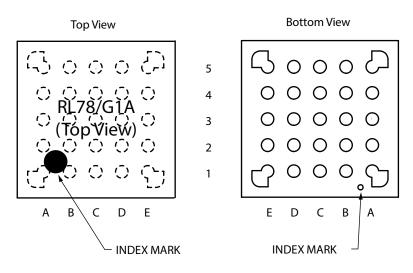
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1. OUTLINE

1.3 Pin Configuration (Top View)

1.3.1 25-pin products

• 25-pin plastic WFLGA (3 × 3 mm, 0.50 mm pitch)



| | А | В | С | D | E | _ |
|---|-------------------|------------|---|---|-----------------------------------|---|
| 5 | P40/TOOL0 | RESET | P03/ANI16/ RxD1/TO00/ (KR1) | P23/ANI3/ (KR3) | AVss | 5 |
| 4 | P122/X2/ EXCLK | P137/INTP0 | P02/ANI17/ TxD1/TI00/ (KR0) | P22/ANI2/ (KR2) | AVDD | 4 |
| 3 | P121/X1 | VDD | P21/ANI1/ AVrefm | P11/ANI20/ SI00/SDA00/ RxD0/ TOOLRxD | P10/ANI18/ SCK00/SCL00 | 3 |
| 2 | REGC | Vss | P30/ANI27/ SCK11/SCL11/ INTP3 | P51/ANI25/ SO11/INTP2 | P50/ANI26/ SI11/SDA11 INTP1 | 2 |
| 1 | P60/SCLA0 | P61/SDAA0 | P31/ANI29/TI03/ TO03/PCLBUZ0 /INTP4 | P12/ANI21/ SO00/TxD0/ TOOLTxD | P20/ANI0/ AV _{REFP} | 1 |
| | А | В | С | D | E | - |

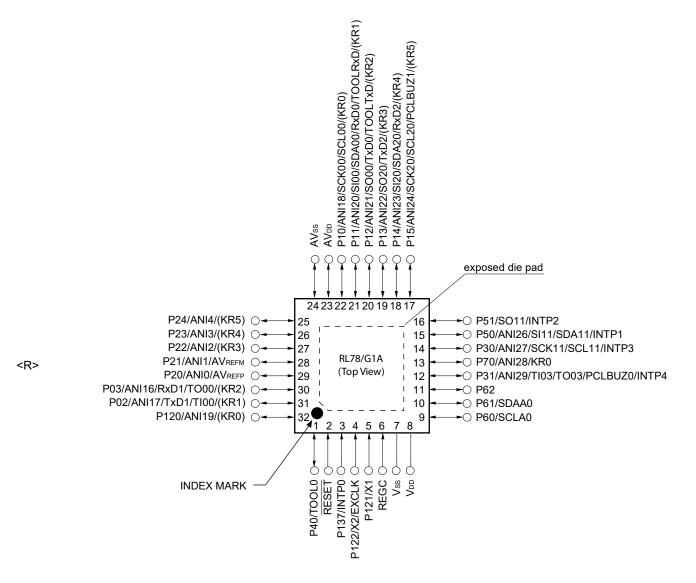
Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F).

Remarks 1. For pin identification, see 1.4 Pin Identification.

2. Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).

1.3.2 32-pin products

• 32-pin plastic HWQFN (5 × 5 mm, 0.5 mm pitch)



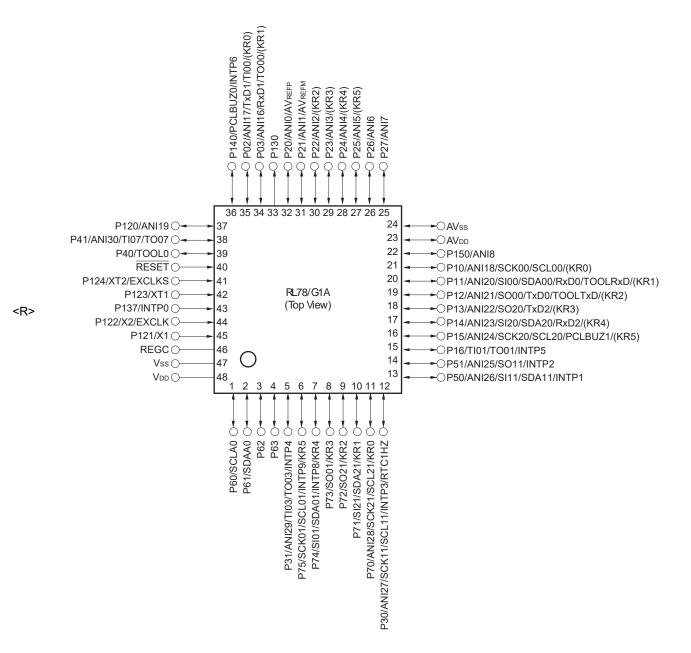
Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F).

Remarks 1. For pin identification, see 1.4 Pin Identification.

- **2.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).
- 3. It is recommended to connect an exposed die pad to Vss.
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1.3.3 48-pin products

• 48-pin plastic LFQFP (7 × 7 mm, 0.5 mm pitch)



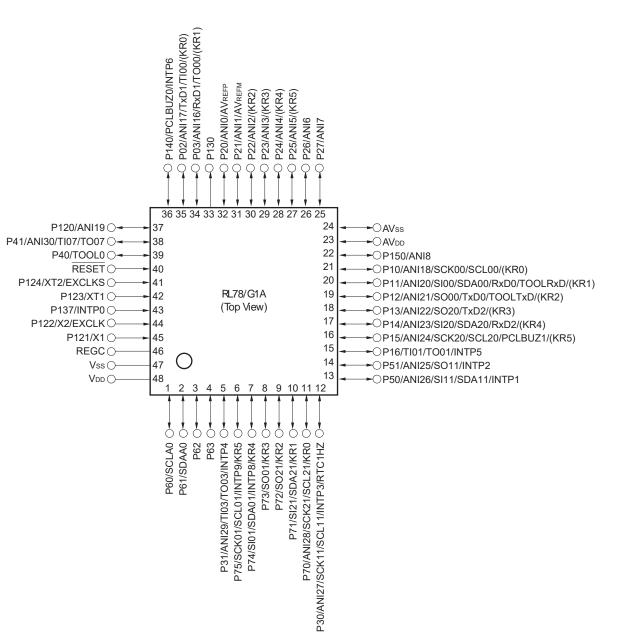
Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F).

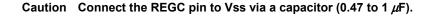
Remarks 1. For pin identification, see 1.4 Pin Identification.

2. Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).



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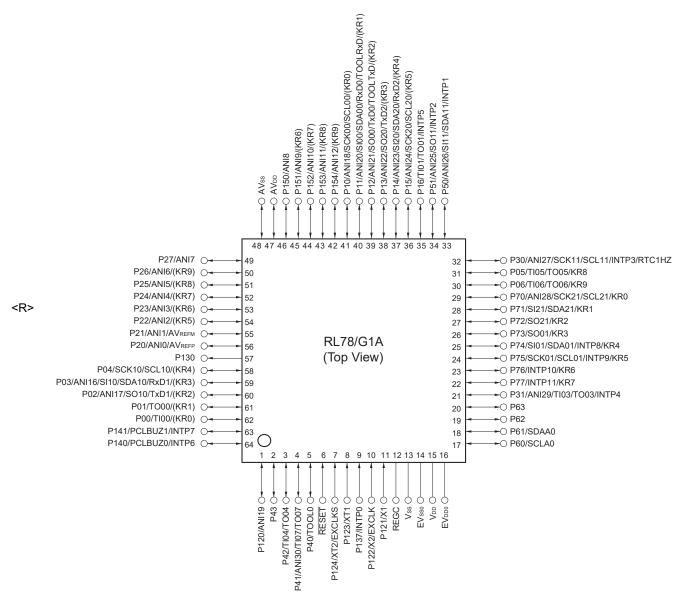
Remarks 1. For pin identification, see 1.4 Pin Identification.

2. Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).



1.3.4 64-pin products

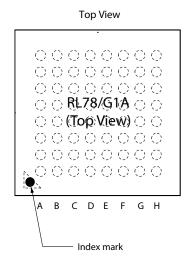
• 64-pin plastic LFQFP (10×10 mm, 0.5 mm pitch)

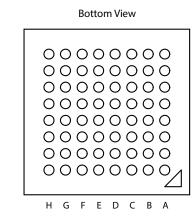


Cautions 1. Make EVsso pin the same potential as Vss pin.

- 2. Make VDD pin the potential that is higher than EVDD0 pin.
- 3. Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F).
- Remarks 1. For pin identification, see 1.4 Pin Identification.
 - 2. When using the microcontroller for an application where the noise generated inside the microcontroller must be reduced, it is recommended to supply separate powers to the V_{DD} and EV_{DD0} pins and connect the Vss and EVss0pins to separate ground lines.
 - **3.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).

• 64-pin plastic VFBGA (4 × 4 mm, 0.4 mm pitch)





| Pin No. | Name | Pin No. | Name | Pin No. | Name | Pin No. | Name |
|---------|--|---------|---------------------------------------|---------|---|---------|-------------------------------|
| A1 | P05/TI05/TO05/KR8 | C1 | P51/ANI25/SO11 /INTP2 | E1 | P153/ANI11/(KR8) | G1 | AVdd |
| A2 | P30/ANI27/SCK11 /SCL11/INTP3 /RTC1HZ | C2 | P71/SI21/SDA21/KR1 | E2 | P154/ANI12/(KR9) | G2 | P25/ANI5/(KR8) |
| A3 | P70/ANI28/SCK21 /SCL21/KR0 | C3 | P74/SI01/SDA01 /INTP8/KR4 | E3 | P10/ANI18/SCK00 /SCL00/(KR0) | G3 | P24/ANI4/(KR7) |
| A4 | P75/SCK01/SCL01 /INTP9/KR5 | C4 | P16/TI01/TO01/INTP5 | E4 | P11/ANI20/SI00 /SDA00/RxD0 /TOOLRxD/(KR1) | G4 | P22/ANI2/(KR5) |
| A5 | P77/INTP11/KR7 | C5 | P15/ANI24/SCK20 /SCL20/(KR5) | E5 | P03/ANI16/SI10 /SDA10/RxD1/(KR3) | G5 | P130 |
| A6 | P61/SDAA0 | C6 | P63 | E6 | P41/ANI30/TI07/TO07 | G6 | P02/ANI17/SO10/TxD1 /(KR2) |
| A7 | P60/SCLA0 | C7 | Vss | E7 | RESET | G7 | P00/TI00/(KR0) |
| A8 | EVDD0 | C8 | P121/X1 | E8 | P137/INTP0 | G8 | P124/XT2/EXCLKS |
| B1 | P50/ANI26 /SI11 /SDA11/INTP1 | D1 | P13/ANI22/SO20 /TxD2/(KR3) | F1 | P150/ANI8 | H1 | AVss |
| B2 | P72/SO21/KR2 | D2 | P06/TI06/TO06/KR9 | F2 | P151/ANI9/(KR6) | H2 | P27/ANI7 |
| B3 | P73/SO01/KR3 | D3 | P12/ANI21/SO00 /TxD0/TOOLTxD/(KR2) | F3 | P152/ANI10/(KR7) | H3 | P26/ANI6/(KR9) |
| B4 | P76/INTP10/KR6 | D4 | P14/ANI23/SI20/ SDA20/RxD2/(KR4) | F4 | P21/ANI1/AVREFM | H4 | P23/ANI3/(KR6) |
| B5 | P31/ANI29/TI03/TO03 /INTP4 | D5 | P42/TI04/TO04 | F5 | P04/SCK10/SCL10 /(KR4) | H5 | P20/ANI0/AVREFP |
| B6 | P62 | D6 | P40/TOOL0 | F6 | P43 | H6 | P141/PCLBUZ1/INTP7 |
| B7 | Vdd | D7 | REGC | F7 | P01/TO00/(KR1) | H7 | P140/PCLBUZ0/INTP6 |
| B8 | EVsso | D8 | P122/X2/EXCLK | F8 | P123/XT1 | H8 | P120/ANI19 |

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Cautions 1. Make EVsso pin the same potential as Vss pin.

- 2. Make VDD pin the potential that is higher than EVDD0 pin.
- 3. Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F).

Remarks 1. For pin identification, see 1.4 Pin Identification.

- 2. When using the microcontroller for an application where the noise generated inside the microcontroller must be reduced, it is recommended to supply separate powers to the V_{DD} and EV_{DD0} pins and connect the Vss and EV_{SS0} pins to separate ground lines.
- **3.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).

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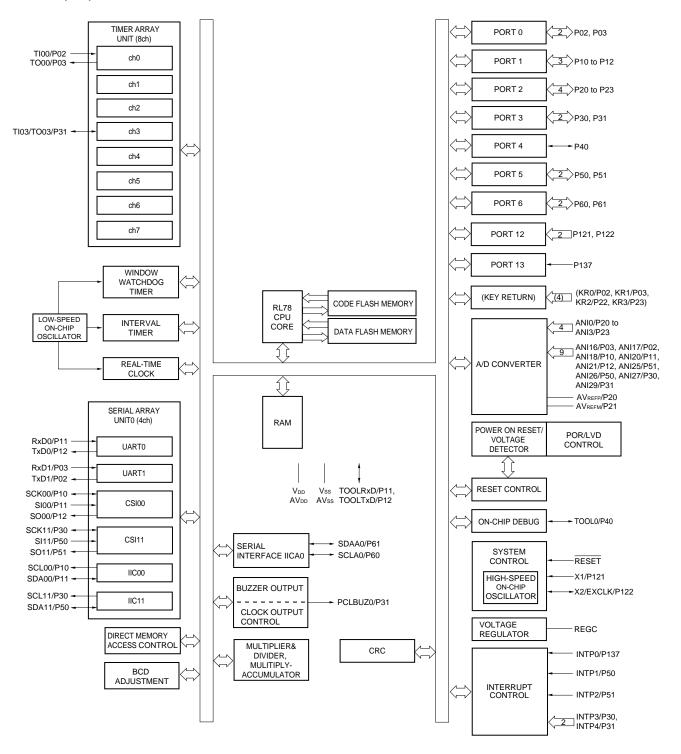
1.4 Pin Identification

| ANI0 to ANI12, | | PCLBUZ0, PCLBUZ1: | Programmable clock output/buzzer |
|------------------|----------------------------|---------------------------|--|
| ANI16 to ANI30: | Analog input | | output |
| AVDD: | Analog power supply | REGC: | Regulator capacitance |
| AVss: | Analog ground | RESET: | Reset |
| AVREFM: | A/D converter reference | RTC1HZ: | Real-time clock correction clock |
| | potential (– side) input | | (1 Hz) output |
| AVREFP: | A/D converter reference | RxD0 to RxD2: | Receive data |
| | potential (+ side) input | SCK00, SCK01, SCK10, | |
| EVDD0: | Power supply for port | SCK11, SCK20, SCK21: | Serial clock input/output |
| EVsso: | Ground for port | SCLA0, SCL00, SCL01, | |
| EXCLK: | External clock input (main | SCL10, SCL11, SCL20, | |
| | system clock) | SCL21: | Serial clock output |
| EXCLKS: | External clock input | SDAA0, SDA00, SDA01, | |
| | (subsystem clock) | SDA10, SDA11, SDA20, | |
| INTP0 to INTP11: | Interrupt Request from | SDA21: | Serial data input/output |
| | External | SI00, SI01, SI10, SI11, | |
| KR0 to KR9: | Key return | SI20, SI21: | Serial data input |
| P00 to P06: | Port 0 | SO00, SO01, SO10, | |
| P10 to P16: | Port 1 | SO11, SO20, SO21: | Serial data output |
| P20 to P27: | Port 2 | TI00, TI01, TI03 to TI07: | Timer input |
| P30, P31: | Port 3 | TO00, TO01, | |
| P40 to P43: | Port 4 | TO03 to TO07: | Timer output |
| P50, P51: | Port 5 | TOOL0: | Data input/output for tool |
| P60 to P63: | Port 6 | TOOLRxD, TOOLTxD: | Data input/output for external device |
| P70 to P77: | Port 7 | TxD0 to TxD2: | Transmit data |
| P120 to P124: | Port 12 | Vdd: | Power supply |
| P130, P137: | Port 13 | Vss: | Ground |
| P140, P141: | Port 14 | X1, X2: | Crystal oscillator (main system clock) |
| P150 to P154: | Port 15 | XT1, XT2: | Crystal oscillator (subsystem clock) |

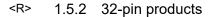


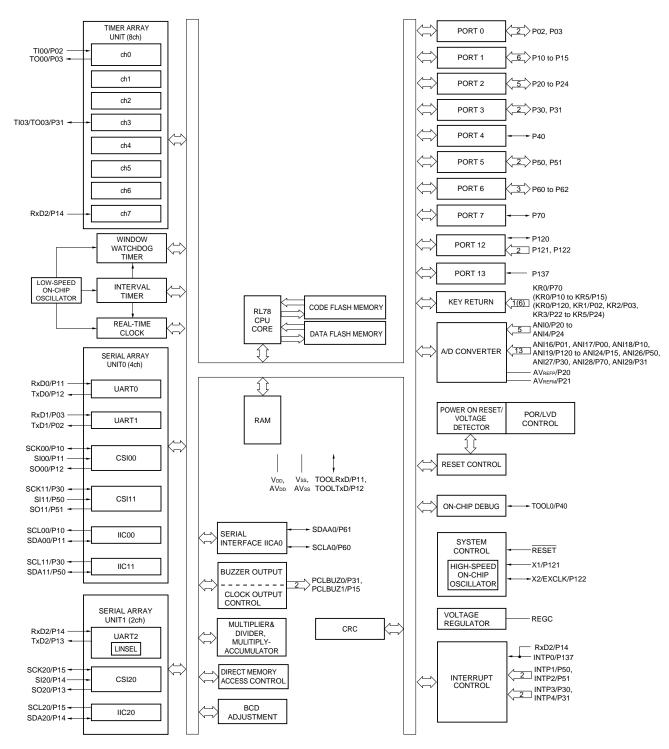
1.5 Block Diagram

1.5.1 25-pin products



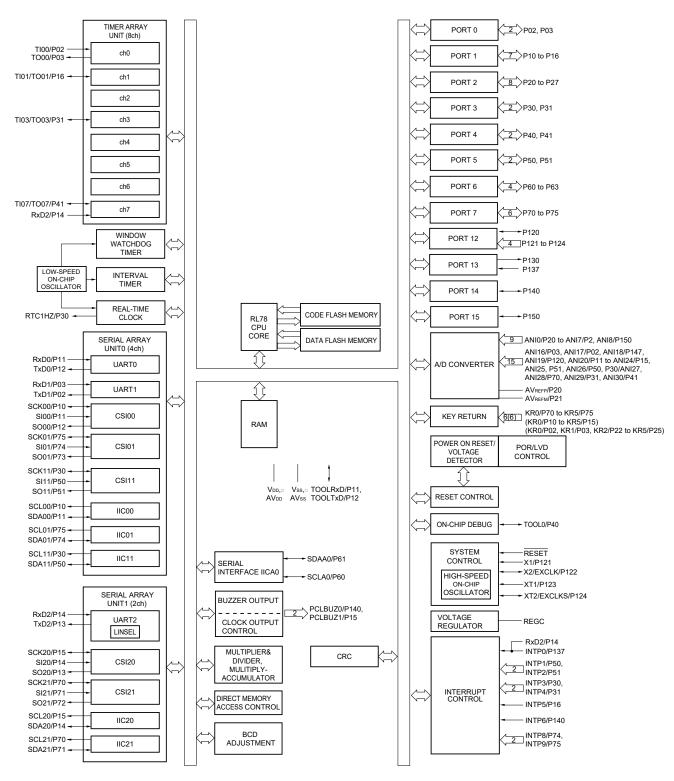
Remark Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).





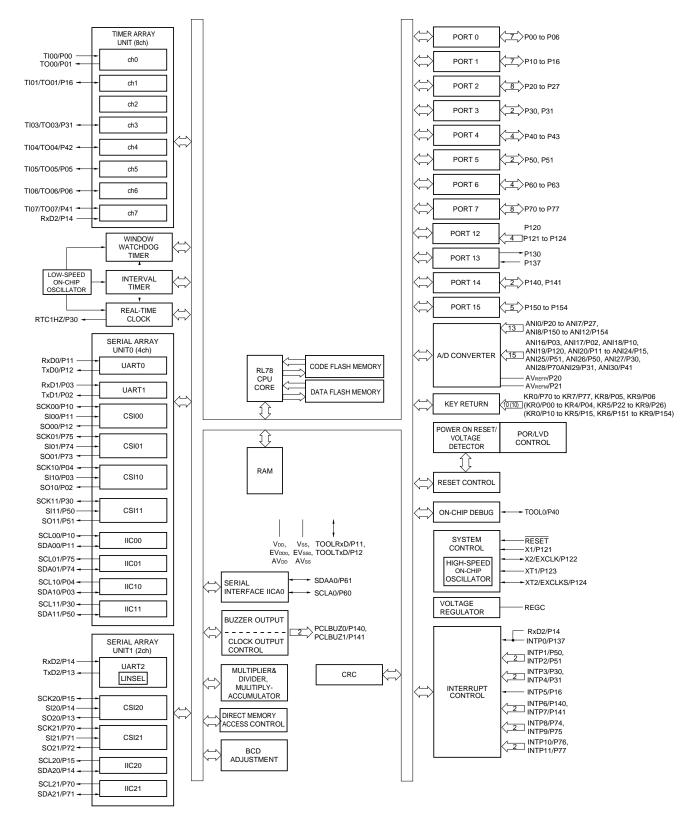
Remark Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).





Remark Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).

1.5.4 64-pin products



Remark Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).

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1.6 Outline of Functions

| Item | | 25-pin | 32-pin | 48-pin | 64-pin | | | |
|---|--|---|--|---|--|--|--|--|
| | | R5F10E8x | R5F10EBx | R5F10EGx | R5F10ELx | | | |
| Code flash memory (KB) | | 16 to 64 | 16 to 64 | 16 to 64 | 32 to 64 | | | |
| Data flash me | emory (KB) | 4 | 4 | 4 | 4 | | | |
| RAM (KB) | | 2 to 4 Note 1 | 2 to 4 Note 1 | 2 to 4 Note 1 | 2 to 4 Note 1 | | | |
| Address space | e | 1 MB | | | | | | |
| | High-speed system clock | X1 (crystal/ceramic) oscillation, external main system clock input (EXCLK) HS (High-speed main) mode: 1 to 20 MHz (V_{DD} = 2.7 to 3.6 V), HS (High-speed main) mode: 1 to 16 MHz (V_{DD} = 2.4 to 3.6 V), LS (Low-speed main) mode: 1 to 8 MHz (V_{DD} = 1.8 to 3.6 V), LV (Low-voltage main) mode: 1 to 4 MHz (V_{DD} = 1.6 to 3.6 V) | | | | | | |
| | High-speed on-chip | | node : 1 to 32 MHz (VD | - | | | | |
| | oscillator | | node ∶1 to 16 MHz (V⊳ | | | | | |
| | | LS (Low-speed main) m | ode : 1 to 8 MHz (VDD | = 1.8 to 3.6 V), | | | | |
| | | LV (Low-voltage main) mode : 1 to 4 MHz (V _{DD} = 1.6 to 3.6 V) | | | | | | |
| Subsystem cl | ock | | XT1 (crystal) oscillation, ex clock input (EXCLKS) 32. | | | | | |
| Low-speed or | n-chip oscillator | 15 kHz (TYP.) | | | | | | |
| General-purp | ose register | (8-bit register \times 8) \times 4 bank | | | | | | |
| Minimum inst | ruction execution time | 0.03125 μ s (High-speed on-chip oscillator: f _{IH} = 32 MHz operation) | | | | | | |
| | | 0.05 μ s (High-speed system clock: f _{MX} = 20 MHz operation) | | | | | | |
| | | | _ | 30.5 μ s (Subsystem clock: f _{SUB} = 32.768 kHz operation) | | | | |
| Instruction se | t | Data transfer (8/16 bits) Adder and subtractor/logical operation (8/16 bits) Multiplication (8 bits × 8 bits) Rotate, barrel shift, and bit manipulation (Set, reset, test, and Boolean operation), etc. | | | | | | |
| I/O port | Total | 19 | 26 | 42 | 56 | | | |
| Data flash me RAM (KB) Address space Main system clock Subsystem clock | CMOS I/O | 14 | 20 | 32 | 46 | | | |
| | | (N-ch O.D. I/O [Vɒɒ withstand voltage]: 6) | (N-ch O.D. I/O [V _{DD} withstand voltage]: 9) | (N-ch O.D. I/O [V _{DD} withstand voltage]: 11) | (N-ch O.D. I/O [V _{DD} withstand voltage]: 1 | | | |
| | CMOS input | 3 | 3 | 5 | 5 | | | |
| | CMOS output | - | - | 1 | 1 | | | |
| | N-ch open-drain I/O (6 V tolerance) | 2 | 3 | 4 | 4 | | | |
| Timer | 16-bit timer | 8 channels | | | | | | |
| | Watchdog timer | 1 channel | | | | | | |
| | Real-time clock (RTC) | 1 chan | nel ^{Note 2} | 1 cha | innel | | | |
| | 12-bit interval timer (IT) | | | annel | | | | |
| | Timer output | 2 channels (PWM output | s: 1 ^{Note 3}) | 4 channels (PWM outputs: 3 ^{Note 3}) | 7 channels (PWM outputs: 6 ^{Note 3} | | | |
| | RTC output | | | 1 • 1 Hz (subsystem clock: fsub = 32.768 kHz) | | | | |

 In the case of the 4 KB, this is about 3 KB when the self-programming function and data flash function are used. (For details, see CHAPTER 3. ELECTRICAL SPECIFICATIONS (G: INDUSTRIAL APPLICATIONS TA = -40 to +105°C))

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- 2. Only the constant-period interrupt function when the low-speed on-chip oscillator clock (fiL) is selected.
- **3.** The number of PWM outputs varies depending on the setting of channels in use (the number of masters and slaves). (**6.9.3 Operation as multiple PWM output function**).

| | | | | T | (2/2) | | |
|---------------------------------------|----------------------|---|---|---|--|--|--|
| Ite | m | 25-pin | 32-pin | 48-pin | 64-pin | | |
| Clock output/buzzer output | | R5F10E8x | R5F10EBx | R5F10EGx | R5F10ELx | | |
| Clock output/buzzer output | | 1 • 2.44 kHz, 4.88 kHz, 9. 2.5 MHz, 5 MHz, 10 M (Main system clock: fw | | 2 2 • 2.44 kHz, 4.88 kHz, 9.76 kHz, 1.25 MHz, 2.5 MHz, 5 MHz, 10 MHz (Main system clock: fmain = 20 MHz operation) | | | |
| | | | | | z, 16.384 kHz, 32.768 kHz ⊫ = 32.768 kHz operation) | | |
| 8/12-bit resolution | A/D converter | 13 channels | 18 channels | 24 channels | 28 channels | | |
| Serial interface | | [25-pin products] | | | | | |
| | | CSI: 1 channel/simpl [32-pin products] CSI: 1 channel/simpl CSI: 1 channel/simpl | ified I ² C: 1 channel/UAR ified I ² C: 1 channel/UAR | T: 1 channel T: 1 channel T: 1 channel | bus): 1 channel | | |
| | | CSI: 2 channels/simplified l²C: 2 channels/UART: 1 channel CSI: 1 channel/simplified l²C: 1 channel/UART: 1 channel CSI: 2 channels/simplified l²C: 2 channels/UART (UART supporting LIN-bus): 1 channel [64-pin products] CSI: 2 channels/simplified l²C: 2 channels/UART: 1 channel CSI: 2 channels/simplified l²C: 2 channels/UART: 1 channel CSI: 2 channels/simplified l²C: 2 channels/UART: 1 channel | | | | | |
| | l ² C bus | CSI: 2 channels/simp 1 channel | blified I ² C: 2 channels/UA | ART (UART supporting LI | N-bus): 1 channel | | |
| Multiplier and divider/multiply-ac | - | 16 bits × 16 bits = 32 k 32 bits ÷ 32 bits = 32 k | I bits (Unsigned or signed) | | | | |
| DMA controller | | 2 channels | | <u> </u> | | | |
| Vectored interrupt | Internal | 24 | 27 | 27 | 27 | | |
| sources | External | 6 | 6 | 10 | 13 | | |
| Key interrupt | | 0 ch (4 ch) ^{Note 1} | 1 ch (6 ch) ^{Note 1} | 6 ch | 10 ch | | |
| Reset | | Reset by RESET pin Internal reset by watchdog timer Internal reset by power-on-reset Internal reset by voltage detector Internal reset by illegal instruction execution^{Note 2} Internal reset by RAM parity error Internal reset by illegal-memory access | | | | | |
| Power-on-reset ci | cuit | Power-on-reset: 1.51 V (TYP.) Power-down-reset: 1.50 V (TYP.) | | | | | |
| Voltage detector | | Rising edge : 1.67 V to 3.14 V (12 stages) Falling edge : 1.63 V to 3.06 V (12 stages) | | | | | |
| On-chip debug fur | oction | Provided | | | | | |
| Power supply volta | age | V _{DD} = 1.6 to 3.6 V | | | | | |
| | t temperature | $T_{A} = -40$ to $+85^{\circ}C$ (A: C | onsumer application), TA | $= -40$ to $\pm 105^{\circ}$ C (G Ind | ustrial application) | | |

Notes 1. Can be used by the Peripheral I/O redirection register (PIOR).

 The illegal instruction is generated when instruction code FFH is executed. Reset by the illegal instruction execution not issued by emulation with the in-circuit emulator or on-chip debug emulator.

2. ELECTRICAL SPECIFICATIONS ($T_A = -40$ to +85°C)

This chapter describes the following electrical specifications.

- Target productsA:Consumer applicationsTA = -40 to +85°CR5F10E8AALA, R5F10E8CALA, R5F10E8DALA, R5F10E8EALAR5F10EBAANA, R5F10EBCANA, R5F10EBDANA, R5F10EBEANAR5F10EGAAFB, R5F10EGCAFB, R5F10EGDAFB, R5F10EGEAFBR5F10EGAANA, R5F10EGCANA, R5F10EGDANA, R5F10EGEANAR5F10ELCAFB, R5F10ELDAFB, R5F10ELEAFBR5F10ELCABG, R5F10ELDABG, R5F10ELEABG
 - G: Industrial applications When T_A = -40 to +105°C products is used in the range of T_A = -40 to +85°C
 R5F10EBAGNA, R5F10EBCGNA, R5F10EBDGNA, R5F10EBEGNA
 R5F10EGAGFB, R5F10EGCGFB, R5F10EGDGFB, R5F10EGEGFB
 R5F10EGAGNA, R5F10EGCGNA, R5F10EGDGNA, R5F10EGEGNA
 R5F10ELCGFB, R5F10ELDGFB, R5F10ELEGFB
- Cautions 1. The RL78 microcontrollers have an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.
 - 2. With products not provided with an EV_{DD0} or EV_{SS0} pin, replace EV_{DD0} with V_{DD}, or replace EV_{SS0} with V_{SS}.



2.1 Absolute Maximum Ratings

Absolute Maximum Ratings (T_A = 25°C) (1/2)

| Parameter | Symbols | Conditions | Ratings | Unit |
|------------------------|-----------------|--|--|------|
| Supply voltage | Vdd | | -0.5 to +6.5 | V |
| | EVDD0 | | -0.5 to +6.5 | V |
| | AVDD | | -0.5 to +4.6 | V |
| | AVREFP | | -0.3 to AV _{DD} +0.3 ^{Note 3} | V |
| | EVsso | | -0.5 to +0.3 | V |
| | AVss | | -0.5 to +0.3 | V |
| | AVREFM | | $-0.3 \text{ to } AV_{DD} + 0.3^{\text{Note 3}}$ and AV_{REFM} $\leq AV_{REFP}$ | V |
| REGC pin input voltage | Viregc | REGC | -0.3 to +2.8 and -0.3 to V _{DD} +0.3 ^{Note 1} | V |
| Input voltage | VI1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | -0.3 to EV _{DD0} +0.3 and -0.3 to V _{DD} +0.3 ^{Note 2} | V |
| | Vı2 | P60 to P63 (N-ch open-drain) | -0.3 to +6.5 | V |
| | Vı3 | P121 to P124, P137, EXCLK, EXCLKS, RESET | -0.3 to V _{DD} +0.3 ^{Note 2} | V |
| | V _{I4} | P20 to P27, P150 to P154 | -0.3 to AV _{DD} +0.3 ^{Note 2} | V |
| Output voltage | Vo1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P63, P70 to P77, P120, P130, P140, P141 | -0.3 to EV _{DD0} +0.3 ^{Note 2} | V |
| | V ₀₂ | P20 to P27, P150 to P154 | -0.3 to AV _{DD} +0.3 ^{Note 2} | V |
| Analog input voltage | Val1 | ANI16 to ANI30 | -0.3 to EV_DD0 +0.3 and -0.3 to AV_{REF(+)} +0.3^{Notes 2,4} | V |
| | Vai2 | ANI0 to ANI12 | -0.3 to AV_DD +0.3 and -0.3 to AV_{\text{REF}(+)} +0.3 $^{\text{Notes 2, 4}}$ | V |

Notes 1. Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F). This value regulates the absolute maximum rating of the REGC pin. Do not use this pin with voltage applied to it.

- 2. Must be 6.5 V or lower.
- **3.** Must be 4.6 V or lower.
- 4. Do not exceed $AV_{REF(+)}$ + 0.3 V in case of A/D conversion target pin.
- Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remarks 1.** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.
 - **2.** AV_{REF(+)}: + side reference voltage of the A/D converter.
 - 3. Vss: Reference voltage



| Parameter | Symbols | | Conditions | Ratings | Unit |
|----------------------|---------|------------------------------|---|-------------|------|
| Output current, high | Іон1 | Per pin | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141 | -40 | mA |
| | | Total of all pins –170 mA | P00 to P04, P40 to P43, P120, P130, P140, P141 | -70 | mA |
| | | | P05, P06, P10 to P16, P30, P31, P50, P51, P70 to P77, | -100 | mA |
| | Іон2 | Per pin | P20 to P27, P150 to P154 | -0.1 | mA |
| | | Total of all pins | | -1.3 | mA |
| Output current, low | Tota | Per pin | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P63, P70 to P77, P120, P130, P140, P141 | 40 | mA |
| | | Total of all pins 170 mA | P00 to P04, P40 to P43, P120, P130, P140, P141 | 70 | mA |
| | | | P05, P06, P10 to P16, P30, P31, P50, P51, P60 to P63, P70 to P77 | 100 | mA |
| | IOL2 | Per pin | P20 to P27, P150 to P154 | 0.4 | mA |
| | | Total of all pins | | 6.4 | mA |
| Operating ambient | TA | In normal operation | on mode | -40 to +85 | °C |
| temperature | | In flash memory p | programming mode | | |
| Storage temperature | Tstg | | | -65 to +150 | °C |

Absolute Maximum Ratings (T_A = 25°C) (2/2)

- Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



2.2 Oscillator Characteristics

2.2.1 X1, XT1 oscillator characteristics

| Parameter | Resonator | Conditions | MIN. | TYP. | MAX. | Unit |
|--|-------------------------------------|---------------------------------------|------|--------|------|------|
| X1 clock oscillation | Ceramic resonator/crystal resonator | $2.7~V \leq V_{\text{DD}} \leq 3.6~V$ | 1.0 | | 20.0 | MHz |
| frequency (fx) ^{Note} | | $2.4~V \leq V_{\text{DD}} < 2.7~V$ | 1.0 | | 16.0 | MHz |
| | | $1.8~V \leq V_{\text{DD}} < 2.4~V$ | 1.0 | | 8.0 | MHz |
| | | $1.6~V \leq V_{\text{DD}} < 1.8~V$ | 1.0 | | 4.0 | MHz |
| XT1 clock oscillation frequency (fx) ^{Note} | Crystal resonator | | 32 | 32.768 | 35 | kHz |

$(T_A = -40 \text{ to } +85^{\circ}C, 1.6 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

- **Note** Indicates only permissible oscillator frequency ranges. See AC Characteristics for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.
- <R> Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

2.2.2 On-chip oscillator characteristics

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

| Oscillators | Parameters | Conditions | | | TYP. | MAX. | Unit |
|--|------------|---------------|---------------------------------------|------|------|------|------|
| High-speed on-chip oscillator clock frequency ^{Notes 1, 2} | fін | | | 1 | | 32 | MHz |
| High-speed on-chip oscillator clock frequency accuracy | | –20 to +85 °C | $1.8~V \leq V_{\text{DD}} \leq 3.6~V$ | -1.0 | | +1.0 | % |
| | | | $1.6~V \leq V_{\text{DD}} < 1.8~V$ | -5.0 | | +5.0 | % |
| | | –40 to –20 °C | $1.8~V \leq V_{\text{DD}} \leq 3.6~V$ | -1.5 | | +1.5 | % |
| | | | $1.6~V \leq V_{\text{DD}} < 1.8~V$ | -5.5 | | +5.5 | % |
| Low-speed on-chip oscillator clock frequency | fı∟ | | | | 15 | | kHz |
| Low-speed on-chip oscillator clock frequency accuracy | | | | -15 | | +15 | % |

- **Notes 1.** High-speed on-chip oscillator frequency is selected by bits 0 to 3 of option byte (000C2H/010C2H) and bits 0 to 2 of HOCODIV register.
 - 2. This indicates the oscillator characteristics only. See AC Characteristics for instruction execution time.

2.3 DC Characteristics

2.3.1 Pin characteristics

| (T _A = -40 to +85°C | , 1.6 V ≤ A | $V_{DD} \leq V_{DD} \leq 3.6 \text{ V}, 1.6 \text{ V} \leq \text{EV}_{DD0} \leq \text{V}$ | DD \leq 3.6 V, Vss = EVs | sso = 0 V |) | | (1/5) | |
|---|-------------|--|--|-------------------------------------|--|-------------------------|-------|--|
| Items | Symbol | Conditions | | MIN. | TYP. | MAX. | Unit | |
| Output current, high ^{Note 1} | Іон1 | Per pin for P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141 | $1.6~V \leq EV_{DD0} \leq 3.6~V$ | | | -10.0 ^{Note 2} | mA | |
| | | Total of P00 to P04, P40 to P43, P120, | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | -10.0 | mA | |
| | | P130, P140, P141 | $1.8~V \leq EV_{\text{DD0}} < 2.7~V$ | .8 V ≤ EV _{DD0} < 2.7 V5.0 | | | | |
| | | (When duty ≤ 70% ^{Note 3}) | $1.6~V \leq EV_{\text{DD0}} < 1.8~V$ | | | -2.5 | mA | |
| | | Total of P05, P06, P10 to P16, P30, | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | -19.0 | mA | |
| | | P31, P50, P51, P70 to P77, | $1.8~V \leq EV_{\text{DD0}} < 2.7~V$ | | -2.5 m -19.0 m -10.0 m -5.0 m | | | |
| | | (When duty ≤ 70% ^{Note 3}) | $1.6~V \leq EV_{\text{DD0}} < 1.8~V$ | | | -5.0 | mA | |
| Іона | | Total of all pins (When duty ≤ 70% ^{Note 3}) | $1.6~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | -29.0 | mA | |
| | Іон2 | Per pin for P20 to P27, P150 to P154 | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | -0.1 ^{Note 2} | mA | |
| | | Total of all pins (When duty ≤ 70% ^{Note 3}) | $1.6 \text{ V} \le AV_{\text{DD}} \le 3.6 \text{ V}$ | | | -1.3 | mA | |

- **Notes 1**. Value of current at which the device operation is guaranteed even if the current flows from the EV_{DD0}, V_{DD} pins to an output pin.
 - 2. However, do not exceed the total current value.
 - 3. Specification under conditions where the duty factor ≤ 70%. The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).
 - Total output current of pins = $(I_{OH} \times 0.7)/(n \times 0.01)$ <Example> Where n = 80% and I_OH = -10.0 mA Total output current of pins = $(-10.0 \times 0.7)/(80 \times 0.01) \cong -8.7$ mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

- Caution P00, P02 to P04, P10 to P15, P43, P50, P71, and P74 do not output high level in N-ch open-drain mode.
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



| $I_A = -40$ to +85 | °C, 1.6 V ≤ | $AV_{DD} \leq V_{DD} \leq 3.6 \text{ V}, 1.6 \text{ V} \leq EV_{DD} \leq 3.6 \text{ V}$ | \leq VDD \leq 3.6 V, Vss = EVsso = U V) | | | | | |
|--|-------------|--|--|------|--------------------|--|------|--|
| Items | Symbol | Conditions | | MIN. | TYP. | MAX. | Unit | |
| Output current, low ^{Note 1} | Iol1 | Per pin for P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141 | | | | 20.0 ^{Note 2} | mA | |
| | | Per pin for P60 to P63 | | | | 15.0 ^{Note 2} | mA | |
| | | Total of P00 to P04, P40 to P43, P120, | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | 15.0 9.0 4.5 | mA | | |
| | | P130, P140, P141 | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} < 2.7 \text{ V}$ | | | 9.0 | mA | |
| | | (When duty ≤ 70% ^{Note 3}) | $1.6 \text{ V} \le \text{EV}_{\text{DD0}} < 1.8 \text{ V}$ | | | 4.5 | mA | |
| | | P31, P50, P51, P60 to P63, | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | 35.0 | mA | |
| | | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} < 2.7 \text{ V}$ | | | 20.0 | mA | |
| | | P70 to P77 (When duty ≤ 70% ^{Note 3}) | $1.6 \text{ V} \le \text{EV}_{\text{DD0}} \le 1.8 \text{ V}$ | | | 10.0 | mA | |
| | | Total of all pins (When duty ≤ 70% ^{Note 3}) | | | | 50.0 | mA | |
| | IOL2 | Per pin for P20 to P27, P150 to P154 | | | | 0.4 ^{Note 2} | mA | |
| | | Total of all pins (When duty ≤ 70% ^{Note 3}) | $1.6 \text{ V} \le \text{AV}_{\text{DD}} \le 3.6 \text{ V}$ | | | 15.0 ^{Note 2} 15.0 9.0 4.5 35.0 20.0 10.0 50.0 | mA | |

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, 1.6 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

- **Notes 1**. Value of current at which the device operation is guaranteed even if the current flows from an output pin to the EVss0 and Vss pin.
 - **2.** However, do not exceed the total current value.
 - **3.** Specification under conditions where the duty factor \leq 70%.

The output current value that has changed to the duty factor > 70% the duty ratio can can be calculated with the following expression (when changing the duty factor from 70% to n%).

• Total output current of pins = $(I_{OL} \times 0.7)/(n \times 0.01)$ <Example> Where n = 80% and IoL = 10.0 mA Total output current of pins = $(10.0 \times 0.7)/(80 \times 0.01) \cong 8.7$ mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



| Items | Symbol | $\frac{\mathbf{AV}_{DD} \leq \mathbf{V}_{DD} \leq \mathbf{3.6 V, 1.6 V} \leq \mathbf{EV}_{DD}}{\text{Conditions}}$ | $0 \leq VDD \leq 3.6 V, VSS =$ | EVSSO = U MIN. | V) TYP. | MAX. | (3/5 Unit |
|------------------------|--------|--|--|-------------------|-------------------|----------|---------------------|
| Input voltage, high | ViH1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | Normal input buffer | 0.8EVddo | | EVDDO | V |
| | VIH2 | P01, P03, P04, P10, P11, P13 to P16, P43 | TTL input buffer $3.3 V \le EV_{DD0} \le 3.6 V$ 2.0 EV_{DD0} TTL input buffer $1.6 V \le EV_{DD0} < 3.3 V$ 1.5 EV_{DD0} 0.7AV_DD AV_{DD} 0.7AV_DD AV_{DD} 0.7EV_{DD0}6.0EXCLISE RESET0.8V_{DD} | V | | | |
| | | | | 1.5 | | EVDD0 | V |
| | VIH3 | P20 to P27, P150 to P154 | | 0.7AVDD | | AVDD | V |
| | VIH4 | P60 to P63 | | 0.7EVDD0 | | 6.0 | V |
| | VIH5 | P121 to P124, P137, EXCLK, EXCLK | (S, RESET | 0.8Vdd | | Vdd | V |
| Input voltage, low | VIL1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | Normal input buffer | 0 | | 0.2EVDD0 | V |
| | VIL2 | P01, P03, P04, P10, P11, P13 to P16, P43 | TTL input buffer $3.3 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | 0 | | 0.5 | V |
| | | | TTL input buffer 1.6 V \leq EV _{DD0} $<$ 3.3 V | 0 | | 0.32 | V |
| | VIL3 | P20 to P27, P150 to P154 | | 0 | | 0.3AVDD | V |
| | VIL4 | P60 to P63 | | 0 | | 0.3EVDD0 | V |
| | VIL5 | P121 to P124, P137, EXCLK, EXCLK | (S, RESET | 0 | | 0.2VDD | V |

 $(T_A = -40 \text{ to } +85^{\circ}\text{C} = 1.6 \text{ V} \le 4 \text{ Vpp} \le 3.6 \text{ V} = 1.6 \text{ V} \le F \text{ Vpp} \le 3.6 \text{ V} = 5 \text{ Vss} = 0.0 \text{ V}$

Caution The maximum value of VIH of pins P00, P02 to P04, P10 to P15, P43, P50, P71, and P74 is EVDD0, even in the N-ch open-drain mode.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



| Items | Symbol | $\leq AV_{DD} \leq V_{DD} \leq 3.6 \text{ V}, 1.6 \text{ V} \leq EV_{DD}$ Conditions | ע ב טע ע א ס.כ ב טע ע ב ט = 1 | MIN. | <u>v)</u> TYP. | MAX. | (4/ Unit |
|-----------------|--------|--|--|----------------------------|-------------------|------|--------------------|
| Output voltage, | VOH1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, | 2.7 V ≤ EV _{DD0} ≤ 3.6 V, Іон1 = −2.0 mA | EV _{DD0} – 0.6 | | | V |
| | | P120, P130, P140, P141 | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OH1}} = -1.5 \text{ mA}$ | EV _{DD0} – 0.5 | | | V |
| | | | 1.6 V ≤ EV _{DD0} ≤ 3.6 V, Іон1 = −1.0 mA | EV _{DD0} - 0.5 | | | V |
| | Voh2 | P20 to P27, P150 to P154 | $1.6 \text{ V} \le \text{AV}_{\text{DD}} \le 3.6 \text{ V},$ IOH2 = -100 μ A | AV _{DD} – 0.5 | | | V |
| Output voltage, | Vol1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, | $2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL1}} = 3.0 \text{ mA}$ | | | 0.6 | V |
| | | P120, P130, P140, P141 | $2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL1}} = 1.5 \text{ mA}$ | | | 0.4 | V |
| | | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL1}} = 0.6 \text{ mA}$ | | | 0.4 | V |
| | | | $1.6 \text{ V} \le \text{EV}_{\text{DD0}} < 1.8 \text{ V},$ $I_{\text{OL1}} = 0.3 \text{ mA}$ | | | 0.4 | V |
| | Vol2 | P20 to P27, P150 to P154 | $1.6 V \le AV_{DD} \le 3.6 V,$ $I_{OL2} = 400 \ \mu A$ | | | 0.4 | V |
| | Vol3 | Vol3 P60 to P63 | $2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL3}} = 3.0 \text{ mA}$ | | | 0.4 | V |
| | | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL3}} = 2.0 \text{ mA}$ | | | 0.4 | V |
| | | | $1.6 \text{ V} \le \text{EV}_{\text{DD0}} < 1.8 \text{ V},$ $I_{\text{OL3}} = 1.0 \text{ mA}$ | | | 0.4 | V |

Caution P00, P02 to P04, P10 to P15, P43, P50, P71, and P74 do not output high level in N-ch open-drain mode.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



| Items | Symbol | Conditio | ons | | MIN. | TYP. | MAX. | Unit |
|--------------------------------|--------|---|------------|---|------|------|------|------|
| Input leakage current, high | ILIH1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P63, P70 to P77, P120, P140, P141 | VI = EVDDO | | | | 1 | μA |
| | ILIH2 | P137, RESET | VI = VDD | | | | 1 | μA |
| | Іцнз | P121 to P124 (X1, X2, XT1, XT2, EXCLK, EXCLKS) | VI = VDD | In input port or external clock input | | | 1 | μA |
| | | | | In resonator connection | | | 10 | μA |
| | Ілн4 | P20 to P27, P150 to P154 | VI = AVDD | | | | 1 | μA |
| Input leakage current, low | ILIL1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P67, P70 to P77, P120, P140, P141 | Vi = EVsso | VI = EVSS0 | | | -1 | μA |
| | | P137, RESET | VI = Vss | | | | -1 | μA |
| | ILIL3 | P121 to P124 (X1, X2, XT1, XT2, EXCLK, EXCLKS) | VI = Vss | In input port or external clock input | | | -1 | μA |
| | | | | In resonator connection | | | -10 | μA |
| | ILIL4 | P20 to P27, P150 to P154 | VI = AVss | VI = AVss | | | -1 | μA |
| On-chip pull-up resistance | Ru | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | VI = EVsso | , In input port | 10 | 20 | 100 | kΩ |

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Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



2.3.2 Supply current characteristics

| Parameter | Symbol | | | /, Vss = EVss₀ = 0 V) Conditions | | | MIN. | TYP. | MAX. | (1) Uni |
|-------------------------------------|--------|----------------|--|--|------------------|-------------------------|------|------|------|--------------------|
| Supply current ^{Note 1} | | Operating mode | HS (high-speed main) mode ^{Note 5} | f⊮ = 32 MHz ^{Note 3} | Basic operation | V _{DD} = 3.0 V | | 2.1 | | mA |
| | | | | | Normal operation | V _{DD} = 3.0 V | | 4.6 | 7.0 | mA |
| | | | | fi⊢ = 24 MHz ^{Note 3} | Normal operation | V _{DD} = 3.0 V | | 3.7 | 5.5 | mA |
| | | | | f _{IH} = 16 MHz ^{Note 3} | Normal operation | V _{DD} = 3.0 V | | 2.7 | 4.0 | mA |
| | | | LS (low-speed | f _{IH} = 8 MHz ^{Note 3} | Normal | V _{DD} = 3.0 V | | 1.2 | 1.8 | m/ |
| | | | main) mode ^{Note 5} | | operation | V _{DD} = 2.0 V | | 1.2 | 1.8 | |
| | | | LV (Low-voltage | f _{IH} = 4 MHz ^{Note 3} | Normal | V _{DD} = 3.0 V | | 1.2 | 1.7 | m/ |
| | | | main) mode ^{Note 5} | | operation | V _{DD} = 2.0 V | | 1.2 | 1.7 | |
| | | | HS (high-speed main) mode ^{Note 5} | f _{MX} = 20 MHz ^{Note 2} , V _{DD} = 3.0 V | Normal operation | Square wave input | | 3.0 | 4.6 | m |
| | | | | | | Resonator connection | | 3.2 | 4.8 | |
| | | | | $f_{MX} = 10 \text{ MHz}^{\text{Note 2}},$ $V_{\text{DD}} = 3.0 \text{ V}$ | Normal operation | Square wave input | | 1.9 | 2.7 | m |
| | | | | | | Resonator connection | | 1.9 | 2.7 | |
| | | | LS (low-speed main) mode ^{Note 5} | f _{MX} = 8 MHz ^{Note 2} , V _{DD} = 3.0 V | Normal operation | Square wave input | | 1.1 | 1.7 | m |
| | | | | | | Resonator connection | | 1.1 | 1.7 | |
| | | | | f _{MX} = 8 MHz ^{Note 2} , V _{DD} = 2.0 V | Normal operation | Square wave input | | 1.1 | 1.7 | m |
| | | | | | | Resonator connection | | 1.1 | 1.7 | |
| | | | Subsystem clock mode | f _{SUB} = 32.768 kHz ^{Note 4} T _A = -40°C | Normal operation | Square wave input | | 4.1 | 4.9 | μ |
| | | | | | | Resonator connection | | 4.2 | 5.0 | |
| | | | | f _{SUB} = 32.768 kHz ^{Note 4} T _A = +25°C | Normal operation | Square wave input | | 4.2 | 4.9 | μ |
| | | | | | | Resonator connection | | 4.3 | 5.0 | |
| | | | | f _{SUB} = 32.768 kHz ^{Note 4} T _A = +50°C | Normal operation | Square wave input | | 4.3 | 5.5 | μ |
| | | | | | | Resonator connection | | 4.4 | 5.6 | |
| | | | | f _{SUB} = 32.768 kHz ^{Note 4} T _A = +70°C | Normal operation | Square wave input | | 4.5 | 6.3 | μ |
| | | | | | | Resonator connection | | 4.6 | 6.4 | |
| | | | | f _{SUB} = 32.768 kHz ^{Note 4} T _A = +85°C | Normal operation | Square wave input | | 4.8 | 7.7 | μ |
| | | | | | | Resonator connection | | 4.9 | 7.8 |] |

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{EV}_{DD0} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{ V}_{SS} = \text{EV}_{SS0} = 0 \text{ V})$

(Notes and Remarks are listed on the next page.)

- **Notes 1.** Total current flowing into V_{DD} and EV_{DD0}, including the input leakage current flowing when the level of the input pin is fixed to V_{DD}, EV_{DD0} or Vss, EV_{SS0}. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, LVD circuit, I/O port, on-chip pull-up/pull-down resistors, and data flash rewriting.
 - 2. When high-speed on-chip oscillator and subsystem clock are stopped.
 - 3. When high-speed system clock and subsystem clock are stopped.
 - **4.** When high-speed on-chip oscillator and high-speed system clock are stopped. When setting ultra-low power consumption oscillation (AMPHS1 = 1). Not including the current flowing into the RTC, 12-bit interval timer and watchdog timer
 - **5.** Relationship between operation voltage width, operation frequency of CPU and operation mode is as below.

HS (high-speed main) mode: $V_{DD} = 2.7 V \text{ to } 3.6 V@1 \text{ MHz to } 32 \text{ MHz}$ $V_{DD} = 2.4 V \text{ to } 3.6 V@1 \text{ MHz to } 16 \text{ MHz}$ LS (low-speed main) mode: $V_{DD} = 1.8 V \text{ to } 3.6 V@1 \text{ MHz to } 8 \text{ MHz}$ LV (Low-voltage main) mode: $V_{DD} = 1.6 V \text{ to } 3.6 V@1 \text{ MHz to } 4 \text{ MHz}$

- **Remarks 1.** f_{MX}: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
 - 2. fin: High-speed on-chip oscillator clock frequency
 - **3.** fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
 - 4. Except subsystem clock operation, temperature condition of the TYP. value is TA = 25°C



| Parameter | Symbol | | | Conditions | | MIN. | TYP. | MAX. | Uni |
|---------------------------|-------------------------|-------------------------|------------------------------|--|-------------------------|------|------|------|-----|
| Supply | DD2Note 2 | HALT | HS (high-speed | f⊮ = 32 MHz ^{Note 4} | V _{DD} = 3.0 V | | 0.54 | 1.63 | mA |
| current ^{Note 1} | | mode | main) mode ^{Note 7} | fı⊢ = 24 MHz ^{Note 4} | V _{DD} = 3.0 V | | 0.44 | 1.28 | mA |
| | | | | f⊮ = 16 MHz ^{Note 4} | V _{DD} = 3.0 V | | 0.40 | 1.00 | mA |
| | | | LS (low-speed | f⊮ = 8 MHz ^{Note 4} | V _{DD} = 3.0 V | | 270 | 530 | μA |
| | | | main) mode ^{Note 7} | | V _{DD} = 2.0 V | | 270 | 530 | |
| | | | LV (Low-voltage | fı⊢ = 4 MHz ^{Note 4} | V _{DD} = 3.0 V | | 435 | 640 | μA |
| | | | main) mode ^{Note 7} | | V _{DD} = 2.0 V | | 435 | 640 | |
| | | | HS (high-speed | f _{MX} = 20 MHz ^{Note 3} , | Square wave input | | 0.28 | 1.00 | mA |
| | | | main) mode ^{Note 7} | V _{DD} = 3.0 V | Resonator connection | | 0.45 | 1.17 | |
| | | | | f _{MX} = 10 MHz ^{Note 3} , | Square wave input | | 0.19 | 0.60 | mA |
| | | | | V _{DD} = 3.0 V | Resonator connection | | 0.26 | 0.67 | |
| | | | LS (low-speed | f _{MX} = 8 MHz ^{Note 3} , | Square wave input | | 95 | 330 | μA |
| | | | main) mode ^{Note 7} | V _{DD} = 3.0 V | Resonator connection | | 145 | 380 | |
| | | | | f _{MX} = 8 MHz ^{Note 3} , | Square wave input | | 95 | 330 | μA |
| | V _{DD} = 2.0 V | V _{DD} = 2.0 V | Resonator connection | | 145 | 380 | | | |
| | | | Subsystem clock | | Square wave input | | 0.25 | 0.57 | μA |
| | | | mode | T _A = -40°C | Resonator connection | | 0.44 | 0.76 | |
| | | | | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.30 | 0.57 | μA |
| | | | | T _A = +25°C | Resonator connection | | 0.49 | 0.76 | |
| | | | | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.38 | 1.17 | μA |
| | | | | T _A = +50°C | Resonator connection | | 0.57 | 1.36 | |
| | | | | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.52 | 1.97 | μA |
| | | | | T _A = +70°C | Resonator connection | | 0.71 | 2.16 | |
| | | | | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.97 | 3.37 | μA |
| | | | T _A = +85°C | Resonator connection | | 1.16 | 3.56 | | |
| | IDD3 ^{Note 6} | STOP | T _A = -40°C | | | | 0.16 | 0.50 | μA |
| | | mode ^{Note 8} | T _A = +25°C | | | | 0.23 | 0.50 | |
| | | T _A = +50°C | | | | 0.34 | 1.10 | | |
| | | | T _A = +70°C | | | | 0.46 | 1.90 | |
| | | | T _A = +85°C | | | | 0.75 | 3.30 | |

 $40 t_{0} \pm 95\%$ $4 \in V < EV_{PP} < V_{PP} < 2 \in V / V_{PP} = EV_{PP} = 0 / V_{PP}$ /**т**

(Notes and Remarks are listed on the next page.)



- Notes 1. Total current flowing into VDD and EVDDO, including the input leakage current flowing when the level of the input pin is fixed to VDD, EVDDO or Vss, EVsso. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, LVD circuit, I/O port, on-chip pull-up/pull-down resistors, and data flash rewriting.
 - 2. During HALT instruction execution by flash memory.
 - 3. When high-speed on-chip oscillator and subsystem clock are stopped.
 - 4. When high-speed system clock and subsystem clock are stopped.
 - When high-speed on-chip oscillator and high-speed system clock are stopped. When RTCLPC = 1 and setting ultra-low current consumption (AMPHS1 = 1). Including the current flowing into the RTC. However, not including the current flowing into the 12-bit interval timer, and watchdog timer.
 - **6.** When subsystem clock is stopped. Not including the current flowing into the RTC, 12-bit interval timer, watchdog timer.
 - **7.** Relationship between operation voltage width, operation frequency of CPU and operation mode is as below.

HS (high-speed main) mode: $2.7 \text{ V} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}@1 \text{ MHz}$ to 32 MHz

- 2.4 V \leq V_DD \leq 3.6 V@1 MHz to 16 MHz
- LS (low-speed main) mode: $1.8 \text{ V} \le \text{V}_{\text{DD}} < 3.6 \text{ V}@1 \text{ MHz}$ to 8 MHz
- LV (low-voltage main) mode: $1.6 \text{ V} \le \text{V}_{\text{DD}} \le 3.6 \text{ V} @1 \text{ MHz}$ to 4 MHz
- Regarding the value for current to operate the subsystem clock in STOP mode, refer to that in HALT mode.
- **Remarks 1.** fMX: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
 - 2. fin: High-speed on-chip oscillator clock frequency
 - **3.** fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
 - Except subsystem clock operation and STOP mode, temperature condition of the TYP. value is T_A = 25°C



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| Parameter | Symbol | | Conditions | MIN. | TYP. | MAX. | Unit |
|--|------------------------------|------------------------------|--|------|------|--|------|
| Low-speed on-chip oscillator operating current | _{FIL} Note 1 | | | | 0.20 | | μA |
| RTC operating current | RTC ^{Notes 1, 2, 3} | | | | 0.02 | | μA |
| 12-bit interval timer operating current | ITNotes 1, 2, 4 | | | | 0.02 | | μA |
| Watchdog timer operating current | WDT ^{Notes 1, 2, 5} | fı∟ = 15 kHz | | | 0.22 | | μA |
| A/D converter operating current | ADC ^{Notes 6, 7} | AV _{DD} = 3.0 V, W | hen conversion at maximum speed | | 420 | 720 | μA |
| AV _{REF(+)} current | AVREF ^{Note 8} | AV _{DD} = 3.0 V, AI | DREFP1 = 0, ADREFP0 = 0 ^{Note 7} | | 14.0 | 14.025.014.025.0 | μA |
| .vref(+) cuirent | | | ADREFP1 = 0, ADREFP0 = $1^{\text{Note 10}}$ | | 14.0 | 25.0 | μA |
| | | ADREFP1 = 1, A | ADREFP0 = 0 ^{Note 1} | | 14.0 | 25.0 | μA |
| A/D converter reference voltage current | ADREF ^{Notes 1, 9} | V _{DD} = 3.0 V | | | 75.0 | 14.025.014.025.0 | |
| Temperature sensor operating current | _{TMP} Note 1 | V _{DD} = 3.0 V | | | 75.0 | | μA |
| LVD operating current | LVD ^{Notes 1, 11} | | | | 0.08 | | μA |
| BGO operating current | BGO ^{Notes 1, 12} | | | | 2.5 | 12.2 | mA |
| Self-programming operating current | FSP ^{Notes 1, 13} | | | | 2.5 | 12.2 | mA |
| SNOOZE operating | Isnoz | A/D converter | The mode is performed ^{Notes 1, 14} | | 0.50 | 0.60 | mA |
| current | | operation | During A/D conversion ^{Note 1} | | 0.60 | 0.75 | mA |
| | | (AV _{DD} = 3.0 V) | During A/D conversion ^{Note 7} | | 420 | 720 | μA |
| | | CSI/UART opera | ation ^{Note 1} | | 0.70 | 25.0 0.08 2.5 12.2 2.5 12.2 0.50 0.60 0.75 420 | mA |

(Notes and Remarks are listed on the next page.)



- <R> Notes 1. Current flowing to VDD.
 - 2. When high-speed on-chip oscillator and high-speed system clock are stopped.
 - 3. Current flowing only to the real-time clock (RTC) (excluding the operating current of the low-speed on-chip ocsillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IRTC, when the real-time clock operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added. IDD2 subsystem clock operation includes the operational current of the real-time clock.
 - 4. Current flowing only to the 12-bit interval timer (excluding the operating current of the low-speed on-chip ocsillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IIT, when the 12-bit interval timer operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added.
 - 5. Current flowing only to the watchdog timer (including the operating current of the low-speed on-chip oscillator). The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2, or IDD3 and IWDT when the watchdog timer is in operation.
 - 6. Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IADC, IAVREF, IADREF when the A/D converter operates in an operation mode or the HALT mode.
 - 7. Current flowing to the AVDD.
 - 8. Current flowing from the reference voltage source of A/D converter.
 - 9. Operation current flowing to the internal reference voltage.
 - **10.** Current flowing to the AVREFP.
 - **11.** Current flowing only to the LVD circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and ILVD when the LVD circuit is in operation.
 - 12. Current flowing only during data flash rewrite.
 - **13.** Current flowing only during self programming.

Remarks 1. fil: Low-speed on-chip oscillator clock frequency

- 2. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
- 3. fclk: CPU/peripheral hardware clock frequency
- 4. Temperature condition of the TYP. value is $T_A = 25^{\circ}C$



2.4 AC Characteristics

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, \text{ AV}_{DD} \le \text{V}_{DD} \le 3.6 \text{ V}, 1.6 \text{ V} \le \text{EV}_{DD0} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{ V}_{SS} = \text{EV}_{SS0} = 0 \text{ V})$

| Items | Symbol | | Cond | itions | | MIN. | TYP. | MAX. | Unit |
|--|------------------|--|-------------------------|--|---|-----------|------|------|--------------------|
| Instruction cycle (minimum | Тсү | Main system | HS (high-s | peed | $2.7~V \leq V_{\text{DD}} \leq 3.6~V$ | 0.03125 | | 1 | μs |
| instruction execution time) | | clock (fmain) operation | main) mod | le | $2.4 \text{ V} \le \text{V}_{\text{DD}} < 2.7 \text{ V}$ | 0.0625 | | 1 | μs |
| | | operation | LS (low-sp main) mod | | $1.8 \text{ V} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}$ | 0.125 | | 1 | μs |
| | | | LV (low-vo main) mod | • | $1.6 \text{ V} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}$ | 0.25 | | 1 | μs |
| | | Subsystem clooperation | ock (fsuв) | | $1.8 \text{ V} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}$ | 28.5 | 30.5 | 31.3 | μs |
| | | In the self . | HS (high-s | | $2.7~V \leq V_{\text{DD}} \leq 3.6~V$ | | | 1 | μs |
| | | programming mode | main) mod | le | $2.4~V \leq V_{\text{DD}} < 2.7~V$ | 0.0625 | | 1 | μs |
| | | mode | LS (low-sp main) mod | | $1.8 \text{ V} \leq V_{\text{DD}} \leq 3.6 \text{ V}$ | 0.125 | | 1 | μs |
| | | | LV (low-vo main) mod | • | $1.6 \text{ V} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}$ | 0.25 | | 1 | μs |
| External system clock | fex | $2.7~V \leq V_{\text{DD}} \leq$ | 3.6 V | | | 1.0 | | 20.0 | MHz |
| frequency | | $2.4~V \leq V_{\text{DD}} <$ | 2.7 V | | | 1.0 | | 16.0 | MHz |
| | | $1.8 \text{ V} \le \text{V}_{\text{DD}}$ < | 2.4 V | | | 1.0 | | 8.0 | MHz |
| | | $1.6 V \le V_{DD}$ < | 1.8 V | | | 1.0 | | 4.0 | MHz |
| | fexs | | | | | 32 | | 35 | kHz |
| External system clock input | texh, texl | | | | | | | | ns |
| high-level width, low-level width | | $2.4~V \leq V_{\text{DD}} <$ | 2.7 V | | | 30 | | | ns |
| | | $1.8 \text{ V} \le \text{V}_{\text{DD}}$ < | 2.4 V | | | 60 | | | ns |
| | | 1.6 V \leq V_DD < | 1.8 V | | | 120 | | | ns |
| | texhs, texls | | | | | 13.7 | | | μs |
| TI00, TI01, TI03 to TI07 input high-level width, low-level width | t⊤ıн, t⊤ı∟ | | | | | 1/fмск+10 | | | ns ^{Note} |
| TO00, TO01, TO03 to | fто | $ \begin{array}{l} \text{HS (high-speed main)} \\ \text{mode} \end{array} \begin{array}{l} 2.7 \ \text{V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \ \text{V} \\ \hline 1.8 \ \text{V} \leq \text{EV}_{\text{DD0}} < 2.7 \ \text{V} \\ \hline 1.6 \ \text{V} \leq \text{EV}_{\text{DD0}} < 1.8 \ \text{V} \\ \hline \text{LS (low-speed main)} \end{array} \begin{array}{l} 1.8 \ \text{V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \ \text{V} \end{array} $ | | $\leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | | | 8 | MHz | |
| TO07 output frequency | | | | $1.8 \text{ V} \le \text{EV}_{\text{DD0}} < 2.7 \text{ V}$ | | | | 4 | MHz |
| | | | | $1.6 \text{ V} \le \text{EV}_{\text{DD0}} < 1.8 \text{ V}$ | | | | 2 | MHz |
| | | | | $1.8 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | | | | 4 | MHz |
| | | mode | | $1.6 \text{ V} \le \text{EV}_{\text{DD0}} < 1.8 \text{ V}$ | | | | 2 | MHz |
| | | LV (low-voltag mode | ge main) | $1.6 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | | | | 2 | MHz |
| PCLBUZ0, PCLBUZ1 | f PCL | HS (high-spee | ed main) | 2.7 V | $\leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | | | 8 | MHz |
| output frequency | | mode | | 1.8 V ≤ EV _{DD0} < 2.7 V | | | | 4 | MHz |
| | | | | 1.6 V | $\leq EV_{DD0} < 1.8 V$ | | | 2 | MHz |
| | | LS (low-speed | d main) | 1.8 V | $\leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | | | 4 | MHz |
| | | mode | | 1.6 V | $\leq EV_{DD0} < 1.8 V$ | | | 2 | MHz |
| | | LV (low-voltag | ge main) | 1.8 V | $\leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | | | 4 | MHz |
| | | mode | Γ | 1.6 V | $\leq EV_{DD0} < 1.8 V$ | | | 2 | MHz |
| Interrupt input high-level | tinth, tintl | INTP0 | | 1.6 V | $\leq V_{\text{DD}} \leq 3.6 \text{ V}$ | 1 | | | μs |
| width, low-level width | | INTP1 to INT | P11 | 1.6 V | $\leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 1 | | | μs |
| Key interrupt input high-level width, low-level | t KR | KR0 to KR9 | | | $ \leq EV_{DD0} \leq 3.6 \text{ V}, \\ \leq AV_{DD0} \leq 3.6 \text{ V} $ | 250 | | | ns |
| width | | | | | $\leq EV_{DD0} < 1.8 \text{ V},$ $\leq AV_{DD0} < 1.8 \text{ V}$ | 1 | | | μs |
| RESET low-level width | t _{RSL} | | | | | 10 | | | μs |

(Note and Remark are listed on the next page.)



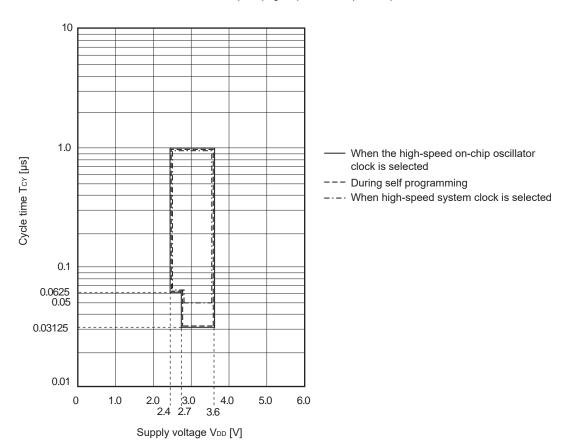
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Note The following conditions are required for low-voltage interface when $EV_{DD0} < V_{DD}$. $1.8 V \le EV_{DD0} < 2.7 V$: MIN. 125 ns $1.6 V \le EV_{DD0} < 1.8 V$: MIN. 250 ns

Remark fMCK: Timer array unit operation clock frequency (Operation clock to be set by the CKS0n bit of timer clock select register 0 (TPS0) and timer mode register 0n (TMR0n). n: Channel number (n = 0 to 7))

Minimum Instruction Execution Time during Main System Clock Operation

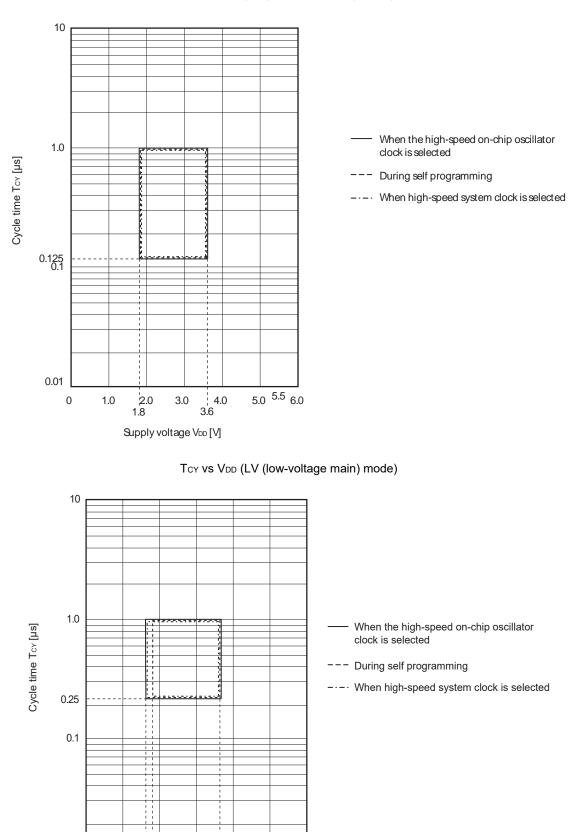
TCY vs VDD (HS (high-speed main) mode)



<R>

<R>

TCY vs VDD (LS (low-speed main) mode)



0.01

0

2.0 1.6 1.8

3.0

Supply voltage VDD [V]

4.0

3.6

5.0

1.0

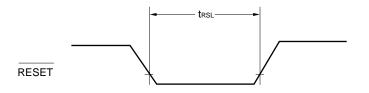


6.0

AC Timing Test Points Viн/Voн Viн/Voн Test points <R> VIL/VOL VIL/VOL **External System Clock Timing** $1/f_{\text{EX}}$ $\mathbf{t}_{\mathsf{EXL}}$ **t**exh 0.7 VDD MIN. EXCLK 0.3 VDD MAX. <R> **TI/TO Timing** t⊤ı∟ tтін TI00, TI01, TI03 to TI07 **1/f**то -TO00, TO01, TO03 to TO07 Interrupt Request Input Timing **t**INTL tinth INTP0 to INTP11 **Key Interrupt Input Timing** tk₽ KR0 to KR9



RESET Input Timing





2.5 Peripheral Functions Characteristics

AC Timing Test Points



| Ин/Vон | \geq | Test points | < | | |
|------------------------|--------|-------------|---|-----------------|--|
| $/ \downarrow VIL/VOL$ | | | | VIL/VOL $\neq $ | |

2.5.1 Serial array unit

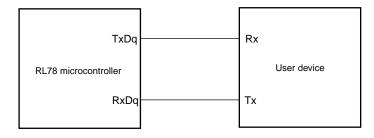
(1) During communication at same potential (UART mode) ($T_A = -40$ to +85°C, 1.6 V $\leq EV_{DD0} \leq V_{DD} \leq$ 3.6 V, Vss = EVsso = 0 V)

| Parameter | Symbol | Conditions | HS | Note 1 | LS | Note 2 | LV | lote 3 | Unit |
|---------------------------------|--------|--|------|-----------------------|------|-----------------------|------|--------|------|
| | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| Transfer rate ^{Note 4} | | $2.4~V \leq EV_{\text{DD}} \leq 3.6~V$ | | fмск/6 | | fмск/6 | | fмск/6 | bps |
| | | Theoretical value of the maximum transfer rate f _{MCK} = f _{CLK} ^{Note 6} | | 5.3 ^{Note 5} | | 1.3 | | 0.6 | Mbps |
| | | $1.8 \text{ V} \leq \text{EV}_{\text{DD}} \leq 3.6 \text{ V}$ | | fмск/6 | | fмск/6 | | fмск/6 | bps |
| | | Theoretical value of the maximum transfer rate f _{MCK} = f _{CLK} ^{Note 6} | | 5.3 ^{Note 5} | | 1.3 | | 0.6 | Mbps |
| | | $1.7~V \le EV_{\text{DD}} \le 3.6~V$ | | fмск/6 | | fмск/6 | | fмск/6 | bps |
| | | Theoretical value of the maximum transfer rate $f_{MCK} = f_{CLK}^{Note 6}$ | | 5.3 ^{Note 5} | | 1.3 ^{Note 5} | | 0.6 | Mbps |
| | | $1.6 \text{ V} \leq \text{EV}_{\text{DD}} \leq 3.6 \text{ V}$ | | - | | fмск/6 | | fмск/6 | bps |
| | | Theoretical value of the maximum transfer rate $f_{MCK} = f_{CLK}^{Note 6}$ | | _ | | 1.3 ^{Note 5} | | 0.6 | Mbps |

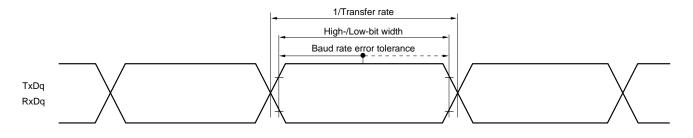
Notes 1. HS is condition of HS (high-speed main) mode.

- 2. LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- 4. Transfer rate in the SNOOZE mode is 4800 bps.
- 5. The following conditions are required for low-voltage interface when $EV_{DD0} < V_{DD}$.
 - $2.4 \text{ V} \le \text{EV}_{\text{DD0}} < 2.7 \text{ V}$: MAX. 2.6 Mbps
 - $1.8~V \leq EV_{\text{DD0}}$ < 2.4 V : MAX. 1.3 Mbps
 - $1.6 \text{ V} \le \text{EV}_{\text{DD0}} < 1.8 \text{ V}$: MAX. 0.6 Mbps
- **6.** fclk in each operating mode is as below.
 - HS (high-speed main) mode: fclk = 32 MHz
 - LS (low-speed main) mode: fclk = 8 MHz
 - LV (low-voltage main) mode: fclk = 4 MHz
- Caution Select the normal input buffer for the RxDq pin and the normal output mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg).

UART mode connection diagram (during communication at same potential)



UART mode bit width (during communication at same potential) (reference)



Remarks 1. q: UART number (q = 0 to 2), g: PIM and POM number (g = 0, 1)

2. fMCK: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

n: Channel number (mn = 00 to 03, 10, 11))



(2) During communication at same potential (CSI mode) (master mode, SCKp... internal clock output, corresponding CSI00 only)

| Parameter | Symbol | Conditions | | HS ^{Note 1} | | LS ^{Note 2} | | LV ^{Note 3} | | Unit |
|--|--------------|--|--------------|----------------------|------|----------------------|------|----------------------|------|------|
| | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SCKp cycle time | tkcy1 | $2.7~V \leq EV_{\text{DD}} \leq 3.6~V$ | tkcy1≥2/fcLk | 83.3 | | 250 | | 500 | | ns |
| SCKp high-/low-level width | tкнı, | $2.7~V \leq EV_{\text{DD}} \leq 3.6~V$ | | tксү1/2 | | tксү1/2 | | t ксү1/2 | | ns |
| | t KL1 | | | -10 | | -50 | | -50 | | |
| SIp setup time (to SCKp↑) ^{Note 4} | tsıĸ1 | $2.7~V \leq EV_{\text{DD}} \leq 3.6~V$ | 1 | 33 | | 110 | | 110 | | ns |
| SIp hold time (from SCKp↑) ^{Note 4} | tksi1 | $2.7~V \leq EV_{\text{DD}} \leq 3.6~V$ | 1 | 10 | | 10 | | 10 | | ns |
| Delay time from SCKp↓ to SOp output ^{Note 5} | tkso1 | C = 20 pF ^{Note 6} | | | 10 | | 10 | | 10 | ns |

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

Notes 1. HS is condition of HS (high-speed main) mode.

- 2. LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- 5. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- 6. C is the load capacitance of the SCKp and SOp output lines.

Caution Select the normal input buffer for the SIp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

- **Remarks 1.** p: CSI number (p = 00), m: Unit number (m = 0), n: Channel number (n = 0),
 - g: PIM and POM numbers (g = 1)
 - fMCK: Serial array unit operation clock frequency (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00))



(3) During communication at same potential (CSI mode) (master mode, SCKp... internal clock output) (T_A = -40 to +85°C, 1.6 V ≤ EV_{DD} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

| Parameter | Symbol | Conditions | 6 | HS | Note 1 | LS | lote 2 | LV ^{Note 3} | | Unit |
|-----------------------------------|---------------|--|--|-----------------|--------|-----------------|--------|----------------------|------|------|
| | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SCKp cycle time | t ксү2 | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | tkcy1 ≥ 4/fclk | 125 | | 500 | | 1000 | | ns |
| | | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | tkcy1 ≥ 4/fclk | 250 | | 500 | | 1000 | | ns |
| | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | tkcy1 ≥ 4/fclk | 500 | | 500 | | 1000 | | ns |
| | | $1.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | tkcy1 ≥ 4/fclk | 1000 | | 1000 | | 1000 | | ns |
| | | $1.6~V \leq EV_{\text{DD0}} \leq 3.6~V$ | $t_{\text{KCY1}} \ge 4/f_{\text{CLK}}$ | - | | 1000 | | 1000 | | ns |
| SCKp high-/low-level width | tкн2, tкL2 | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | tксү2/2 –18 | | tксү2/2 –50 | | tксү₂/2 –50 | | ns |
| | | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | | | tксү2/2 –50 | | tксү2/2 –50 | | ns |
| | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | | tксү2/2 –50 | | tксү2/2 –50 | | tксү2/2 –50 | | ns |
| | | $1.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | | tксү2/2 –100 | | tксү2/2 –100 | | tксү2/2 –100 | | ns |
| | | $1.6~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | - | | tксү₂/2 −100 | | tксү₂/2 −100 | | ns |
| SIp setup time | tsık2 | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | 44 | | 110 | | 110 | | ns |
| (to SCKp↑) ^{Note 4} | | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | 75 | | 110 | | 110 | | ns |
| | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | 110 | | 110 | | 110 | | ns |
| | | $1.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | 220 | | 220 | | 220 | | ns |
| | | $1.6~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | _ | | 220 | | 220 | | ns |
| SIp hold time | tksi2 | $1.7~V \leq EV_{\text{DD}} \leq 3.6~V$ | | 19 | | 19 | | 19 | | ns |
| (from SCKp↑) ^{Note 4} | | $1.6~V \leq EV_{\text{DD}} \leq 3.6~V$ | | _ | | 19 | | 19 | | ns |
| Delay time from SCKp \downarrow | tkso2 | $1.7~V \leq EV_{\text{DD}} \leq 3.6~V$ | $C = 30 \text{ pF}^{Note 6}$ | | 25 | | 25 | | 25 | ns |
| to SOp output ^{Note 5} | | $1.6~V \leq EV_{\text{DD}} \leq 3.6~V$ | $C = 30 pF^{Note 6}$ | | _ | | 25 | | 25 | ns |

Notes 1. HS is condition of HS (high-speed main) mode.

- **2.** LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- 4. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- 5. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- 6. C is the load capacitance of the SCKp and SOp output lines.
- Caution Select the normal input buffer for the SIp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).
- **Remark** p: CSI number (p = 00, 01, 10, 11, 20, 21), m: Unit number (m = 0, 1), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 1)



(4) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input) ($T_A = -40$ to $+85^{\circ}C$, 1.6 V $\leq EV_{DD0} \leq V_{DD} \leq 3.6$ V, Vss = $EV_{SS0} = 0$ V)

| Parameter | Symbol | C | Condition | าร | HS | Note 1 | LS | lote 2 | LVN | ote 3 | Unit |
|---|---------------|--|-----------|-----------------------------|---------------|----------------|----------------|----------------|----------------|----------------|------|
| | | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SCKp cycle time ^{Note 4} | t ксү2 | $2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq$ | ≦ 3.6 V | 16 MHz < fмск | 8/fмск | | - | | - | | ns |
| | | | | $f_{MCK} ≤ 16 MHz$ | 6/fмск | | 6/fмск | | 6/fмск | | ns |
| | | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} \leq$ | ≦ 3.6 V | | 6/fмск | | 6/fмск | | 6/fмск | | ns |
| | | | | | and | | and | | and | | |
| | | | | | 500ns | | 500ns | | 500ns | | |
| | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq$ | ≤ 3.6 V | | 6/fмск and | | 6/fмск and | | 6/fмск and | | ns |
| | | | | | 750ns | | 750ns | | 750ns | | |
| | | 1.7 V ≤ EV _{DD0} ≤ | ≤ 3.6 V | | 6/fмск | | 6/fмск | | 6/fмск | | ns |
| | | | | | and | | and | | and | | |
| | | | | | 1500ns | | 1500ns | | 1500ns | | |
| | | 1.6 V ≤ EV _{DD0} ≤ | ≦ 3.6 V | | - | | 6/fмск and | | 6/fмск and | | ns |
| | | | | | | | 1500ns | | 1500ns | | |
| SCKp high-/low-level | tкн2, | $2.7 \text{ V} \leq \text{EV}_{\text{DD}} \leq$ | 3.6 V | | tксү2/2 | | tксү2/2 | | tксү2/2 | | ns |
| width | tĸL2 | | | | -8 | | -8 | | 8 | | |
| | | $1.8 \text{ V} \le \text{EV}_{\text{DD0}} \le$ | ≦ 3.6 V | | tксү2/2 | | tксү2/2 | | tксү2/2 | | ns |
| | | | | | -18 | | -18 | | -18 | | |
| | | $1.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq$ | ≦ 3.6 V | | tксү2/2 | | tксү2/2 | | tксү2/2 | | ns |
| | | | | | -66 | | -66 | | -66 | | |
| | | 1.6 V ≤ EV _{DD0} ≤ | ≦ 3.6 V | | - | | tксү2/2 –66 | | tксү2/2 -66 | | ns |
| SIp setup time | tsik2 | 2.7 V ≤ EV _{DD0} ≤ | (36V | | 1/fмск | | _00 1/fмск | | _00 1/fмск | | ns |
| (to SCKp↑) ^{Note 5} | LSIK2 | | 20.0 V | | +20 | | +30 | | +30 | | 115 |
| , | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | | | 1/fмск | | 1/fмск | | 1/fмск | | ns |
| | | | | +30 | | +30 | | +30 | | | |
| | | $1.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | | | 1/fмск | | 1/fмск | | 1/fмск | | ns |
| | | | | | +40 | | +40 | | +40 | | |
| | | $1.6 V \le EV_{DD0} \le$ | ≦ 3.6 V | | - | | 1/fмск | | 1/fмск | | ns |
| | | | | | A.15 | | +40 | | +40 | | |
| SIp hold time (from SCKp↑) ^{Note 5} | tksi2 | $1.8 V \le EV_{DD0} \le$ | 3.6 V | | 1/fмск +31 | | 1/fмск +31 | | 1/fмск +31 | | ns |
| | | 1.7 V ≤ EV _{DD0} ≤ | 36V | | 1/fмск+ | | 1/fмск+ | | 1/fмск+ | | ns |
| | | | 0.0 1 | | 250 | | 250 | | 250 | | 110 |
| | | 1.6 V ≤ EVDD0 ≤ | ≤ 3.6 V | | _ | | 1/fмск+ | | 1/fмск+ | | ns |
| | | | | | | | 250 | | 250 | | |
| Delay time from SCKp \downarrow | tĸso2 | C = 30 pF ^{Note 7} | 2.7 V | $\leq EV_{DD0} \leq 3.6 V$ | | 2/fмск | | 2/fмск | | 2/f мск | ns |
| to SOp output ^{Note 6} | | | | | | +44 | | +110 | | +110 | |
| | | | 2.4 V | $\leq EV_{DD0} \leq 3.6 V$ | | 2/fмск | | 2/fмск | | 2/fмск | ns |
| | | | 4.011 | | | +75 | | +110 | | +110 | |
| | | | 1.8 V : | $\leq EV_{DD0} \leq 3.6 V$ | | 2/fмск +110 | | 2/fмск +110 | | 2/fмск +110 | ns |
| | | | 17V | ≤ EV _{DD0} ≤ 3.6 V | | 2/fмск | | 2/fмск | | 2/fмск | ns |
| | | | | | | +220 | | +220 | | +220 | 113 |
| | | 1. | 1.6 V | $\leq EV_{DD0} \leq 3.6 V$ | | _ | | 2/fмск | | 2/fмск | ns |
| | | | | | | | | +220 | | +220 | |

(Note, Caution and Remark are listed on the next page.)



- Notes 1. HS is condition of HS (high-speed main) mode.
 - **2.** LS is condition of LS (low-speed main) mode.
 - 3. LV is condition of LV (low-voltage main) mode.
 - 4. Transfer rate in the SNOOZE mode: MAX. 1 Mbps
 - When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
 - **6.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp[↑]" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
 - 7. C is the load capacitance of the SOp output lines.

Caution Select the normal input buffer for the SIp pin and SCKp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

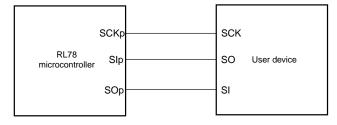
- **Remarks 1.** p: CSI number (p = 00, 01, 10, 11, 20, 21), m: Unit number (m = 0, 1), n: Channel number (n = 0 to 3),
 - g: PIM number (g = 0, 1)
 - 2. fMCK: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

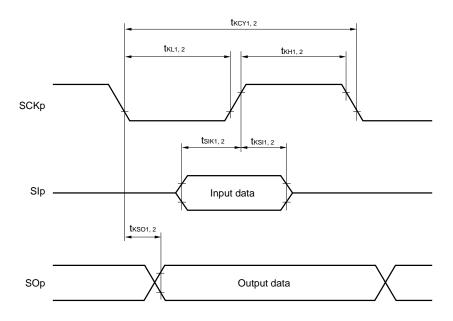
n: Channel number (mn = 00 to 03, 10, 11))



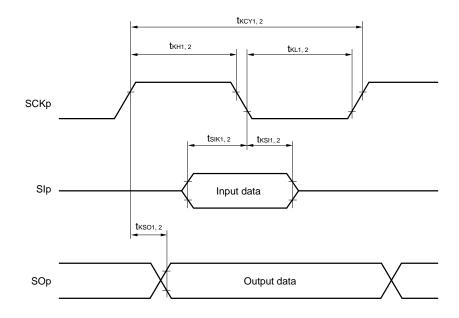
CSI mode connection diagram (during communication at same potential)

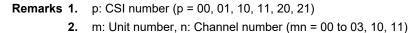


CSI mode serial transfer timing (during communication at same potential) (When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)



CSI mode serial transfer timing (during communication at same potential) (When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)





(5) During communication at same potential (simplified l²C mode) (1/2) (T_A = -40 to +85°C, 1.6 V \leq EV_{DD} \leq V_{DD} \leq 3.6 V. Vss = EV_{S0} = 0 V)

| Parameter | Symbol | Conditions | HS | Note 1 | LS | lote 2 | L٧ | Unit | |
|-----------------------------|---------|---|---|---------------------------|---|--------------------------|---|--------------------------|-----|
| | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SCLr clock frequency | fsc∟ | $\label{eq:linear} \begin{array}{l} 2.7 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 50 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 2.7 \mbox{ k}\Omega \end{array}$ | | 1000 ^{Note} 4 | | 400 ^{Note} 4 | | 400 ^{Note} 4 | kHz |
| | | $\label{eq:linear} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 3 k\Omega \end{array}$ | | 400 ^{Note 4} | | 400 ^{Note} 4 | | 400 ^{Note} 4 | kHz |
| | | $\begin{array}{l} 1.8 \ V \leq EV_{DD0} < 2.7 \ V, \\ C_{b} = 100 \ pF, \ R_{b} = 5 \ k\Omega \end{array}$ | | 300 ^{Note 4} | | 300 ^{Note} 4 | | 300 ^{Note} 4 | kHz |
| | | $\label{eq:linear} \begin{array}{l} 1.7 \mbox{ V} \leq \mbox{EV}_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 5 \mbox{ k}\Omega \end{array}$ | | 250 ^{Note 4} | | 250 ^{Note} 4 | | 250 ^{Note} 4 | kHz |
| | | $\label{eq:linear} \begin{array}{l} 1.6 \mbox{ V} \leq \mbox{EV}_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 5 \mbox{k}\Omega \end{array}$ | | _ | | 250 ^{Note} 4 | | 250 ^{Note} 4 | kHz |
| Hold time when SCLr = "L" | tLOW | $\begin{array}{l} 2.7 \ V \leq EV_{\text{DD0}} \leq 3.6 \ V, \\ C_{\text{b}} = 50 \ \text{pF}, \ R_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$ | 475 | | 1150 | | 1150 | | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 3 k\Omega \end{array}$ | 1150 | | 1150 | | 1150 | | ns |
| | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} < 2.7 \text{ V},$ $C_{\text{b}} = 100 \text{ pF}, \text{R}_{\text{b}} = 5 \text{ k}\Omega$ | 1550 | | 1550 | | 1550 | | ns |
| | | 1.7 V ≤ EV _{DD0} < 1.8 V, C _b = 100 pF, R _b = 5 kΩ | 1850 | | 1850 | | 1850 | | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.6 \mbox{ V} \leq \mbox{EV}_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 5 \mbox{k}\Omega \end{array}$ | _ | | 1850 | | 1850 | | ns |
| Hold time when SCLr = "H" | tніgн | $\begin{array}{l} 2.7 \ V \leq EV_{\text{DD0}} \leq 3.6 \ V, \\ C_{\text{b}} = 50 \ \text{pF}, \ R_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$ | 475 | | 1150 | | 1150 | | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 3 k\Omega \end{array}$ | 1150 | | 1150 | | 1150 | | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.8 \mbox{ V} \leq \mbox{EV}_{\mbox{DD0}} < 2.7 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 5 \mbox{Ω} \end{array}$ | 1550 | | 1550 | | 1550 | | ns |
| | | $1.7 V \le EV_{DD0} < 1.8 V,$ C _b = 100 pF, R _b = 5 kΩ | 1850 | | 1850 | | 1850 | | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.6 \mbox{ V} \leq \mbox{EV}_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 5 \mbox{k}\Omega \end{array}$ | - | | 1850 | | 1850 | | ns |
| Data setup time (reception) | tsu:dat | $\label{eq:linear} \begin{array}{l} 2.7 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_b = 50 \mbox{ pF}, \mbox{ R}_b = 2.7 \mbox{ k}\Omega \end{array}$ | 1/f _{МСК} + 85 ^{Note 5} | | 1/f _{мск} + 145 ^{Note 5} | | 1/f _{мск} + 145 ^{Note 5} | | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 3 k\Omega \end{array}$ | 1/f _{МСК} + 145 ^{Note 5} | | 1/f _{МСК} + 145 ^{Note 5} | | 1/f _{МСК} + 145 ^{Note 5} | | ns |
| | | $\label{eq:linear} \begin{split} 1.8 \ V &\leq EV_{\text{DD0}} < 2.7 \ V, \\ C_b &= 100 \ p\text{F}, \ R_b = 5 \ k\Omega \end{split}$ | 1/fмск+ 230 ^{Note 5} | | 1/f _{МСК} + 230 ^{Note 5} | | 1/f _{мск} + 230 ^{Note 5} | | ns |
| | | $1.7 \text{ V} \le \text{EV}_{\text{DD}} < 1.8 \text{ V},$ C _b = 100 pF, R _b = 5 kΩ | 1/f _{MCK} + 290 ^{Note 5} | | 1/f _{MCK} + 290 ^{Note 5} | | 1/f _{MCK} + 290 ^{Note 5} | | ns |
| | | 1.6 V ≤ EV _{DD0} < 1.8 V, C _b = 100 pF, R _b = 5 kΩ | _ | | 1/f _{мск} + 290 ^{Note 5} | | 1/f _{мск} + 290 ^{Note 5} | | ns |

(Notes, Caution and Remarks are listed on the next page.)

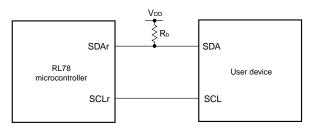


| Parameter | Symbol | Conditions | HS | HS ^{Note 1} | | lote 2 | LV ^{Note 3} | | Unit |
|-------------------------------|---------|---|------|----------------------|------|--------|----------------------|------|------|
| | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| Data hold time (transmission) | thd:dat | $\begin{array}{l} 2.7 \ \text{V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \ \text{V}, \\ \text{C}_{\text{b}} = 50 \ \text{pF}, \ \text{R}_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$ | 0 | 305 | 0 | 305 | 0 | 305 | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 3 k\Omega \end{array}$ | 0 | 355 | 0 | 355 | 0 | 355 | ns |
| | | 1.8 V ≤ EV _{DD0} < 2.7 V, C _b = 100 pF, R _b = 5 kΩ | 0 | 405 | 0 | 405 | 0 | 405 | ns |
| | | $\label{eq:linear} \begin{array}{l} 1.7 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 1.8 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 5 k\Omega \end{array}$ | 0 | 405 | 0 | 405 | 0 | 405 | ns |
| | | $1.6 \text{ V} \le \text{EV}_{\text{DD0}} < 1.8 \text{ V},$ C _b = 100 pF, R _b = 5 kΩ | - | - | 0 | 405 | 0 | 405 | ns |

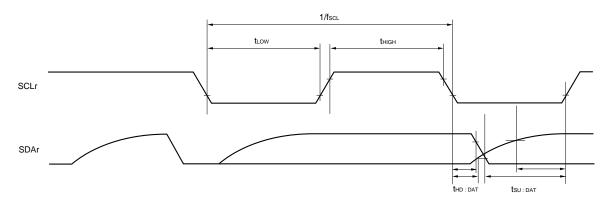
(5) During communication at same potential (simplified I²C mode) (2/2) (T_A = -40 to +85°C, 1.6 V \leq EV_{DD} \leq V_{DD} \leq 3.6 V, V_{SS} = EV_{SS0} = 0 V)

- Notes 1. HS is condition of HS (high-speed main) mode.
 - 2. LS is condition of LS (low-speed main) mode.
 - 3. LV is condition of LV (low-voltage main) mode.
 - 4. The value must also be fcLK/4 or lower.
 - 5. Set the fMCK value to keep the hold time of SCLr = "L" and SCLr = "H".
- Caution Select the normal input buffer and the N-ch open drain output (Vbb tolerance (When 25- to 48-pin products)/EVbb tolerance (When 64-pin products)) mode for the SDAr pin and the normal output mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register h (POMh).

Simplified I²C mode mode connection diagram (during communication at same potential)



Simplified I²C mode serial transfer timing (during communication at same potential)



- **Remarks 1.** R_b[Ω]: Communication line (SDAr) pull-up resistance, C_b[F]: Communication line (SDAr, SCLr) load capacitance
 - **2.** r: IIC number (r = 00, 01, 10, 11, 20, 21), g: PIM number (g = 0, 1), h: POM number (h = 0, 1)
 - fMCK: Serial array unit operation clock frequency (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number, mn = 00 to 03, 10, 11)

(6) Communication at different potential (1.8 V, 2.5 V) (UART mode) (dedicated baud rate generator output) (1/2)

| Parameter | Symbol | | Conditions | | | HS ^{Note 1} | | lote 2 | LV ^{Note 3} | | Unit |
|------------------------|--------|-----------|---|---|------|----------------------|------|--------|----------------------|--------|------|
| | | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| Transfer | | Reception | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V,$ | | | fмск/6 | | fмск/6 | | fмск/6 | bps |
| rate ^{Note 4} | | | $2.3~V \leq V_b \leq 2.7~V$ | Theoretical value of the maximum transfer rate $f_{MCK} = f_{CLK}^{Note 7}$ | | 5.3 | | 1.3 | | 0.6 | Mbps |
| | | | $1.8 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V},$ | | | fмск/6 | | fмск/6 | | fмск/6 | bps |
| | | | $1.6~V \leq V_b \leq 2.0~V^{\text{Note 5}}$ | Theoretical value of the maximum transfer rate $f_{MCK} = f_{CLK}^{Note 7}$ | | 5.3 Note 6 | | 1.3 | | 0.6 | Mbps |

- Notes 1. HS is condition of HS (high-speed main) mode.
 - 2. LS is condition of LS (low-speed main) mode.
 - 3. LV is condition of LV (low-voltage main) mode.
 - **4.** Transfer rate in the SNOOZE mode is 4800 bps.
 - 5. Use it with $EV_{DD0} \ge V_b$.
 - 6. The following conditions are required for low-voltage interface when EVDD0 < VDD.
 - $2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le 2.7 \text{ V}$: MAX. 2.6 Mbps
 - $1.8~\text{V} \leq \text{EV}_{\text{DD0}}$ < 2.4 V : MAX. 1.3 Mbps
 - 7. fclk in each operating mode is as below.
 - HS (high-speed main) mode: fclk = 32 MHz
 - LS (low-speed main) mode: fclk = 8 MHz
 - LV (low-voltage main) mode: fcLK = 4 MHz
- Caution Select the TTL input buffer for the RxDq pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.
- **Remarks 1.** $V_{b}[V]$: Communication line voltage
 - **2.** q: UART number (q = 0 to 2), g: PIM and POM number (g = 0, 1)
 - 3. fmck: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

n: Channel number (mn = 00 to 03, 10, 11)



Г

[bps]

(6) Communication at different potential (1.8 V, 2.5 V) (UART mode) (dedicated baud rate generator output) (2/2)

| (Ta | . = -40 to | +85°C, 1.8 V \leq EV _{DD0} \leq V _{DD} \leq 3.6 V, V _{SS} = EV _{SS0} = 0 V) | | |
|-----------|------------|---|----------------------|---|
| Parameter | Symbol | Conditions | HS ^{Note 1} | L |

| Parameter | Symbol | | Conditions | | | | LS ^{Note 2} | | LV ^{Note 3} | | Unit |
|-----------|--------|--------------|---|--|------|----------------|----------------------|----------------|----------------------|----------------|------|
| | | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| Transfer | | Transmission | $2.7~V \leq EV_{DD0} \leq 3.6~V,$ | | | Note 4 | | Note 4 | | Note 4 | bps |
| rate | | | $2.3 V \le V_b \le 2.7 V$ | Theoretical value of the maximum transfer rate C_b = 50 pF, R_b = 2.7 k Ω , V_b = 2.3 V | | 1.2 Note 5 | | 1.2 Note 5 | | 1.2 Note 5 | Mbps |
| | | | $1.8 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V},$ | | | Note 7 | | Note 7 | | Note 7 | bps |
| | | | $1.6 V \le V_b \le 2.0 V^{Note 6}$ | Theoretical value of the maximum transfer rate $C_b = 50 \text{ pF}, R_b = 5.5 \text{ k}\Omega, V_b = 1.6 \text{ V}$ | | 0.43 Note 8 | | 0.43 Note 8 | | 0.43 Note 8 | Mbps |

Notes 1. HS is condition of HS (high-speed main) mode.

- **2.** LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- **4.** The smaller maximum transfer rate derived by using f_{MCK}/6 or the following expression is the valid maximum transfer rate.

Expression for calculating the transfer rate when 2.7 V \leq EV _DD0 \leq 3.6 V and 2.3 V \leq V _b \leq 2.7 V

Maximum transfer rate =
$$\frac{1}{\{-C_b \times R_b \times ln (1 - \frac{2.0}{V_b})\} \times 3}$$
 [bps]

$$Baud rate error (theoretical value) = \frac{1}{\frac{1}{Transfer rate \times 2} - \{-C_b \times R_b \times \ln (1 - \frac{2.0}{V_b})\}}{(\frac{1}{(Transfer rate}) \times Number of transferred bits} \times 100 [\%]$$

- * This value is the theoretical value of the relative difference between the transmission and reception sides.
- 5. This value as an example is calculated when the conditions described in the "Conditions" column are met. See **Note 4** above to calculate the maximum transfer rate under conditions of the customer.
- 6. Use it with $EV_{DD0} \ge V_b$.
- **7.** The smaller maximum transfer rate derived by using fMCK/6 or the following expression is the valid maximum transfer rate.

Expression for calculating the transfer rate when 1.8 V \leq EV_{DD0} < 3.3 V and 1.6 V \leq V_b \leq 2.0 V

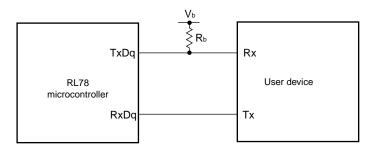
Maximum transfer rate =
$$\frac{1}{\{-C_b \times R_b \times \ln (1 - \frac{1.5}{V_b})\} \times 3}$$

Baud rate error (theoretical value) =
$$\frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{1.5}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 [\%]$$

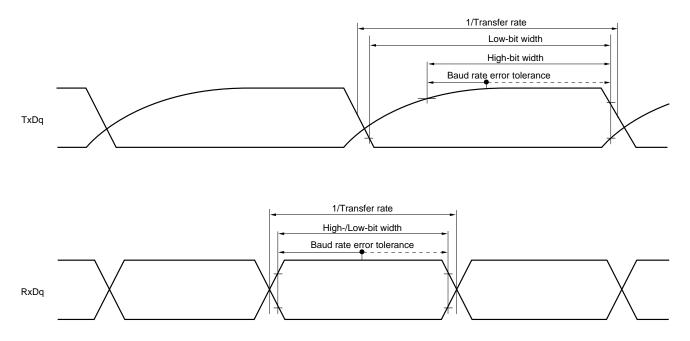
- * This value is the theoretical value of the relative difference between the transmission and reception sides.
- This value as an example is calculated when the conditions described in the "Conditions" column are met. See Note 7 above to calculate the maximum transfer rate under conditions of the customer.
- Caution Select the TTL input buffer for the RxDq pin and the N-ch open drain output (Vbb tolerance (When 25- to 48-pin products)/EVbb tolerance (When 64-pin products)) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For Vi and ViL, see the DC characteristics with TTL input buffer selected.

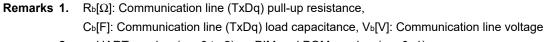


UART mode connection diagram (during communication at different potential)



UART mode bit width (during communication at different potential) (reference)





2. q: UART number (q = 0 to 2), g: PIM and POM number (g = 0, 1)

3. fMCK: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn).

m: Unit number, n: Channel number (mn = 00 to 03, 10, 11))



(7) Communication at different potential (2.5 V) (CSI mode) (master mode, SCKp... internal clock output, corresponding CSI00 only)

| Parameter | Symbol | Conditions | | HS [№] | ote 1 | LS [№] | ote 2 | LV ^{NC} | ote 3 | Unit |
|--|---------------|---|---------------------------|------------------|-------|------------------|-------|------------------|-------|------|
| | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SCKp cycle time | t ксү1 | $\label{eq:2.7} \begin{split} 2.7 \ V &\leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V &\leq V_b \leq 2.7 \ V, \\ C_b &= 20 \ pF, \ R_b = 2.7 \ k\Omega \end{split}$ | tксү1 ≥ 2/f с∟к | 300 | | 1150 | | 1150 | | ns |
| SCKp high-level width | t кн1 | $\begin{array}{l} 2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}, 2.3 \text{ V} \\ C_{\text{b}} = 20 \text{ pF}, \text{R}_{\text{b}} = 2.7 \text{ k}\Omega \end{array}$ | $V \le V_b \le 2.7 V$, | tксү1/2 – 120 | | tксү1/2 – 120 | | tксү1/2 – 120 | | ns |
| SCKp low-level width | tĸ∟1 | $\label{eq:constraint} \begin{array}{l} 2.7 \mbox{ V} \leq EV_{DD0} \leq 3.6 \mbox{ V}, 2.3 \mbox{ V} \\ C_b = 20 \mbox{ pF}, \mbox{ R}_b = 2.7 \mbox{ k}\Omega \end{array}$ | $V \le V_b \le 2.7 V$, | tксү1/2 – 10 | | tксү1/2 – 50 | | tксү1/2 – 50 | | ns |
| SIp setup time (to SCKp↑) ^{Note 4} | tsik1 | $\begin{array}{l} 2.7 \ V \leq E V_{DD0} \leq 3.6 \ V, \ 2.3 \ V \\ C_b = 20 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | $V \le V_b \le 2.7 V_s$ | 121 | | 479 | | 479 | | ns |
| SIp hold time (from SCKp↑) ^{Note 4} | tksi1 | $\begin{array}{l} 2.7 \ V \leq E V_{DD0} \leq 3.6 \ V, \ 2.3 \ V \\ C_b = 20 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | $V \le V_b \le 2.7 V_s$ | 10 | | 10 | | 10 | | ns |
| Delay time from SCKp↓ to SOp output ^{Note 4} | tkso1 | $\label{eq:constraint} \begin{array}{l} 2.7 \mbox{ V} \leq EV_{DD0} \leq 3.6 \mbox{ V}, 2.3 \mbox{ V} \\ C_b = 20 \mbox{ pF}, \mbox{ R}_b = 2.7 \mbox{ k}\Omega \end{array}$ | $V \le V_b \le 2.7 V$, | | 130 | | 130 | | 130 | ns |
| SIp setup time (to SCKp↓) ^{Note 5} | tsik1 | $\begin{array}{l} 2.7 \ V \leq E V_{DD0} \leq 3.6 \ V, \ 2.3 \ V \\ C_b = 20 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | $V \le V_b \le 2.7 V_s$ | 33 | | 110 | | 110 | | ns |
| SIp hold time (from SCKp↓) ^{Note 5} | tksi1 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \\ C_b = 20 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | $V \le V_b \le 2.7 V$, | 10 | | 10 | | 10 | | ns |
| Delay time from SCKp↑ to SOp output ^{Note 5} | tkso1 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \\ C_b = 20 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | $V \leq V_b \leq 2.7 V$, | | 10 | | 10 | | 10 | ns |

| (| $T_{A} = -40$ to +85°C 2 | $.7 V \leq EV_{DD0} \leq V_{DD} \leq 3.6$ | $V_{SS} = FV_{SS0} = 0 V$ |
|----|--------------------------|---|---------------------------|
| ۰. | 1A = -40 10 0000, 2 | | v, voo – Lvoou – U vj |

Notes 1. HS is condition of HS (high-speed main) mode.

- 2. LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- 4. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.
- 5. When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

- **Remarks 1.** R_b[Ω]: Communication line (SCKp, SOp) pull-up resistance, C_b[F]: Communication line (SCKp, SOp) load capacitance, V_b[V]: Communication line voltage
 - p: CSI number (p = 00), m: Unit number (m = 0), n: Channel number (n = 0), g: PIM and POM number (g = 1)

(8) Communication at different potential (1.8V, 2.5 V) (CSI mode) (master mode, SCKp... internal clock output) (1/2)

| | | | | | | SNote 2 VNote | | | | |
|-----------------------|--------|---|--|------------------|-------|------------------|-------|------------------|-------|------|
| Parameter | Symbol | Conditions | | HS ^N | ote 1 | LS™ | ote 2 | LVN | ote 3 | Unit |
| | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SCKp cycle time | tксүı | | | 500 | | 1150 | | 1150 | | ns |
| | | $ \begin{split} 1.8 \ V &\leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V &\leq V_b \leq 2.0 \ V^{\text{Note 4}}, \\ C_b &= 30 \ pF, \ R_b = 5.5 \ k\Omega \end{split} $ | | | | 1150 | | 1150 | | ns |
| SCKp high-level width | tкнı | $\label{eq:linear} \begin{array}{l} 2.7 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, 2.3 \mbox{ V} \leq \\ C_{\mbox{\tiny b}} = 30 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 2.7 \mbox{ k}\Omega \end{array}$ | $\leq V_{b} \leq 2.7 V$, | tксү1/2 – 170 | | tксү1/2 – 170 | | tксү1/2 – 170 | | ns |
| | | $\begin{array}{l} 1.8 \ V \leq EV_{\text{DD0}} < 3.3 \ V, \ 1.6 \ V \leq \\ ^{4}, \\ C_{\text{b}} = 30 \ \text{pF}, \ R_{\text{b}} = 5.5 \ \text{k}\Omega \end{array}$ | $\leq V_b \leq 2.0 \ V^{\text{Note}}$ | tксү1/2 – 458 | | tксү1/2 – 458 | | tксү1/2 – 458 | | ns |
| SCKp low-level width | tĸ∟1 | $\begin{array}{l} 2.7 \ V \leq EV_{\text{DD0}} \leq 3.6 \ \text{V}, \ 2.3 \ \text{V} \leq \text{V}_{\text{b}} \leq 2.7 \ \text{V}, \\ \text{C}_{\text{b}} = 30 \ \text{pF}, \ \text{R}_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$ | | tксү1/2 – 18 | | tксү1/2 – 50 | | tксү1/2 – 50 | | ns |
| | | $\begin{array}{l} 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \ 1.6 \ V \leq \\ ^{4}, \\ C_{b} = 30 \ pF, \ R_{b} = 5.5 \ k\Omega \end{array}$ | 1.8 V \leq EV _{DD0} < 3.3 V, 1.6 V \leq V _b \leq 2.0 V ^{Note} 4, | | | tксү1/2 – 50 | | tксү1/2 – 50 | | ns |

 $(T_A = -40 \text{ to } +85^{\circ}C, 1.8 \text{ V} \le EV_{DD0} \le V_{DD} \le 3.6 \text{ V}, \text{ Vss} = EV_{SS0} = 0 \text{ V})$

Notes 1. HS is condition of HS (high-speed main) mode.

- 2. LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- 4. Use it with $EV_{DD0} \ge V_b$.
- Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and V_{IL} , see the DC characteristics with TTL input buffer selected.
 - **Remarks 1.** R_b[Ω]: Communication line (SCKp, SOp) pull-up resistance, C_b[F]: Communication line (SCKp, SOp) load capacitance, Vb[V]: Communication line voltage
 - **2.** p: CSI number (p = 00, 10, 20), m: Unit number , n: Channel number (mn = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - 3. CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.



(8) Communication at different potential (1.8 V, 2.5 V) (CSI mode) (master mode, SCKp... internal clock output) (2/2)

| Parameter | Symbol | Conditions | HS | Note 1 | LS | Note 2 | LV ^{Note 3} | | Unit |
|---|--------|---|------|--------|------|--------|----------------------|------|------|
| | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SIp setup time (to SCKp↑) ^{Note 4} | tsik1 | $\begin{array}{l} 2.7 \; V \leq EV_{\text{DD0}} \leq 3.6 \; V, 2.3 \; V \leq V_{\text{b}} \leq 2.7 \; V, \\ C_{\text{b}} = 30 \; pF, \; R_{\text{b}} = 2.7 \; k\Omega \end{array}$ | 177 | | 479 | | 479 | | ns |
| | | $ \begin{array}{l} 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note}} \\ {}^{6}, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array} $ | 479 | | 479 | | 479 | | ns |
| SIp hold time (from SCKp↑) ^{Note 4} | tksii | $\begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ C_{b} = 30 \; pF, \; R_{b} = 2.7 \; k\Omega \end{array}$ | 19 | | 19 | | 19 | | ns |
| | | $ \begin{array}{l} 1.8 \ V \leq EV_{\text{DD0}} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note}} \\ {}^{\text{6}}, \\ C_b = 30 \ p\text{F}, \ R_b = 5.5 \ k\Omega \end{array} $ | 19 | | 19 | | 19 | | ns |
| Delay time from SCKp \downarrow to SOp output ^{Note 4} | tĸso1 | $\begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ C_{b} = 30 \; pF, \; R_{b} = 2.7 \; k\Omega \end{array}$ | | 195 | | 195 | | 195 | ns |
| | | | | 483 | | 483 | | 483 | ns |
| SIp setup time (to SCKp↓) ^{Note 5} | tsik1 | $\begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ C_{b} = 30 \; pF, \; R_{b} = 2.7 \; k\Omega \end{array}$ | 44 | | 110 | | 110 | | ns |
| | | $ \begin{array}{l} 1.8 \ V \leq EV_{\text{DD0}} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note}} \\ {}^{6}, \\ C_b = 30 \ p\text{F}, \ R_b = 5.5 \ k\Omega \end{array} $ | 110 | | 110 | | 110 | | ns |
| SIp hold time (from SCKp↓) ^{Note 5} | tksi1 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 19 | | 19 | | 19 | | ns |
| | | $ \begin{array}{l} 1.8 \ V \leq EV_{\text{DD0}} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note}} \\ {}^{6}, \\ C_b = 30 \ p\text{F}, \ R_b = 5.5 \ k\Omega \end{array} $ | 19 | | 19 | | 19 | | ns |
| Delay time from SCKp↑ to SOp output ^{Note 5} | tkso1 | $\begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ C_{b} = 30 \; pF, \; R_{b} = 2.7 \; k\Omega \end{array}$ | | 25 | | 25 | | 25 | ns |
| | | 1.8 V \leq EV _{DD0} < 3.3 V, 1.6 V \leq V _b \leq 2.0 V ^{Note} 6, C _b = 30 pF, R _b = 5.5 kΩ | | 25 | | 25 | | 25 | ns |

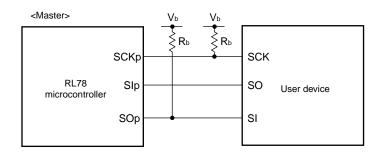
$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.8 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

Notes 1. HS is condition of HS (high-speed main) mode.

- **2.** LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- 4. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.
- 5. When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- 6. Use it with $EV_{DD0} \ge V_b$.
- Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (V_{DD} tolerance (When 25- to 48-pin products)/EV_{DD} tolerance (When 64-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V_{IH} and V_{IL}, see the DC characteristics with TTL input buffer selected.

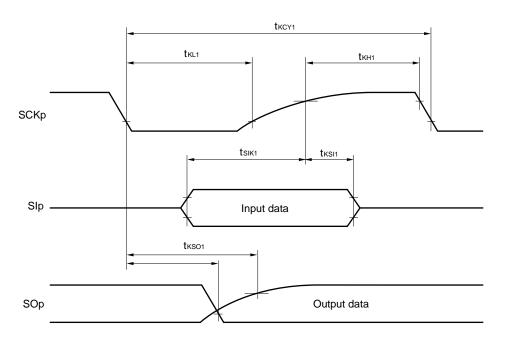
(Remarks are listed on the next page.)

CSI mode connection diagram (during communication at different potential)

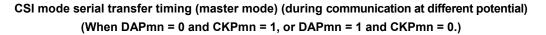


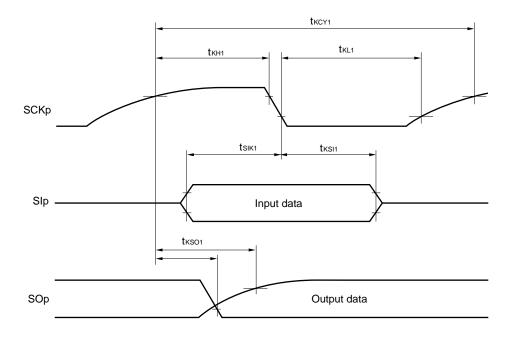
- **Remarks 1.** R_b[Ω]: Communication line (SCKp, SOp) pull-up resistance, C_b[F]: Communication line (SCKp, SOp) load capacitance, V_b[V]: Communication line voltage
 - p: CSI number (p = 00, 10, 20), m: Unit number , n: Channel number (mn = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - **3.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.





CSI mode serial transfer timing (master mode) (during communication at different potential) (When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)





- **Remarks 1.** p: CSI number (p = 00, 10, 20), m: Unit number, n: Channel number (m = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - **2.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

(9) Communication at different potential (1.8 V, 2.5 V) (CSI mode) (slave mode, SCKp... external clock input) ($T_A = -40$ to +85°C, 1.8 V $\leq EV_{DD0} \leq V_{DD} \leq 3.6$ V, Vss = EVss0 = 0 V)

| Parameter | Symbol | Conditions | | | Note 1 | LS | lote 2 | L۷ | lote 3 | Unit |
|---|------------------------------------|--|---|------------------|-----------------|-----------------|-----------------|-----------------|-----------------|------|
| | | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | l |
| SCKp cycle time ^{Note 4} | tксү2 | $2.7~V \leq EV_{DD0} \leq 3.6~V,$ | 24 MHz < fмск | 20/fмск | | - | | - | | ns |
| | | $2.3V{\leq}V_b{\leq}2.7V$ | 20 MHz < fмск≤24 MHz | 16/ f мск | | - | | - | | ns |
| | | | 16 MHz < fмск≤20 MHz | 14/ f мск | | _ | | - | | ns |
| | | | 8 MHz < fмск≤ 16 MHz | 12/fмск | | - | | - | | ns |
| | | | 4 MHz < fмck≤8 MHz | 8/f мск | | 16/fмск | | _ | | ns |
| | | | fмск≤4 MHz | 6/fмск | | 10/f мск | | 10/f мск | | ns |
| | | $1.8 V \le EV_{DD0} < 3.3 V$, | 24 MHz < fмск | 48/f мск | | _ | | _ | | ns |
| | $1.6 V \le V_b \le 2.0 V^{Note 5}$ | | 20 MHz < fмск≤24 MHz | 36/f мск | | _ | | _ | | ns |
| | | | 16 MHz < fмск≤20 MHz | 32/f мск | | - | | - | | ns |
| | | | 8 MHz < fмск≤ 16 MHz | 26/ f мск | | _ | | _ | | ns |
| | | | $4 \text{ MHz} < f_{\text{MCK}} \le 8 \text{ MHz}$ | 16/ f мск | | 16/fмск | | - | | ns |
| | | | fмck ≤ 4 MHz | 10/ f мск | | 10/fмск | | 10/fмск | | ns |
| SCKp high-/low-level width | tкн2, tкL2 | $2.7~V \leq EV_{DD0} \leq 3.6~V$ | , 2.3 V \le Vb \le 2.7 V | tксү2/2 – 18 | | tксү2/2 - 50 | | tксү2/2 - 50 | | ns |
| | | 1.8 V ≤ EV _{DD0} < 3.3 V ₅ | , $1.6 \text{ V} \le V_b \le 2.0 \text{ V}^{\text{Note}}$ | tксү2/2 - 50 | | tксү2/2 - 50 | | tксү2/2 - 50 | | ns |
| SIp setup time (to SCKp↑) ^{Note 6} | tsıĸ2 | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | , 2.3 V \le Vb \le 2.7 V | 1/fмск + 20 | | 1/fмск + 30 | | 1/fмск + 30 | | ns |
| | | 1.8 V ≤ EV _{DD0} < 3.3 V ₅ | , 1.6 V \le V_b \le 2.0 V^{Note} | 1/fмск + 30 | | 1/fмск + 30 | | 1/fмск + 30 | | ns |
| Slp hold time (from SCKp↑) ^{Note 6} | tksi2 | | 1 | | | 1/fмск + 31 | | 1/fмск + 31 | | ns |
| $ \begin{array}{ c c c c c } \hline Delay time from SCKp \downarrow & t_{KSO2} & 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \leq V_b < V_b \leq V_b < V_b \leq V_b < V_b \leq V_b < V_b $ | | | | 2/fмск + 214 | | 2/fмск + 573 | | 2/fмск + 573 | ns | |
| | | 1.8 V \leq EV _{DD0} < 3.3 V 5, C _b = 30 pF, R _b = 5.5 k | $V_{\rm b} \le V_{\rm b} \le 2.0 \ V^{\rm Note}$ | | 2/fмск + 573 | | 2/fмск + 573 | | 2/fмск + 573 | ns |

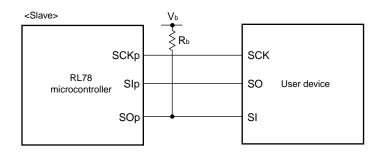
Notes 1. HS is condition of HS (high-speed main) mode.

- 2. LS is condition of LS (low-speed main) mode.
- **3.** LV is condition of LV (low-voltage main) mode.
- **4.** Transfer rate in the SNOOZE mode : MAX. 1 Mbps
- **5.** Use it with $EV_{DD0} \ge V_b$.
- 6. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- 7. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

Caution Select the TTL input buffer for the SIp pin and SCKp pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

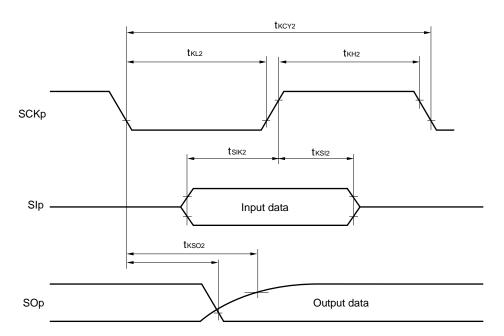
(Remarks are listed on the next page.)

CSI mode connection diagram (during communication at different potential)

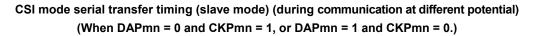


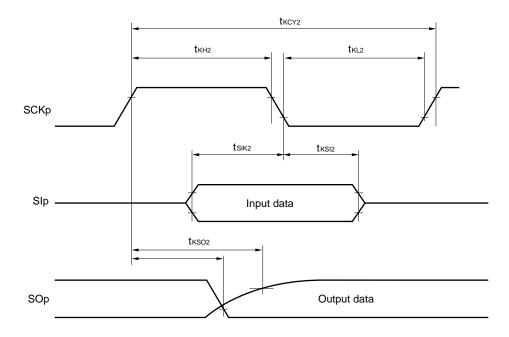
- **Remarks 1.** R_b[Ω]: Communication line (SOp) pull-up resistance, C_b[F]: Communication line (SOp) load capacitance, V_b[V]: Communication line voltage
 - p: CSI number (p = 00, 10, 20), m: Unit number (m = 0, 1), n: Channel number (n = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - fMCK: Serial array unit operation clock frequency
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn).
 m: Unit number, n: Channel number (mn = 00, 02, 10))
 - **4.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.





CSI mode serial transfer timing (slave mode) (during communication at different potential) (When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)





- **Remarks 1.** p: CSI number (p = 00, 10, 20), m: Unit number, n: Channel number (mn = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - **2.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

(10) Communication at different potential (1.8 V, 2.5 V) (simplified I²C mode) (1/2) (T_A = -40 to +85°C, 1.8 V \leq EV_{DD0} \leq V_{DD} \leq 3.6 V, Vss = EV_{SS0} = 0 V)

| Parameter | Symbol | Conditions | HS | Note 1 | LS | Note 2 | L۷ | Note 3 | Unit |
|---------------------------|--------|--|------|--------------------------|------|--------------------------|------|--------------------------|------|
| | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| SCLr clock frequency | fsc∟ | $\label{eq:2.7} \begin{split} 2.7 \ V &\leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V &\leq V_b \leq 2.7 \ V, \\ C_b &= 50 \ pF, \ R_b = 2.7 \ k\Omega \end{split}$ | | 1000 ^{Note 4} | | 300 ^{Note} 4 | | 300 ^{Note} 4 | kHz |
| | | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 100 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | | 400 ^{Note} 4 | | 300 ^{Note} 4 | | 300 ^{Note} 4 | kHz |
| | | $ \begin{split} & 1.8 \; V \leq EV_{DD0} < 3.3 \; V, \\ & 1.6 \; V \leq V_{b} \leq 2.0 \; V^{\text{Note 5}}, \\ & C_{b} = 100 \; pF, \; R_{b} = 5.5 \; k\Omega \end{split} $ | | 300 ^{Note} 4 | | 300 ^{Note} 4 | | 300 ^{Note} 4 | kHz |
| Hold time when SCLr = "L" | tlow | $\label{eq:2.7} \begin{split} & 2.7 \; V \leq E V_{DDO} \leq 3.6 \; V, \\ & 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ & C_{b} = 50 \; pF, \; R_{b} = 2.7 \; k\Omega \end{split}$ | 475 | | 1550 | | 1550 | | ns |
| | | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 100 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 1150 | | 1550 | | 1550 | | ns |
| | | $\begin{split} & 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \\ & 1.6 \ V \leq V_{b} \leq 2.0 \ V^{Note \ 5}, \\ & C_{b} = 100 \ pF, \ R_{b} = 5.5 \ k\Omega \end{split}$ | 1550 | | 1550 | | 1550 | | ns |
| Hold time when SCLr = "H" | tніgн | $\label{eq:2.7} \begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 50 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 200 | | 610 | | 610 | | ns |
| | | $\label{eq:2.7} \begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 100 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$ | 600 | | 610 | | 610 | | ns |
| | | $ \begin{split} & 1.8 \; V \leq EV_{DD0} < 3.3 \; V, \\ & 1.6 \; V \leq V_{b} \leq 2.0 \; V^{\text{Note 5}}, \\ & C_{b} = 100 \; pF, \; R_{b} = 5.5 \; k\Omega \end{split} $ | 610 | | 610 | | 610 | | ns |

(Notes, Caution and Remarks are listed on the next page.)



| Parameter | Symbol | Conditions | HS | Note 1 | LS [№] | lote 2 | LVN | lote 3 | Unit |
|-------------------------------|---------|---|--|--------|---|--------|--|--------|------|
| | | | MIN. | MAX. | MIN. | MAX. | MIN. | MAX. | |
| Data setup time (reception) | tsu:dat | $\begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 50 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$ | 1/f _{мск} + 135 ^{Note} 6 | | 1/f _{МСК} + 190 ^{Note 6} | | 1/f _{мск} + 190 ^{Note} 6 | | ns |
| | | $\label{eq:2.7} \begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 100 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$ | 1/f _{MCK} + 190 ^{Note} 6 | | 1/f _{МСК} + 190 ^{Note 6} | | 1/f _{мск} + 190 ^{Note} 6 | | ns |
| | | $ \begin{split} 1.8 \ V &\leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V &\leq V_{b} \leq 2.0 \ V^{Note 5}, \\ C_{b} &= 100 \ pF, \ R_{b} = 5.5 \ k\Omega \end{split} $ | 1/f _{МСК} + 190 ^{Note} 6 | | 1/f _{МСК} + 190 ^{Note 6} | | 1/f _{MCK} + 190 ^{Note} 6 | | ns |
| Data hold time (transmission) | thd:dat | $\label{eq:2.7} \begin{split} 2.7 \ V &\leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V &\leq V_b \leq 2.7 \ V, \\ C_b &= 50 \ pF, \ R_b = 2.7 \ k\Omega \end{split}$ | 0 | 305 | 0 | 305 | 0 | 305 | ns |
| | | $\begin{array}{l} 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 100 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$ | 0 | 355 | 0 | 355 | 0 | 355 | ns |
| | | $ \begin{split} 1.8 \ V &\leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V &\leq V_{b} \leq 2.0 \ V^{Note 5}, \\ C_{b} &= 100 \ pF, \ R_{b} = 5.5 \ k\Omega \end{split} $ | 0 | 405 | 0 | 405 | 0 | 405 | ns |

(10) Communication at different potential (1.8 V, 2.5 V) (simplified I²C mode) (2/2) (T_A = -40 to +85°C. 1.8 V \leq EV_{DD0} \leq V_{DD} \leq 3.6 V. V_{SS} = EV_{SS0} = 0 V)

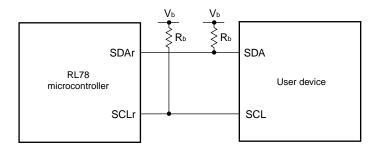
Notes 1. HS is condition of HS (high-speed main) mode.

- 2. LS is condition of LS (low-speed main) mode.
- 3. LV is condition of LV (low-voltage main) mode.
- 4. The value must also be $f_{CLK}/4$ or lower.
- **5.** Use it with $EV_{DD0} \ge V_b$.
- 6. Set the fmck value to keep the hold time of SCLr = "L" and SCLr = "H".
- Caution Select the TTL input buffer and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SDAr pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

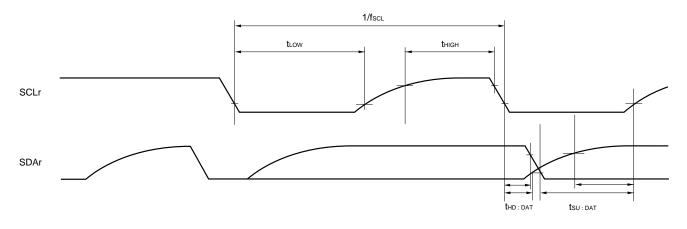
(**Remarks** are listed on the next page.)



Simplified I²C mode connection diagram (during communication at different potential)



Simplified I²C mode serial transfer timing (during communication at different potential)



- **Remarks 1.** R_b[Ω]: Communication line (SDAr, SCLr) pull-up resistance, C_b[F]: Communication line (SDAr, SCLr) load capacitance, V_b[V]: Communication line voltage
 - **2.** r: IIC number (r = 00, 10, 20), g: PIM, POM number (g = 0, 1)
 - fmck: Serial array unit operation clock frequency
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00, 02, 10)
 - **4.** IIC01, IIC11, and IIC21 cannot communicate at different potential. Use IIC00, IIC10, or IIC20 for communication at different potential.



2.5.2 Serial interface IICA

(1) I²C standard mode

(TA = -40 to +85°C, 1.6 V \leq EV_{DD0} \leq V_{DD} \leq 3.6 V, V_{SS} = EV_{SS0} = 0 V)

| Parameter | Symbol | Conditions | | St | andard | Mode ^{No} | ote 1 | | Unit |
|---|--------------|--|------|--------|--------|--------------------|-------|--------|------|
| | | | HS | Note 2 | LS | lote 3 | L۷ | lote 4 | |
| | | | MIN. | MAX. | MIN. | MIN. | MAX. | MIN. | |
| SCLA0 clock frequency | fscL | $2.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 0 | 100 | 0 | 100 | 0 | 100 | kHz |
| | | $1.8 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 0 | 100 | 0 | 100 | 0 | 100 | |
| | | $1.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 0 | 100 | 0 | 100 | 0 | 100 | |
| | | $1.6 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | - | | 0 | 100 | 0 | 100 | |
| Setup time of restart condition | tsu:sta | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | μs |
| | | $1.8 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | |
| | | $1.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | |
| | | $1.6 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | - | | 4.7 | | 4.7 | | |
| Hold time ^{Note 5} the structure | | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 4.0 | | 4.0 | | 4.0 | | μs |
| | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.0 | | 4.0 | | 4.0 | | |
| Hold time when SCLA0 = "L" tLOW | | $1.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 4.0 | | 4.0 | | 4.0 | | |
| | | $1.6 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | - | | 4.0 | | 4.0 | | |
| | | $2.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | μs |
| | | $1.8 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | |
| | | $1.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | |
| | | $1.6 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | - | | 4.7 | | 4.7 | | |
| Hold time when SCLA0 = "H" | tніgн | $2.7 \text{ V} \leq EV_{DD0} \leq 3.6 \text{ V}$ | 4.0 | | 4.0 | | 4.0 | | μs |
| | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.0 | | 4.0 | | 4.0 | | |
| | | $1.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 4.0 | | 4.0 | | 4.0 | | |
| | | $1.6 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | - | | 4.0 | | 4.0 | | |
| Data setup time (reception) | tsu:dat | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 250 | | 250 | | 250 | | ns |
| | | $1.8 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 250 | | 250 | | 250 | | |
| | | $1.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 250 | | 250 | | 250 | | |
| | | $1.6 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | - | | 250 | | 250 | | |
| Data hold time (transmission)Note 6 | thd:dat | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 0 | 3.45 | 0 | 3.45 | 0 | 3.45 | μs |
| | | $1.8 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 0 | 3.45 | 0 | 3.45 | 0 | 3.45 | |
| | | $1.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | 0 | 3.45 | 0 | 3.45 | 0 | 3.45 | |
| | | $1.6~V \leq EV_{DD0} \leq 3.6~V$ | - | - | 0 | 3.45 | 0 | 3.45 | |
| Setup time of stop condition | tsu:sto | $2.7~V \leq EV_{DD0} \leq 3.6~V$ | 4.0 | | 4.0 | | 4.0 | | μs |
| | | $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.0 | | 4.0 | | 4.0 | | |
| | | $1.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 4.0 | | 4.0 | | 4.0 | | |
| | | $1.6~V \leq EV_{\text{DD0}} \leq 3.6~V$ | _ | | 4.0 | | 4.0 | | |
| Bus-free time | t BUF | $2.7~V \leq EV_{DD0} \leq 3.6~V$ | 4.7 | | 4.7 | | 4.7 | | μs |
| | | $1.8 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | |
| | | $1.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | 4.7 | | 4.7 | | 4.7 | | |
| | | $1.6 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | _ | | 4.7 | | 4.7 | | |

(Note and Remark are listed on the next page.)

| Parameter | Symbol | Conditions | | | Fast M | ode ^{Note 7} | | | Fast Mode Plus ^{Note 8} | | Unit |
|----------------------------------|---------------|---|------|----------------------|--------|-----------------------|------|----------------------|-------------------------------------|----------------------|------|
| | | | HS | HS ^{Note 2} | | lote 3 | LV | LV ^{Note 4} | | HS ^{Note 2} | |
| | | | MIN. | MAX. | MIN. | MIN. | MAX. | MIN. | MAX. | MIN. | |
| SCLA0 clock frequency | fscL | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0 | 400 | 0 | 400 | 0 | 400 | 0 | 1000 | kHz |
| | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0 | 400 | 0 | 400 | 0 | 400 | - | | |
| Setup time of restart | tsu:sta | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | 0.26 | | μs |
| condition | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | - | | |
| Hold time ^{Note 5} | thd:sta | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | 0.26 | | μs |
| | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | - | | |
| Hold time when SCLA0 | t∟ow | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 1.3 | | 1.3 | | 1.3 | | 0.5 | | μs |
| = "L" | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 1.3 | | 1.3 | | 1.3 | | - | | |
| Hold time when SCLA0 | t high | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | 0.26 | | μs |
| = "H" | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | - | | |
| Data setup time | tsu:dat | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 100 | | 100 | | 100 | | 50 | | ns |
| (reception) | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 100 | | 100 | | 100 | | - | | |
| Data hold time | thd:dat | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0 | 0.9 | 0 | 0.9 | 0 | 0.9 | 0 | 450 | μs |
| (transmission) ^{Note 6} | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0 | 0.9 | 0 | 0.9 | 0 | 0.9 | - | | |
| Setup time of stop | tsu:sto | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | 0.26 | | μs |
| condition | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0.6 | | 0.6 | | 0.6 | | - | | |
| Bus-free time | t BUF | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 1.3 | | 1.3 | | 1.3 | | 0.5 | | μs |
| | | $1.8~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 1.3 | | 1.3 | | 1.3 | | - | | |

(2) I²C fast mode, fast mode plus (T_A = -40 to +85°C, 1.6 V \leq EV_{DD0} \leq V_{DD} \leq 3.6 V, V_{SS} = EV_{SS0} = 0 V)

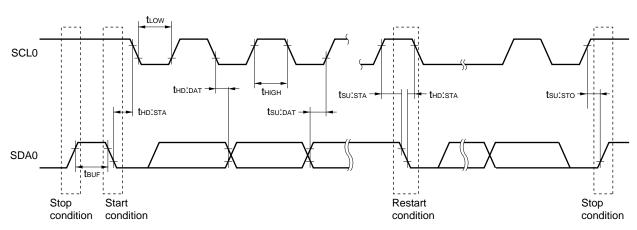
Notes 1. In normal mode, use it with fcLK \geq 1 MHz, 1.6 V \leq EVDD \leq 3.6 V.

- 2. HS is condition of HS (high-speed main) mode.
- **3.** LS is condition of LS (low-speed main) mode.
- 4. LV is condition of LV (low-voltage main) mode.
- 5. The first clock pulse is generated after this period when the start/restart condition is detected.
- 6. The maximum value (MAX.) of the:DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.
- 7. In fast mode, use it with fcLK \ge 3.5 MHz, 1.8 V \le EVDD \le 3.6 V.
- 8. In fast mode plus, use it with fcLK \ge 10 MHz, 2.7 V \le EVDD \le 3.6 V.

Remark The maximum value of C_b (communication line capacitance) and the value of R_b (communication line pull-up resistor) at that time in each mode are as follows.

 $Standard mode: \quad C_b = 400 \text{ pF}, \text{ } \text{R}_b = 2.7 \text{ } \text{k}\Omega \\ Fast mode: \qquad C_b = 320 \text{ pF}, \text{ } \text{R}_b = 1.1 \text{ } \text{k}\Omega \\ Fast mode plus: \qquad C_b = 120 \text{ pF}, \text{ } \text{R}_b = 1.1 \text{ } \text{k}\Omega \\$





IICA serial transfer timing



2.6 Analog Characteristics

2.6.1 A/D converter characteristics

Division of A/D Converter Characteristics

| Reference voltag | Reference voltage (+) = AV _{REFP} Reference voltage (-) = AV _{REFM} | Reference voltage (+) = AV _{DD} Reference voltage (-) = AV _{SS} | Reference voltage (+) = Internal refrence voltage Reference voltage (-) = AVss |
|---|--|--|--|
| High-accuracy channel; ANI0 to ANI12 (input buffer power supply: AV _{DD}) | See 2.6.1 (1) See 2.6.1 (2) | See 2.6.1 (3) | See 2.6.1 (6) |
| Standard channel; ANI16 to ANI30 (input buffer power supply: Vbb or EVbbo) | See 2.6.1 (4) | See 2.6.1 (5) | |
| Temperature sensor, internal reference voltage output | See 2.6.1 (4) | See 2.6.1 (5) | _ |

<R> (1) When reference voltage (+) = AV_{REFP}/ANIO (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) = AV_{REFM}/ANI1 (ADREFM = 1), target for conversion: ANI2 to ANI12

<R> $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.4 \text{ V} \le \text{AV}_{REFP} \le \text{AV}_{DD} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = 0 \text{ V}, \text{AV}_{SS} = 0 \text{ V}, \text{Reference voltage (+)} = \text{AV}_{REFP}, \text{Reference voltage (-)} = \text{AV}_{REFM} = 0 \text{ V}, \text{HALT mode})$

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---|--------|------------------------------|-------|------|--------|------|
| Resolution | Res | | | | 12 | bit |
| Overall error ^{Notes 1, 2, 3} | AINL | 12-bit resolution | | ±1.7 | ±3.3 | LSB |
| Conversion time | tconv | ADTYP = 0, 12-bit resolution | 3.375 | | | μs |
| Zero-scale error ^{Notes 1, 2, 3} | Ezs | 12-bit resolution | | ±1.3 | ±3.2 | LSB |
| Full-scale error ^{Notes 1, 2, 3} | Efs | 12-bit resolution | | ±0.7 | ±2.9 | LSB |
| Integral linearity errorNotes 1, 2, 3 | ILE | 12-bit resolution | | ±1.0 | ±1.4 | LSB |
| Differential linearity error ^{Notes 1, 2, 3} | DLE | 12-bit resolution | | ±0.9 | ±1.2 | LSB |
| Analog input voltage | VAIN | | 0 | | AVREFP | V |

- **Notes 1.** TYP. Value is the average value at $AV_{DD} = AV_{REFP} = 3 V$ and $T_A = 25^{\circ}C$. MAX. value is the average value $\pm 3\sigma$ at normalized distribution.
 - 2. These values are the results of characteristic evaluation and are not checked for shipment.
 - **3.** Excludes quantization error ($\pm 1/2$ LSB).
- Cautions 1. Route the wiring so that noise will not be superimposed on each power line and ground line, and insert a capacitor to suppress noise. In addition, separate the reference voltage line of AV_{REFP} from the other power lines to keep it free from the influences of noise.
 - 2. During A/D conversion, keep a pulse, such as a digital signal, that abruptly changes its level from being input to or output from the pins adjacent to the converter pins and P20 to P27 and P150 to P154.

<R>

(2) When reference voltage (+) = AV_{REFP}/ANI0 (ADREFP1 = 0, ADREFP0 = 1), reference voltage (–) = AV_{REFM}/ANI1 (ADREFM = 1), target for conversion: ANI2 to ANI12

| $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{AV}_{REFP} \le \text{AV}_{DD} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = 0 \text{ V}, \text{AV}_{SS} = 0 \text{ V}, \text{Reference voltage (+)} = \text{AV}_{REFP}, \text{AV}_{SS} = 0 \text{ V}, \text{AV}_{SS} = 0 $ |
|--|
| Reference voltage (–) = AV _{REFM} = 0 V) |

| Parameter | Symbol | | Conditions | MIN. | TYP. | MAX. | Unit |
|--|--------|---|--|---------------------|------|----------------------|------|
| Resolution | Res | | $2.4~\text{V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | 8 | | 12 | bit |
| | | | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 8 | | 10 ^{Note 1} | |
| | | $1.6 \text{ V} \le \text{AV}_{\text{REFP}} \le \text{AV}_{\text{DD}} \le 3.6 \text{ V}$ | | 8 ^{Note 2} | | | |
| Overall errorNote 3 | AINL | 12-bit resolution | $2.4~\text{V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | | | ±6.0 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±5.0 | |
| | | 8-bit resolution | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±2.5 | |
| Conversion time | tconv | ADTYP = 0, 12-bit resolution | $2.4 \text{ V} \leq \text{AV}_{\text{REFP}} \leq \text{AV}_{\text{DD}} \leq 3.6 \text{ V}$ | 3.375 | | | μs |
| | | ADTYP = 0, 10-bit resolution ^{Note 1} | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 6.75 | | | |
| | | ADTYP = 0, 8-bit resolution ^{Note 2} | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 13.5 | | | |
| | | 0 hit na a lution | $2.4~\text{V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | 2.5625 | | | |
| | | | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 5.125 | | | |
| | | | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 10.25 | | | |
| Zero-scale errorNote 3 | Ezs | 12-bit resolution | $2.4~\text{V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | | | ±4.5 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±4.5 | |
| | | 8-bit resolution | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±2.0 | |
| Full-scale error ^{Note 3} | Efs | 12-bit resolution | $2.4~\text{V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | | | ±4.5 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±4.5 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | |
| Integral linearity error ^{Note 3} | ILE | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±1.5 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±1.0 | |
| Differential linearity error ^{Note 3} | DLE | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±1.5 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±1.5 | |
| | | 8-bit resolution | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±1.0 | |
| Analog input voltage | VAIN | | | 0 | | AVREFP | V |

Notes 1. Cannot be used for lower 2 bit of ADCR register

- 2. Cannot be used for lower 4 bit of ADCR register
- **3.** Excludes quantization error ($\pm 1/2$ LSB).

<R>

(3) When reference voltage (+) = AV_{DD} (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = AV_{SS} (ADREFM = 0), target for conversion: ANI0 to ANI12

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{ V}_{\text{SS}} = 0 \text{ V}, \text{ AV}_{\text{SS}} = 0 \text{ V}, \text{ Reference voltage (+) = AV}_{\text{DD}}, \text{ Reference voltage (+) =$

| Parameter | Symbol | Co | onditions | MIN. | TYP. | MAX. | U |
|--|-------------------|---|--|--------|---------------------|----------------------|---|
| Resolution | Res | | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 8 | | 12 | k |
| | | | $1.8 \text{ V} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 8 | | 10 ^{Note 1} | |
| | | | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | 8 ^{Note 2} | | |
| Overall errorNote 3 | AINL | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±7.5 | L |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±5.5 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.0 | |
| Conversion time | t _{CONV} | ADTYP = 0, 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 3.375 | | | ļ |
| | | ADTYP = 0, 10-bit resolution ^{Note 1} | $1.8 \text{ V} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 6.75 | | | |
| | | ADTYP = 0, 8-bit resolution ^{Note 2} | $1.6 \text{ V} \leq AV_{DD} \leq 3.6 \text{ V}$ | 13.5 | | | |
| | | ADTYP = 1, | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 2.5625 | | | |
| | | 8-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | 5.125 | | | |
| | | | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | 10.25 | | | |
| Zero-scale error ^{Note 3} | Ezs | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±6.0 | L |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±5.0 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.5 | |
| Full-scale error ^{Note 3} | Ers | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±6.0 | L |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±5.0 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.5 | |
| Integral linearity errorNote 3 | ILE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.0 | L |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±1.5 | |
| Differential linearity error ^{Note 3} | DLE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | L |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±1.5 | |
| Analog input voltage | VAIN | | | 0 | | AVDD | |

Notes 1. Cannot be used for lower 2 bit of ADCR register

- 2. Cannot be used for lower 4 bit of ADCR register
- **3.** Excludes quantization error ($\pm 1/2$ LSB).

- <R>
- (4) When reference voltage (+) = AVREFP/ANIO (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) = AVREFM/ANI1 (ADREFM = 1), target for conversion: ANI16 to ANI30, interanal reference voltage, temperature sensor output voltage

 $(T_{A} = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, 1.6 \text{ V} \le \text{AV}_{\text{REFP}} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V}, \text{AV}_{\text{SS}} = 0 \text{ AV}_{\text{SS}} = 0 \text{ AV}_$

| Parameter | Symbol | | Conditions | MIN. | TYP. | MAX. | Unit |
|--|--------|--|--|-------------------------|-------------------------|----------------------|------|
| Resolution | Res | | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | 8 | | 12 | bit |
| | | | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 8 | | 10 ^{Note 1} | |
| | | | $1.6~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | 8 ^{Note 2} | | |
| Overall error ^{Note 3} | AINL | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±7.0 | LSB |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±5.5 | |
| | | 8-bit resolution | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±3.0 | |
| Conversion time | tсолу | ADTYP = 0, 12-bit resolution | $2.4 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 4.125 | | | μs |
| | | ADTYP = 0, 10-bit resolution ^{Note 1} | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 9.5 | | | |
| | | ADTYP = 0, 8-bit resolution ^{Note 2} | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 57.5 | | | |
| | | ADTYP = 1, | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | 3.3125 | | | |
| | | 8-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | 7.875 | | | |
| | | | $1.6 \text{ V} \leq \text{AV}_{\text{REFP}} \leq \text{AV}_{\text{DD}} \leq 3.6 \text{ V}$ | 54.25 | | | |
| Zero-scale error ^{Note 3} | Ezs | 12-bit resolution | $2.4~\text{V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | | | ±5.0 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±5.0 | |
| | | 8-bit resolution | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±2.5 | |
| Full-scale error ^{Note 3} | Ers | 12-bit resolution | $2.4 \text{ V} \leq \text{AV}_{\text{REFP}} \leq \text{AV}_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±5.0 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq \text{AV}_{\text{REFP}} \leq \text{AV}_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±5.0 | |
| | | 8-bit resolution | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±2.5 | |
| Integral linearity error ^{Note 3} | ILE | 12-bit resolution | $2.4~\text{V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | | | ±3.0 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±2.0 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±1.5 | |
| Differential linearity error ^{Note 3} | DLE | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | LSB |
| | | 10-bit resolution | $1.8 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±2.0 | |
| | | 8-bit resolution | $1.6 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±1.5 | |
| Analog input voltage | Vain | | | 0 | | AVREFP and EVDD0 | V |
| | | Interanal reference v $(2.4 \text{ V} \le \text{V}_{\text{DD}} \le 3.6 \text{ V},$ | oltage HS (high-speed main) mode) | V _{BGR} Note 4 | | | V |
| | | Temperature sensor (2.4 V \leq V _{DD} \leq 3.6 V, | output voltage HS (high-speed main) mode) | , | VTMPS25 ^{Note} | 4 | V |

- Notes 1. Cannot be used for lower 2 bit of ADCR register
 - 2. Cannot be used for lower 4 bit of ADCR register
 - **3.** Excludes quantization error ($\pm 1/2$ LSB).
 - 4. See 2.6.2 Temperature sensor, internal reference voltage output characteristics.

- <R>
- (5) When reference voltage (+) = AV_{DD} (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = AV_{SS} (ADREFM = 0), target for conversion: ANI16 to ANI30, interanal reference voltage, temperature sensor output voltage

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD0}} \le 3.6 \text{ V}, 1.6 \text{ V} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V}, \text{AV}_{\text{SS}} = 0 \text{ V}, \text{Reference voltage (+) = AV}_{\text{DD}}, \text{Reference voltage (-) = AV}_{\text{SS}} = 0 \text{ V})$

| Parameter | Symbol | Co | onditions | MIN. | TYP. | MAX. | Unit |
|--|--------|--|--|-------------------------|-------------------------|---|------|
| Resolution | Res | | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 8 | | 12 | bit |
| | | | $1.8 V \le AV_{DD} \le 3.6 V$ | 8 | | 10 ^{Note 1} | |
| | | | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | 8 ^{Note 2} | | |
| Overall error ^{Note 3} | AINL | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±8.5 | LSB |
| | | 10-bit resolution | $1.8~V \le AV_{\text{DD}} \le 3.6~V$ | | | ±6.0 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.5 | |
| Conversion time | tconv | ADTYP = 0, 12-bit resolution | $2.4~V \le AV_{\text{DD}} \le 3.6~V$ | 4.125 | | | μs |
| | | ADTYP = 0, 10-bit resolution ^{Note 1} | $1.8~V \le AV_{DD} \le 3.6~V$ | 9.5 | | | |
| | | ADTYP = 0, 8-bit resolution ^{Note 2} | $1.6~V \le AV_{\text{DD}} \le 3.6~V$ | 57.5 | | | |
| | | ADTYP = 1, | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 3.3125 | | | μs |
| | | 8-bit resolution | $1.8~V \le AV_{\text{DD}} \le 3.6~V$ | 7.875 | | | |
| | | | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | 54.25 | | | |
| Zero-scale error ^{Note 3} | Ezs | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±8.0 | LSB |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±5.5 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.0 | |
| Full-scale error ^{Note 3} | EFS | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±8.0 | LSB |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±5.5 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.0 | |
| Integral linearity error ^{Note 3} | ILE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.5 | LSB |
| | | 10-bit resolution | $1.8~V \le AV_{\text{DD}} \le 3.6~V$ | | | ±2.5 | |
| | | 8-bit resolution | $1.6~V \le AV_{\text{DD}} \le 3.6~V$ | | | ±1.5 | |
| Differential linearity errorNote 3 | DLE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.5 | LSB |
| | | 10-bit resolution | $1.8~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.5 | |
| | | 8-bit resolution | $1.6~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | |
| Analog input voltage | VAIN | | | 0 | | AV _{DD} and EV _{DD0} | V |
| | | Interanal reference volt (2.4 V \leq V _{DD} \leq 3.6 V, H | tage S (high-speed main) mode) | V _{BGR} Note 4 | | | V |
| | | Temperature sensor of (2.4 V \leq V _{DD} \leq 3.6 V, H | utput voltage S (high-speed main) mode) | , | VTMPS25 ^{Note} | 4 | V |

Notes 1. Cannot be used for lower 2 bit of ADCR register

- 2. Cannot be used for lower 4 bit of ADCR register
- **3.** Excludes quantization error ($\pm 1/2$ LSB).
- 4. See 2.6.2 Temperature sensor, internal reference voltage output characteristics.

<R>

(6) When reference voltage (+) = Internal reference voltage (1.45 V) (ADREFP1 = 1, ADREFP0 = 0), reference voltage (-) = AVss (ADREFM = 0), target ANI pin: ANI0 to ANI12, ANI16 to ANI30

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 2.4 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}, 1.6 \text{ V} \le \text{EV}_{DD} \le \text{V}_{DD}, 1.6 \text{ V} \le \text{AV}_{DD} \le \text{V}_{DD}, \text{V}_{SS} = \text{EV}_{SS0} = 0 \text{ V}, \text{AV}_{SS} = 0 \text{ V}, \text{Reference voltage (+) = Internal reference voltage, Reference voltage (-) = AV}_{SS} = 0 \text{ V}, \text{HS (high-speed main) mode)}$

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|--|----------------------|--|------|------|------|------|
| Resolution | Res | | 8 | | | bit |
| Conversion time | t _{CONV} | 8-bit resolution | 16 | | | μs |
| Zero-scale error ^{Note} | Ezs | 8-bit resolution | | | ±4.0 | LSB |
| Integral linearity error ^{Note} | ILE | 8-bit resolution | | | ±2.0 | LSB |
| Differential linearity error ^{Note} | DLE | 8-bit resolution | | | ±2.5 | LSB |
| Reference voltage (+) | AV _{REF(+)} | = Internal reference voltage (V _{BGR}) | 1.38 | 1.45 | 1.5 | V |
| Analog input voltage | VAIN | | 0 | | VBGR | V |

Note Excludes quantization error ($\pm 1/2$ LSB).

2.6.2 Temperature sensor, internal reference voltage output characteristics

| • | | ; (| | | | |
|-----------------------------------|---------|---|------|------|------|-------|
| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
| Temperature sensor output voltage | VTMPS25 | Setting ADS register = 80H, T _A = +25°C | | 1.05 | | V |
| Internal reference voltage | VBGR | Setting ADS register = 81H | 1.38 | 1.45 | 1.5 | V |
| Temperature coefficient | Fvtmps | Temperature sensor output voltage that depends on the temperature | | -3.6 | | mV/°C |
| Operation stabilization wait time | tamp | | 10 | | | μs |

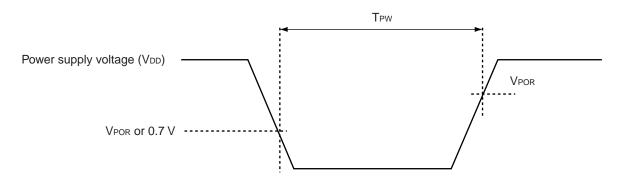
(T_A = -40 to +85°C, 2.4 V \leq V_{DD} \leq 3.6 V, V_{SS} = 0 V, HS (high-speed main) mode)

2.6.3 POR circuit characteristics

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, \text{Vss} = 0 \text{ V})$

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|-------------------------------------|--------|------------------------|------|------|------|------|
| Detection voltage | VPOR | Power supply rise time | 1.47 | 1.51 | 1.55 | V |
| | VPDR | Power supply fall time | 1.46 | 1.50 | 1.54 | V |
| Minimum pulse width ^{Note} | TPW | | 300 | | | μs |

Note This is the time required for the POR circuit to execute a reset when V_{DD} falls below V_{PDR}. When the microcontroller enters STOP mode or if the main system clock (f_{MAIN}) has been stopped by setting bit 0 (HIOSTOP) and bit 7 (MSTOP) of the clock operation status control register (CSC), this is the time required for the POR circuit to execute a reset before V_{DD} rises to V_{POR} after having fallen below 0.7 V.





2.6.4 LVD circuit characteristics

LVD Detection Voltage of Reset Mode and Interrupt Mode

| (T _A = -40 to +85°C | , VPDR \leq VDD \leq 3.6 | V, Vss = 0 V) |
|--------------------------------|------------------------------|---------------|
|--------------------------------|------------------------------|---------------|

| | Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|--------------|----------------------|------------------------|------------------------|------|------|------|------|
| Detection | Supply voltage level | VLVD2 | Power supply rise time | 3.07 | 3.13 | 3.19 | V |
| voltage | | | Power supply fall time | 3.00 | 3.06 | 3.12 | V |
| | | VLVD3 | Power supply rise time | 2.96 | 3.02 | 3.08 | V |
| | | | Power supply fall time | 2.90 | 2.96 | 3.02 | V |
| | | VLVD4 | Power supply rise time | 2.86 | 2.92 | 2.97 | V |
| | | | Power supply fall time | 2.80 | 2.86 | 2.91 | V |
| | | VLVD5 | Power supply rise time | 2.76 | 2.81 | 2.87 | V |
| | | | Power supply fall time | 2.70 | 2.75 | 2.81 | V |
| | | VLVD6 | Power supply rise time | 2.66 | 2.71 | 2.76 | V |
| | | | Power supply fall time | 2.60 | 2.65 | 2.70 | V |
| | | VLVD7 | Power supply rise time | 2.56 | 2.61 | 2.66 | V |
| | | Power supply fall time | 2.50 | 2.55 | 2.60 | V | |
| | | VLVD8 | Power supply rise time | 2.45 | 2.50 | 2.55 | V |
| | | | Power supply fall time | 2.40 | 2.45 | 2.50 | V |
| | | VLVD9 | Power supply rise time | 2.05 | 2.09 | 2.13 | V |
| | | | Power supply fall time | 2.00 | 2.04 | 2.08 | V |
| | | VLVD10 | Power supply rise time | 1.94 | 1.98 | 2.02 | V |
| | | | Power supply fall time | 1.90 | 1.94 | 1.98 | V |
| | | VLVD11 | Power supply rise time | 1.84 | 1.88 | 1.91 | V |
| | | | Power supply fall time | 1.80 | 1.84 | 1.87 | V |
| | | VLVD12 | Power supply rise time | 1.74 | 1.77 | 1.81 | V |
| | | | Power supply fall time | 1.70 | 1.73 | 1.77 | V |
| | | VLVD13 | Power supply rise time | 1.64 | 1.67 | 1.70 | V |
| | | | Power supply fall time | 1.60 | 1.63 | 1.66 | V |
| Minimum pu | lse width | t∟w | | 300 | | | μs |
| Detection de | elay time | | | | | 300 | μs |

Caution Set the detection voltage (VLVD) to be within the operating voltage range. The operating voltage range depends on the setting of the user option byte (000C2H/010C2H). The following shows the operating voltage range.

HS (high-speed main) mode: $V_{DD} = 2.7$ to 3.6 V@1 MHz to 32 MHz $V_{DD} = 2.4$ to 3.6 V@1 MHz to 16 MHz LS (low-speed main) mode: $V_{DD} = 1.8$ to 3.6 V@1 MHz to 8 MHz

LV (low-voltage main) mode: VDD = 1.6 to 3.6 V@1 MHz to 4 MHz

LVD Detection Voltage of Interrupt & Reset Mode (T_A = -40 to +85°C, V_{PDR} \leq V_{DD} \leq 3.6 V, V_{SS} = 0 V)

| Parameter | Symbol | Con | ditions | MIN. | TYP. | MAX. | Unit |
|-------------------|--------|-----------------------|--------------------------------|------|------|------|------|
| Interrupt & reset | VLVD13 | VPOC2, VPOC1, VPOC0 = | 0, 0, 0, falling reset voltage | 1.60 | 1.63 | 1.66 | V |
| mode | VLVD12 | LVIS1, LVIS0 = 1, 0 | Rising release reset voltage | 1.74 | 1.77 | 1.81 | V |
| | | | Falling interrupt voltage | 1.70 | 1.73 | 1.77 | V |
| | VLVD11 | LVIS1, LVIS0 = 0, 1 | Rising release reset voltage | 1.84 | 1.88 | 1.91 | V |
| | | | Falling interrupt voltage | 1.80 | 1.84 | 1.87 | V |
| | VLVD4 | LVIS1, LVIS0 = 0, 0 | Rising release reset voltage | 2.86 | 2.92 | 2.97 | V |
| | | | Falling interrupt voltage | 2.80 | 2.86 | 2.91 | V |
| | VLVD11 | VPOC2, VPOC1, VPOC0 = | 0, 0, 1, falling reset voltage | 1.80 | 1.84 | 1.87 | V |
| | VLVD10 | LVIS1, LVIS0 = 1, 0 | Rising release reset voltage | 1.94 | 1.98 | 2.02 | V |
| | | | Falling interrupt voltage | 1.90 | 1.94 | 1.98 | V |
| | VLVD9 | LVIS1, LVIS0 = 0, 1 | Rising release reset voltage | 2.05 | 2.09 | 2.13 | V |
| | | | Falling interrupt voltage | 2.00 | 2.04 | 2.08 | V |
| | VLVD2 | LVIS1, LVIS0 = 0, 0 | Rising release reset voltage | 3.07 | 3.13 | 3.19 | V |
| | | | Falling interrupt voltage | 3.00 | 3.06 | 3.12 | V |
| | VLVD8 | VPOC2, VPOC1, VPOC0 = | 2.40 | 2.45 | 2.50 | V | |
| | VLVD7 | LVIS1, LVIS0 = 1, 0 | Rising release reset voltage | 2.56 | 2.61 | 2.66 | V |
| | | | Falling interrupt voltage | 2.50 | 2.55 | 2.60 | V |
| | VLVD6 | LVIS1, LVIS0 = 0, 1 | Rising release reset voltage | 2.66 | 2.71 | 2.76 | V |
| | | | Falling interrupt voltage | 2.60 | 2.65 | 2.70 | V |
| | VLVD5 | VPOC2, VPOC1, VPOC0 = | 0, 1, 1, falling reset voltage | 2.70 | 2.75 | 2.81 | V |
| | VLVD4 | LVIS1, LVIS0 = 1, 0 | Rising release reset voltage | 2.86 | 2.92 | 2.97 | V |
| | | | Falling interrupt voltage | 2.80 | 2.86 | 2.91 | V |
| | VLVD3 | LVIS1, LVIS0 = 0, 1 | Rising release reset voltage | 2.96 | 3.02 | 3.08 | V |
| | | | Falling interrupt voltage | 2.90 | 2.96 | 3.02 | V |

Caution Set the detection voltage (VLVD) to be within the operating voltage range. The operating voltage range depends on the setting of the user option byte (000C2H/010C2H). The following shows the operating voltage range.

HS (high-speed main) mode: VDD = 2.7 to 3.6 V@1 MHz to 32 MHz

- VDD = 2.4 to 3.6 V@1 MHz to 16 MHz
- LS (low-speed main) mode: VDD = 1.8 to 3.6 V@1 MHz to 8 MHz

LV (low-voltage main) mode: VDD = 1.6 to 3.6 V@1 MHz to 4 MHz

2.6.5 Supply voltage rise slope characteristics

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, \text{Vss} = 0 \text{ V})$

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---------------------|--------|------------|------|------|------|------|
| Supply voltage rise | SVDD | | | | 54 | V/ms |

Caution Be sure to maintain the internal reset state until VDD reaches the operating voltage range specified

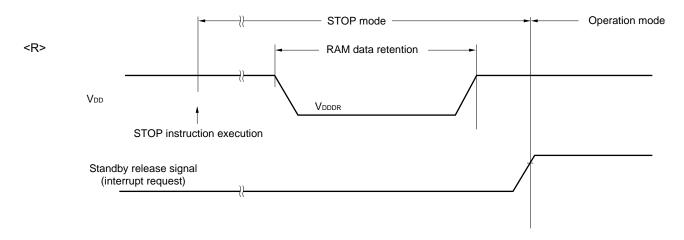
in 2.4 AC Characteristics, by using the LVD circuit or external reset pin.

<R> 2.7 RAM Data Retention Characteristics

<R> (T_A = -40 to +85°C, Vss = 0 V)

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|-------------------------------|--------|------------|----------------------|------|------|------|
| Data retention supply voltage | VDDDR | | 1.46 ^{Note} | | 3.6 | V |

<R> Note This depends on the POR detection voltage. For a falling voltage, data in RAM are retained until the voltage reaches the level that triggers a POR reset but not once it reaches the level at which a POR reset is generated.



<R> 2.8 Flash Memory Programming Characteristics

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---|--------|---|---------|-----------|------|-------|
| CPU/peripheral hardware clock frequency | fclк | $1.8~V \leq V_{\text{DD}} \leq 3.6~V$ | 1 | | 32 | MHz |
| Number of code flash rewrites ^{Notes 1, 2} | Cerwr | Retained for 20 years $T_A = 85^{\circ}C^{Note 3}$ | 1,000 | | | Times |
| Number of data flash rewrites ^{Notes 1, 2} | | Retained for 1 years T _A = $25^{\circ}C^{Note 3}$ | | 1,000,000 | | |
| | | Retained for 5 years $T_A = 85^{\circ}C^{Note 3}$ | 100,000 | | | |
| | | Retained for 20 years $T_A = 85^{\circ}C^{Note 3}$ | 10,000 | | | |

$(T_A = -40 \text{ to } +85^{\circ}C, 1.8 \text{ V} \le V_{DD} \le 3.6 \text{ V}, \text{ Vss} = 0 \text{ V})$

Notes 1. 1 erase + 1 write after the erase is regarded as 1 rewrite.

The retaining years are until next rewrite after the rewrite.

- 2. When using flash memory programmer and Renesas Electronics self programming library
- **3.** These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.

2.9 Dedicated Flash Memory Programmer Communication (UART)

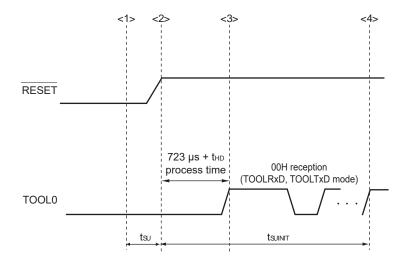
| $(1A = -40 \ 10 \ 103 \ 0, \ 1.0 \ 4 \ 3 \ 10$ | | | | | | | | |
|--|--------|---------------------------------|---------|-----------|-----|------|--|--|
| Parameter | Symbol | ol Conditions | | MIN. TYP. | | Unit | | |
| Transfer rate | | During flash memory programming | 115.2 k | | 1 M | bps | | |

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.8 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

2.10 Timing Specs for Switching Flash Memory Programming Modes

| (T _A = -40 to +85°C | $1.8 V \le EV_{DD0} \le V_{DD} \le 3.6$ | V, Vss = EVsso = 0 V) |
|--------------------------------|---|-----------------------|
|--------------------------------|---|-----------------------|

| | Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---------|---|---------|--|------|------|------|------|
| | How long from when an external reset ends until the initial communication settings are specified | tsuinit | POR and LVD reset must end before the external reset ends. | | | 100 | ms |
| | How long from when the TOOL0 pin is placed at the low level until a external reset ends | ts∪ | POR and LVD reset must end before the external reset ends. | 10 | | | μs |
| <r></r> | How long the TOOL0 pin must be kept at the low level after an external reset ends (except flash firmware processing time) | tнD | POR and LVD reset must end before the external reset ends. | 1 | | | ms |



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- <1> The low level is input to the TOOL0 pin.
- <2> The pins reset ends (POR and LVD reset must end before the external reset ends.).
- <3> The TOOL0 pin is set to the high level.
- <4> Setting of the flash memory programming mode by UART reception and complete the baud rate setting.
- **Remark** tsuinit: The segment shows that it is necessary to finish specifying the initial communication settings within 100 ms from when the resets end.
 - t_{SU} : How long from when the TOOL0 pin is placed at the low level until a external reset ends
- thd: How long to keep the TOOL0 pin at the low level from when the external resets end (except flash firmware processing time)



3. ELECTRICAL SPECIFICATIONS (G: INDUSTRIAL APPLICATIONS $T_A = -40$ to +105°C)

This chapter describes the following electrical specifications.

Target productsG:Industrial applicationsTA = -40 to +105°CR5F10EBAGNA, R5F10EBCGNA, R5F10EBDGNA, R5F10EBEGNAR5F10EGAGFB, R5F10EGCGFB, R5F10EGDGFB, R5F10EGEGFBR5F10EGAGNA, R5F10EGCGNA, R5F10EGDGNA, R5F10EGEGNAR5F10ELCGFB, R5F10ELDGFB, R5F10ELEGFB

- Cautions 1. The RL78/G1A has an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.
 - 2. With products not provided with an EV_{DD0} or EV_{SS0} pin, replace EV_{DD0} with V_{DD}, or replace EV_{SS0} with V_{SS}.
 - Please contact Renesas Electronics sales office for derating of operation under T_A = +85°C to +105°C. Derating is the systematic reduction of load for the sake of improved reliability.
- **Remark** When RL78/G1A is used in the range of $T_A = -40$ to +85°C, see 2. **ELECTRICAL SPECIFICATIONS** ($T_A = -40$ to +85°C).



3.1 Absolute Maximum Ratings

Absolute Maximum Ratings (T_A = 25°C) (1/2)

| Parameter | Symbols | Conditions | Ratings | Unit |
|------------------------|-----------------|--|--|------|
| Supply voltage | Vdd | | –0.5 to +6.5 | V |
| | EVDD0 | | –0.5 to +6.5 | V |
| | AVDD | | –0.5 to +4.6 | V |
| | AVREFP | | -0.3 to AV _{DD} +0.3 ^{Note 3} | V |
| | EVsso | | –0.5 to +0.3 | V |
| | AVss | | -0.5 to +0.3 | V |
| | AVREFM | | –0.3 to AV _{DD} +0.3 ^{Note 3} and AV _{REFM} ≤ AV _{REFP} | V |
| REGC pin input voltage | VIREGC | REGC | -0.3 to +2.8 and -0.3 to V_{DD} +0.3 $^{\text{Note 1}}$ | V |
| Input voltage | VI1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | -0.3 to EV_DD0 +0.3 and -0.3 to V_DD +0.3^Note 2 | V |
| | V ₁₂ | P60 to P63 (N-ch open-drain) | -0.3 to +6.5 | V |
| | V _{I3} | P121 to P124, P137, EXCLK, EXCLKS, RESET | -0.3 to V _{DD} +0.3 ^{Note 2} | V |
| | V ₁₄ | P20 to P27, P150 to P154 | -0.3 to AV _{DD} +0.3 ^{Note 2} | V |
| Output voltage | Vo1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P63, P70 to P77, P120, P130, P140, P141 | –0.3 to EV _{DD0} +0.3 ^{Note 2} | V |
| | V ₀₂ | P20 to P27, P150 to P154 | -0.3 to AV _{DD} +0.3 ^{Note 2} | V |
| Analog input voltage | Vaii | ANI16 to ANI30 | -0.3 to EV_DD0 +0.3 and -0.3 to AV_{REF(+)} +0.3^{Notes 2, 4} | V |
| | Vai2 | ANI0 to ANI12 | -0.3 to AV_DD +0.3 and -0.3 to AV_{REF(+)} +0.3^{Notes 2, 4} | V |

Notes 1. Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F). This value regulates the absolute maximum rating of the REGC pin. Do not use this pin with voltage applied to it.

- **2.** Must be 6.5 V or lower.
- 3. Must be 4.6 V or lower.
- 4. Do not exceed AV_{REF(+)} + 0.3 V in case of A/D conversion target pin.
- Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remarks 1.** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.
 - **2.** AV_{REF(+)}: + side reference voltage of the A/D converter.
 - **3.** Vss: Reference voltage



| Parameter | Symbols | | Conditions | Ratings | Unit |
|----------------------|---------|------------------------------|---|-------------|------|
| Output current, high | Іон1 | Per pin | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141 | -40 | mA |
| | | Total of all pins –170 mA | P00 to P04, P40 to P43, P120, P130, P140, P141 | -70 | mA |
| | | | P05, P06, P10 to P16, P30, P31, P50, P51, P70 to P77, | -100 | mA |
| | Іон2 | Per pin | P20 to P27, P150 to P154 | -0.1 | mA |
| | | Total of all pins | otal of all pins | | mA |
| Output current, low | lol1 | Per pin | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P63, P70 to P77, P120, P130, P140, P141 | 40 | mA |
| | | Total of all pins 170 mA | P00 to P04, P40 to P43, P120, P130, P140, P141 | 70 | mA |
| | | | P05, P06, P10 to P16, P30, P31, P50, P51, P60 to P63, P70 to P77 | 100 | mA |
| | IOL2 | Per pin | P20 to P27, P150 to P154 | 0.4 | mA |
| | | Total of all pins | | 6.4 | mA |
| Operating ambient | TA | In normal operation | on mode | -40 to +105 | °C |
| temperature | | In flash memory p | programming mode | | |
| Storage temperature | Tstg | | | –65 to +150 | °C |

Absolute Maximum Ratings (T_A = 25°C) (2/2)

- Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



3.2 Oscillator Characteristics

3.2.1 X1, XT1 oscillator characteristics

$(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

| Parameter | Resonator | Conditions | MIN. | TYP. | MAX. | Unit |
|--|-------------------------------------|---------------------------------------|------|--------|------|------|
| X1 clock oscillation | Ceramic resonator/crystal resonator | $2.7~V \leq V_{\text{DD}} \leq 3.6~V$ | 1.0 | | 20.0 | MHz |
| frequency (fx) ^{Note} | | $2.4~V \leq V_{\text{DD}} < 2.7~V$ | 1.0 | | 16.0 | |
| XT1 clock oscillation frequency (fx) ^{Note} | Crystal resonator | | 32 | 32.768 | 35 | kHz |

- **Note** Indicates only permissible oscillator frequency ranges. See AC Characteristics for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.
- <R> Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

3.2.2 On-chip oscillator characteristics

$(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = 0 \text{ V})$

| Oscillators | Parameters | | Conditions | MIN. | TYP. | MAX. | Unit |
|---|------------|----------------|--|------|------|------|------|
| High-speed on-chip oscillator oscillation frequency ^{Notes 1, 2} | fін | | | 1 | | 32 | MHz |
| High-speed on-chip oscillator | | +85 to +105 °C | $2.4~V \leq V_{\text{DD}} \leq 3.6~V$ | -2 | | +2 | % |
| oscillation frequency accuracy | | –20 to +85 °C | $2.4~V \leq V_{\text{DD}} \leq 3.6~V$ | -1 | | +1 | % |
| | | –40 to –20 °C | $2.4~\text{V} \leq \text{V}_{\text{DD}} \leq 3.6~\text{V}$ | -1.5 | | +1.5 | % |
| Low-speed on-chip oscillator oscillation | fı∟ | | | | 15 | | kHz |
| Low-speed on-chip oscillator oscillation frequency accuracy | | | | -15 | | +15 | % |

- **Notes 1.** High-speed on-chip oscillator frequency is selected by bits 0 to 3 of option byte (000C2H/010C2H) and bits 0 to 2 of HOCODIV register.
 - 2. This indicates the oscillator characteristics only. See AC Characteristics for instruction execution time.



3.3 DC Characteristics

3.3.1 Pin characteristics

| Items | Symbol | Conditions | | MIN. | TYP. | MAX. | U |
|---|--------|--|---|------|------|------------------------|---|
| Output current, high ^{∾ote 1} | Іон1 | Per pin for P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141 | $2.4~V \leq EV_{DD0} \leq 3.6~V$ | | | -3.0 ^{Note 2} | r |
| | | Total of P00 to P04, P40 to P43, P120, | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | -10.0 | 1 |
| | | P130, P140, P141 (When duty ≤ 70% ^{Note 3}) | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} < 2.7 \text{ V}$ | | | -5.0 | - |
| | | Total of P05, P06, P10 to P16, P30, | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | -19.0 | _ |
| | | P31, P50, P51, P70 to P77, (When duty ≤ 70% ^{Note 3}) | $2.4~V \leq EV_{DD0} < 2.7~V$ | | | -10.0 | |
| | | Total of all pins (When duty ≤ 70% ^{Note 3}) | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | -29.0 | |
| | Іон2 | Per pin for P20 to P27, P150 to P154 | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | -0.1 ^{Note 2} | |
| | | Total of all pins (When duty ≤ 70% ^{Note 3}) | $2.4~V \le AV_{\text{DD}} \le 3.6~V$ | | | -1.3 | |

- **Notes 1**. Value of current at which the device operation is guaranteed even if the current flows from the EV_{DD0}, V_{DD} pins to an output pin.
 - 2. However, do not exceed the total current value.

3. Specification under conditions where the duty factor ≤ 70%. The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

Total output current of pins = (I_{OH} × 0.7)/(n × 0.01)
 <Example> Where n = 80% and I_{OH} = -10.0 mA
 Total output current of pins = (-10.0 × 0.7)/(80 × 0.01) ≅ -8.7 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

- Caution P00, P02 to P04, P10 to P15, P43, P50, P71, and P74 do not output high level in N-ch open-drain mode.
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



<R> $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{AV}_{DD} \le \text{V}_{DD} \le 3.6 \text{ V}, 2.4 \text{ V} \le \text{EV}_{DD0} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = \text{EV}_{SS0} = 0 \text{ V})$

| $\left[14 - 4000 + 1050, 2.40 \pm 000 \pm 000 \pm 5.00, 2.40 \pm 2000 \pm 000 \pm 5.00, 355 - 10550 \pm 0.07\right] $ | | | | | | | | |
|---|--------|--|---|------|------|------------------------|------|--|
| Items | Symbol | Conditions | | MIN. | TYP. | MAX. | Unit | |
| Output current, low ^{Note 1} | Iol1 | Per pin for P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141 | | | | 8.5 ^{Note 2} | mA | |
| | | Per pin for P60 to P63 | | | | 15.0 ^{Note 2} | mA | |
| | | Total of P00 to P04, P40 to P43, P120, | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | 15.0 | mA | |
| | | P130, P140, P141 (When duty $\leq 70\%^{\text{Note 3}}$) | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} < 2.7 \text{ V}$ | | | 9.0 | mA | |
| | | P31 P50 P51 P60 to P63 | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | 35.0 | mA | |
| | | | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} < 2.7 \text{ V}$ | | | 20.0 | mA | |
| | | Total of all pins (When duty ≤ 70% ^{Note 3}) | | | | 50.0 | mA | |
| | IOL2 | Per pin for P20 to P27, P150 to P154 | | | | 0.4 ^{Note 2} | mA | |
| | | Total of all pins (When duty ≤ 70% ^{Note 3}) | $2.4 \text{ V} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | 5.2 | mA | |

Notes 1. Value of current at which the device operation is guaranteed even if the current flows from an output pin to the EVsso and Vss pin.

- **2.** However, do not exceed the total current value.
- **3.** Specification under conditions where the duty factor \leq 70%.

The output current value that has changed to the dury factor > 70% the duty ratio can can be calculated with the following expression (when changing the duty factor from 70% to n%).

- Total output current of pins = $(I_{OL} \times 0.7)/(n \times 0.01)$
- <Example> Where n = 80% and IoL = 10.0 mA

Total output current of pins = $(10.0 \times 0.7)/(80 \times 0.01) \approx 8.7 \text{ mA}$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



(2/5)

| (T _A = –40 to +10 | 5°C, 2.4 V | \leq AVDD \leq VDD \leq 3.6 V, 2.4 V \leq EVD | $DO \leq VDD \leq 3.6 V, VSS =$ | = EVsso = (|) V) | | (3/5 |
|------------------------------|------------|--|--|-------------|------|----------|------|
| Items | Symbol | Conditions | | MIN. | TYP. | MAX. | Unit |
| Input voltage, high | VIH1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | Normal input buffer | 0.8EVddo | | EVDDO | V |
| | VIH2 | P01, P03, P04, P10, P11, P13 to P16, P43 | TTL input buffer $3.3 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | 2.0 | | EVDD0 | V |
| - | | | TTL input buffer $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} < 3.3 \text{ V}$ | 1.5 | | EVDD0 | V |
| | VIH3 | P20 to P27, P150 to P154 | 0.7AVDD | | AVDD | V | |
| | VIH4 | P60 to P63 | 0.7EVDD0 | | 6.0 | V | |
| | VIH5 | P121 to P124, P137, EXCLK, EXCLK | 0.8Vdd | | Vdd | V | |
| Input voltage, low | VIL1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | Normal input buffer | 0 | | 0.2EVDD0 | V |
| | VIL2 | P01, P03, P04, P10, P11, P13 to P16, P43 | TTL input buffer $3.3 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | 0 | | 0.5 | V |
| | | | TTL input buffer $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} < 3.3 \text{ V}$ | 0 | | 0.32 | V |
| | VIL3 | P20 to P27, P150 to P154 | | 0 | | 0.3AVDD | V |
| | VIL4 | P60 to P63 | | 0 | | 0.3EVDD0 | V |
| | VIL5 | P121 to P124, P137, EXCLK, EXCLK | S, RESET | 0 | | 0.2VDD | V |

$(T_{A} = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, 2.4 \text{ V} \le \text{EV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

Caution The maximum value of VIH of pins P00, P02 to P04, P10 to P15, P43, P50, P71, and P74 is EVDD0, even in the N-ch open-drain mode.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



() (E)

| Items | Symbol | Conditions | | | TYP. | MAX. | Unit |
|-------------------------|------------------|--|--|---------------------------|------|------|------|
| Output voltage, high | Vон1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V},$ I _{OH1} = -2.0 mA | EV _{DD0} - 0.6 | | | V |
| | | P120, P130, P140, P141 | 2.4 V \leq EV _{DD0} \leq 3.6 V, Іон1 = -1.5 mA | EV _{DD0} - 0.5 | | | V |
| | V _{OH2} | P20 to P27, P150 to P154 | 2.4 V \leq AV _{DD} \leq 3.6 V, Іон2 = -100 μ A | AV _{DD} – 0.5 | | | V |
| Output voltage, Vo | V _{OL1} | /oL1 P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141 | $\begin{array}{l} 2.7 \ \text{V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \ \text{V}, \\ I_{\text{OL1}} = 3.0 \ \text{mA} \end{array}$ | | | 0.6 | V |
| | | | $2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL1}} = 1.5 \text{ mA}$ | | | 0.4 | V |
| | | | $2.4 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL1}} = 0.6 \text{ mA}$ | | | 0.4 | V |
| | Vol2 | P20 to P27, P150 to P154 | $2.4 \text{ V} \leq \text{AV}_{\text{DD}} \leq 3.6 \text{ V},$ $I_{\text{OL2}} = 400 \ \mu\text{A}$ | | | 0.4 | V |
| | Vol3 | P60 to P63 | $2.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL3}} = 3.0 \text{ mA}$ | | | 0.4 | V |
| | | | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V},$ $I_{\text{OL3}} = 2.0 \text{ mA}$ | | | 0.4 | V |

40 to ±105°C 2 4 V < AV ~~ < 2 6 V V -... **0** \/\

- Caution P00, P02 to P04, P10 to P15, P43, P50, P71, and P74 do not output high level in N-ch open-drain mode.
- Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



| $(I_A = -40 \text{ to } +10)$ | <u>)5°C, 2.4 V</u> | \leq AVDD \leq VDD \leq 3.6 V, 2.4 V \leq I | | $0 \le 3.6 \text{ V}, \text{ Vss} =$ | EVsso = | 0 V) | | (5/ |
|--------------------------------|--------------------|---|------------------|---|---------|------|------|------|
| Items | Symbol | Conditio | ons | | MIN. | TYP. | MAX. | Unit |
| Input leakage current, high | Ісінт | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P63, P70 to P77, P120, P140, P141 | VI = EVDD0 | | | | 1 | μA |
| | ILIH2 | P137, RESET | $V_{I} = V_{DD}$ | | | | 1 | μA |
| | І∟інз | P121 to P124 (X1, X2, XT1, XT2, EXCLK, EXCLKS) | VI = VDD | In input port or external clock input | | | 1 | μA |
| | | | | In resonator connection | | | 10 | μA |
| | Ілн4 | P20 to P27, P150 to P154 | $V_I = AV_{DD}$ | | | | 1 | μA |
| Input leakage current, low | luu1 | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P60 to P67, P70 to P77, P120, P140, P141 | VI = EVSSO | | | | -1 | μA |
| | ILIL2 | P137, RESET | VI = Vss | | | | -1 | μA |
| | Ililis | P121 to P124 (X1, X2, XT1, XT2, EXCLK, EXCLKS) | VI = Vss | In input port or external clock input | | | -1 | μA |
| | | | | In resonator connection | | | -10 | μA |
| | ILIL4 | P20 to P27, P150 to P154 | VI = AVss | | | | -1 | μA |
| On-chip pull-up resistance | Ru | P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P140, P141 | VI = EVsso | , In input port | 10 | 20 | 100 | kΩ |

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



3.3.2 Supply current characteristics

| Parameter | Symbol | | | Conditions | | | MIN. | TYP. | MAX. | Unit |
|-------------------|-----------------------|----------------|--|--|--------------------|-------------------------|------|------|------|------|
| Supply current | DD1 ^{Note 1} | Operating mode | HS (high-speed main) mode ^{Note 5} | f _{IH} = 32 MHz ^{Note 3} | Basic operation | V _{DD} = 3.0 V | | 2.1 | | mA |
| | | | | | Normal operation | V _{DD} = 3.0 V | | 4.6 | 7.5 | mA |
| | | | | f _{IH} = 24 MHz ^{Note 3} | Normal operation | V _{DD} = 3.0 V | | 3.7 | 5.8 | mA |
| | | | | f⊪ = 16 MHz ^{Note 3} | Normal operation | V _{DD} = 3.0 V | | 2.7 | 4.2 | mA |
| | | | HS (high-speed main) mode ^{Note 5} | $f_{MX} = 20 \text{ MHz}^{\text{Note 2}},$ $V_{\text{DD}} = 3.0 \text{ V}$ | Normal operation | Square wave input | | 3.0 | 4.9 | mA |
| | | | | | | Resonator connection | | 3.2 | 5.0 | |
| | | | | f _{MX} = 10 MHz ^{Note 2} , V _{DD} = 3.0 V | Normal operation | Square wave input | | 1.9 | 2.9 | mA |
| | | | | | | Resonator connection | | 1.9 | 2.9 | |
| | | | Subsystem clock mode | fsub = 32.768 kHz ^{Note 4} T _A = -40°C | Normal operation | Square wave input | | 4.1 | 4.9 | μA |
| | | | | Resonator connection | | 4.2 | 5.0 | | | |
| | | | | fsub = 32.768 kHz ^{Note 4} T _A = +25°C | Normal operation | Square wave input | | 4.2 | 4.9 | μA |
| | | | | | | Resonator connection | | 4.3 | 5.0 | |
| | | | | f _{SUB} = 32.768 kHz ^{Note 4} T _A = +50°C | Normal operation | Square wave input | | 4.3 | 5.5 | μA |
| | | | | | | Resonator connection | | 4.4 | 5.6 | |
| | | | | f _{SUB} = 32.768 kHz ^{Note 4} T _A = +70°C | Normal operation | Square wave input | | 4.5 | 6.3 | μA |
| | | | | | | Resonator connection | | 4.6 | 6.4 | |
| | | | | fsub = 32.768 kHz ^{Note 4} T _A = +85°C | Normal operation | Square wave input | | 4.8 | 7.7 | μA |
| | | | | | | Resonator connection | | 4.9 | 7.8 | |
| | | | | fsub = 32.768 kHz ^{Note 4} T _A = +105°C | Normal operation | Square wave input | | 6.9 | 19.7 | μΑ |
| | | | | | | Resonator connection | | 7.0 | 19.8 | |

| $(T_A = -40 \text{ to } +105^{\circ}\text{C},$ | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}, \text{ Vss} = \text{EV}_{\text{SS0}} = 0 \text{ V})$ |
|--|---|
| | |

(Notes and Remarks are listed on the next page.)



- **Notes 1.** Total current flowing into V_{DD} and EV_{DD0}, including the input leakage current flowing when the level of the input pin is fixed to V_{DD}, EV_{DD0} or V_{SS}, EV_{SS0}. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, LVD circuit, I/O port, on-chip pull-up/pull-down resistors, and data flash rewriting.
 - 2. When high-speed on-chip oscillator and subsystem clock are stopped.
 - 3. When high-speed system clock and subsystem clock are stopped.
 - **4.** When high-speed on-chip oscillator and high-speed system clock are stopped. When setting ultra-low power consumption oscillation (AMPHS1 = 1). Not including the current flowing into the RTC, 12-bit interval timer and watchdog timer
 - **5.** Relationship between operation voltage width, operation frequency of CPU and operation mode is as below.

HS (high-speed main) mode: $V_{DD} = 2.7 V \text{ to } 3.6 V@1 \text{ MHz to } 32 \text{ MHz}$ $V_{DD} = 2.4 V \text{ to } 3.6 V@1 \text{ MHz to } 16 \text{ MHz}$

- **Remarks 1.** f_{MX}: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
 - 2. fin: High-speed on-chip oscillator clock frequency
 - 3. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
 - 4. Except subsystem clock operation, temperature condition of the TYP. value is $T_A = 25^{\circ}C$



| (T _A = -40 to | • +105°C | , 2.4 V ≤ E | $V_{DD0} \leq V_{DD} \leq 3.6$ | V, Vss = EVsso = 0 V |) | | | | (2/3) |
|---------------------------|-----------------------|------------------------|--------------------------------|--|-------------------------|------|------|-------|-------|
| Parameter | Symbol | | | Conditions | | MIN. | TYP. | MAX. | Unit |
| Supply | DD2Note 2 | HALT | HS (high-speed | fı⊢ = 32 MHz ^{Note 4} | V _{DD} = 3.0 V | | 0.54 | 2.90 | mA |
| current ^{Note 1} | | mode | main) mode ^{Note 7} | f _{IH} = 24 MHz ^{Note 4} | V _{DD} = 3.0 V | | 0.44 | 2.30 | mA |
| | | | | f⊮ = 16 MHz ^{Note 4} | V _{DD} = 3.0 V | | 0.40 | 1.70 | mA |
| | | | HS (high-speed | f _{MX} = 20 MHz ^{Note 3} , | Square wave input | | 0.28 | 1.90 | mA |
| | | | main) mode ^{Note 7} | V _{DD} = 3.0 V | Resonator connection | | 0.45 | 2.00 | |
| | | | | f _{MX} = 10 MHz ^{Note 3} , | Square wave input | | 0.19 | 1.02 | mA |
| | | | | V _{DD} = 3.0 V | Resonator connection | | 0.26 | 1.10 | |
| | | | Subsystem clock | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.25 | 0.57 | μA |
| | | | mode | $T_A = -40^{\circ}C$ | Resonator connection | | 0.44 | 0.76 | |
| | | | | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.30 | 0.57 | μA |
| | | | | T _A = +25°C | Resonator connection | | 0.49 | 0.76 | |
| | | | | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.38 | 1.17 | μA |
| | | | | T _A = +50°C | Resonator connection | | 0.57 | 1.36 | |
| | | | | fsuв = 32.768 kHz ^{Note 5} | Square wave input | | 0.52 | 1.97 | μA |
| | | | | T _A = +70°C | Resonator connection | | 0.71 | 2.16 | |
| | | | | fsub = 32.768 kHz ^{Note 5} | Square wave input | | 0.97 | 3.37 | μA |
| | | | | T _A = +85°C | Resonator connection | | 1.16 | 3.56 | |
| | | | | fsub = 32.768 kHz ^{Note 5} | Square wave input | | 3.01 | 15.37 | μA |
| | | | | T _A = +105°C | Resonator connection | | 3.20 | 15.56 | |
| | DD3 ^{Note 6} | STOP | T _A = -40°C | | | | 0.16 | 0.50 | μA |
| | | mode ^{Note 8} | | | | | 0.23 | 0.50 | |
| | | | T _A = +50°C | | | | 0.34 | 1.10 | |
| | | | T _A = +70°C | | | | 0.46 | 1.90 | |
| | | | T _A = +85°C | | | | 0.75 | 3.30 | |
| | | | T _A = +105°C | | | | 2.94 | 15.30 | |

(Notes and Remarks are listed on the next page.)



- Notes 1. Total current flowing into VDD and EVDDO, including the input leakage current flowing when the level of the input pin is fixed to VDD, EVDDO or Vss, EVsso. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, LVD circuit, I/O port, on-chip pull-up/pull-down resistors, and data flash rewriting.
 - 2. During HALT instruction execution by flash memory.
 - 3. When high-speed on-chip oscillator and subsystem clock are stopped.
 - 4. When high-speed system clock and subsystem clock are stopped.
 - When high-speed on-chip oscillator and high-speed system clock are stopped. When RTCLPC = 1 and setting ultra-low current consumption (AMPHS1 = 1). Including the current flowing into the RTC. However, not including the current flowing into the 12-bit interval timer, and watchdog timer.
 - **6.** When subsystem clock is stopped. Not including the current flowing into the RTC, 12-bit interval timer, watchdog timer.
 - **7.** Relationship between operation voltage width, operation frequency of CPU and operation mode is as below.

HS (high-speed main) mode: $2.7 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}@1 \text{ MHz}$ to 32 MHz

 $2.4 \text{ V} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}@1 \text{ MHz}$ to 16 MHz

- **8.** Regarding the value for current to operate the subsystem clock in STOP mode, refer to that in HALT mode.
- **Remarks 1.** fMX: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
 - 2. fin: High-speed on-chip oscillator clock frequency
 - 3. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
 - **4.** Except subsystem clock operation and STOP mode, temperature condition of the TYP. value is $T_A = 25^{\circ}C$



| Parameter | Symbol | | Conditions | MIN. | TYP. | MAX. | Unit |
|--|------------------------------|-------------------------------|--|------|------|------|------|
| Low-speed on-chip oscillator operating current | _{FIL} Note 1 | | | | 0.20 | | μA |
| RTC operating current | _{RTC} Notes 1, 2, 3 | | | | 0.02 | | μA |
| 12-bit interval timer operating current | ITNotes 1, 2, 4 | | | | 0.02 | | μA |
| Watchdog timer operating current | _{WDT} Notes 1, 2, 5 | f⊩ = 15 kHz | | | 0.22 | | μA |
| A/D converter operating current | ADC ^{Notes 6, 7} | AV _{DD} = 3.0 V, W | V_{DD} = 3.0 V, When conversion at maximum speed | | | 720 | μA |
| AVREF(+) current IAVREF ^{Note 8} | | AV _{DD} = 3.0 V, A | DREFP1 = 0, ADREFP0 = 0 ^{Note 7} | | 14.0 | 25.0 | μA |
| | | AV _{REFP} = 3.0 V, / | $ADREFP1 = 0, ADREFP0 = 1^{Note 10}$ | | 14.0 | 25.0 | μA |
| | | ADREFP1 = 1, A | $\Delta DREFP0 = 0^{Note 1}$ | | 14.0 | 25.0 | μA |
| A/D converter reference voltage current | ADREF ^{Notes 1, 9} | V _{DD} = 3.0 V | | | 75.0 | | μA |
| Temperature sensor operating current | I _{TMPS} Note 1 | V _{DD} = 3.0 V | | | 75.0 | | μA |
| LVD operating current | ILVD ^{Notes 1, 11} | | | | 0.08 | | μA |
| BGO operating current | BGO ^{Notes 1, 12} | | | | 2.5 | 12.2 | mA |
| Self-programming operating current | FSP ^{Notes 1, 13} | | | | 2.5 | 12.2 | mA |
| SNOOZE operating | Isnoz | A/D converter | The mode is performed ^{Notes 1, 14} | | 0.50 | 1.10 | mA |
| current | | operation | During A/D conversion ^{Note 1} | | 0.60 | 1.34 | mA |
| | | (AV _{DD} = 3.0 V) | During A/D conversion ^{Note 7} | | 420 | 720 | μA |
| | | CSI/UART opera | ation ^{Note 1} | | 0.70 | 1.54 | mA |

(**T** EV/a

(Notes and Remarks are listed on the next page.)



- <R> Notes 1. Current flowing to VDD.
 - 2. When high-speed on-chip oscillator and high-speed system clock are stopped.
 - 3. Current flowing only to the real-time clock (RTC) (excluding the operating current of the low-speed on-chip ocsillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IRTC, when the real-time clock operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added. IDD2 subsystem clock operation includes the operational current of the real-time clock.
 - 4. Current flowing only to the 12-bit interval timer (excluding the operating current of the low-speed on-chip ocsillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IIT, when the 12-bit interval timer operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added.
 - **5.** Current flowing only to the watchdog timer (including the operating current of the low-speed on-chip oscillator). The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2, or IDD3 and IWDT when the watchdog timer is in operation.
 - **6.** Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IADC, IAVREF, IADREF when the A/D converter operates in an operation mode or the HALT mode.
 - 7. Current flowing to the AVDD.
 - 8. Current flowing from the reference voltage source of A/D converter.
 - 9. Operation current flowing to the internal reference voltage.
 - **10.** Current flowing to the AVREFP.
 - **11.** Current flowing only to the LVD circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and ILVD when the LVD circuit is in operation.
 - 12. Current flowing only during data flash rewrite.
 - **13.** Current flowing only during self programming.

Remarks 1. fil: Low-speed on-chip oscillator clock frequency

- 2. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
- 3. fclk: CPU/peripheral hardware clock frequency
- 4. Temperature condition of the TYP. value is $T_A = 25^{\circ}C$



3.4 AC Characteristics

$(T_A = -40 \text{ to } +105^{\circ}\text{C}, \text{ AV}_{DD} \le \text{V}_{DD} \le 3.6 \text{ V}, 2.4 \text{ V} \le \text{EV}_{DD0} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = \text{EV}_{SS0} = 0 \text{ V})$

| Items | Symbol | | Conditio | ons | | MIN. | TYP. | MAX. | Unit |
|--|--------------|--|--------------|--------------|---|-----------|------|------|--------------------|
| Instruction cycle (minimum | Тсү | Main system | HS (high-spe | ed | $2.7~V \leq V_{\text{DD}} \leq 3.6~V$ | 0.03125 | | 1 | μs |
| instruction execution time) | | clock (fmain) operation | main) mode | | $2.4 \text{ V} \le \text{V}_{\text{DD}} < 2.7 \text{ V}$ | 0.0625 | | 1 | μs |
| | | $\begin{array}{llllllllllllllllllllllllllllllllllll$ | | 28.5 | 30.5 | 31.3 | μs | | |
| | | In the self | HS (high-spe | ed | $2.7~V \leq V_{\text{DD}} \leq 3.6~V$ | 0.03125 | | 1 | μs |
| | | programming n mode | main) mode | main) mode 2 | $2.4 \text{ V} \le \text{V}_{\text{DD}} < 2.7 \text{ V}$ | 0.0625 | | 1 | μs |
| External system clock | fex | $2.7~V \leq V_{\text{DD}} \leq$ | 3.6 V | | | 1.0 | | 20.0 | MHz |
| frequency | | $2.4 \text{ V} \le \text{V}_{\text{DD}} < 2.7 \text{ V}$ | | | 1.0 | | 16.0 | MHz | |
| | fexs | | | | | 32 | | 35 | kHz |
| External system clock input | texh, texl | $2.7~V \leq V_{\text{DD}} \leq$ | 3.6 V | | | 24 | | | ns |
| high-level width, low-level width | | $2.4~V \leq V_{\text{DD}} <$ | 2.7 V | | | 30 | | | ns |
| | texns, texls | | | | | 13.7 | | | μs |
| TI00, TI01, TI03 to TI07 input high-level width, low-level width | tт⊪, tт⊫ | | | | | 1/fмск+10 | | | ns ^{Note} |
| TO00, TO01, TO03 to | fто | HS (high-spee | ed main) 2. | 7 V | $\leq EV_{DD0} \leq 3.6 V$ | | | 8 | MHz |
| TO07 output frequency | | mode | 2. | .4 V | $\leq EV_{DD0} < 2.7 V$ | | | 4 | MHz |
| PCLBUZ0, PCLBUZ1 | f PCL | HS (high-spee | ed main) 2. | .7 V | $\leq EV_{DD0} \leq 3.6 V$ | | | 8 | MHz |
| output frequency | | mode | 2. | 4 V | \leq EV _{DD0} < 2.7 V | | | 4 | MHz |
| Interrupt input high-level | tinth, tintl | INTP0 | 2. | .4 V | $\leq V_{\text{DD}} \leq 3.6 \text{ V}$ | 1 | | | μs |
| width, low-level width | | INTP1 to INTE | P11 2. | .4 V | $\leq EV_{DD0} \leq 3.6 V$ | 1 | | | μs |
| Key interrupt input high-level width, low-level width | tкr | KR0 to KR9 | | | $\leq EV_{DD0} \leq 3.6 V,$ $\leq AV_{DD0} \leq 3.6 V$ | 250 | | | ns |
| RESET low-level width | trsl | | | | | 10 | | | μs |

Note The following conditions are required for low-voltage interface when $EV_{DD0} < V_{DD}$. 2.4 V $\leq EV_{DD0} < 2.7$ V : MIN. 125 ns

Remark fmck: Timer array unit operation clock frequency

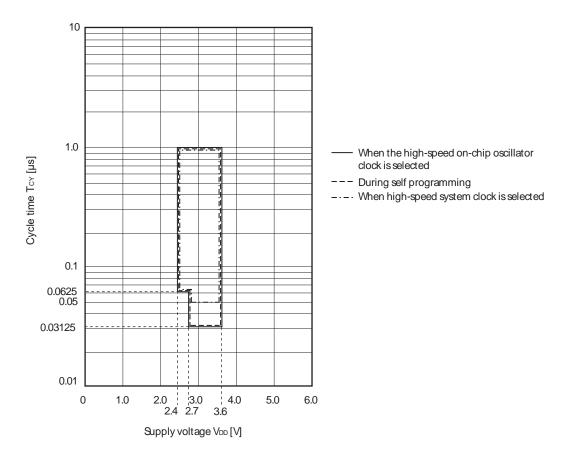
(Operation clock to be set by the CKS0n bit of timer clock select register 0 (TPS0) and timer mode register 0n (TMR0n). n: Channel number (n = 0 to 7))



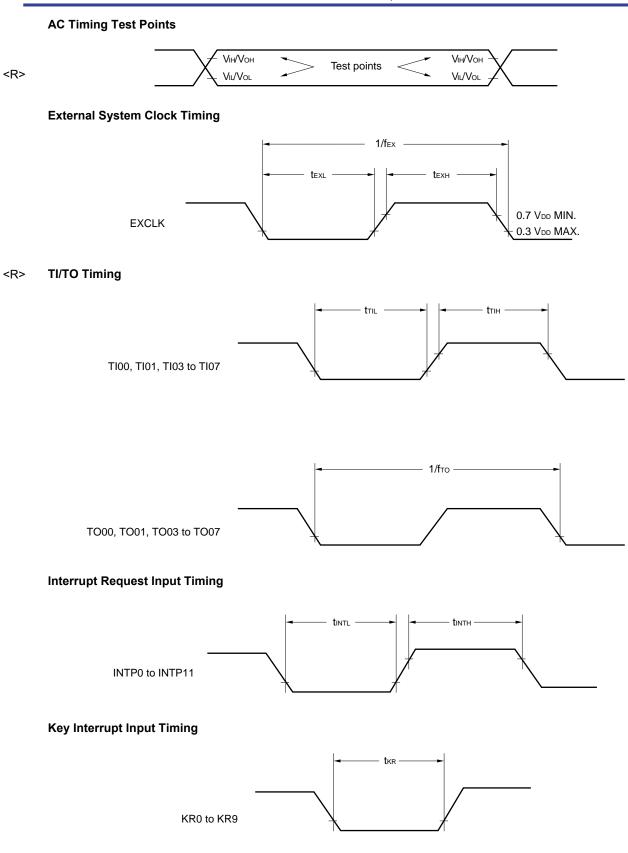
Minimum Instruction Execution Time during Main System Clock Operation



TCY vs VDD (HS (high-speed main) mode)

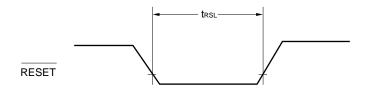








RESET Input Timing





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3.5 Peripheral Functions Characteristics

AC Timing Test Points



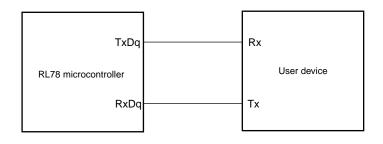
3.5.1 Serial array unit

(1) During communication at same potential (UART mode) (dedicated baud rate generator output) ($T_A = -40$ to +105°C, 2.4 V $\leq EV_{DD0} \leq V_{DD} \leq 3.6$ V, Vss = EVsso = 0 V)

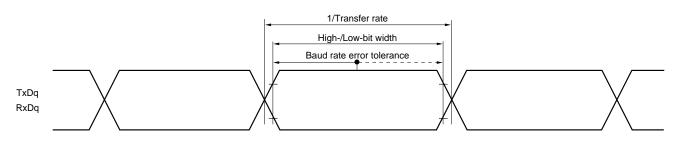
| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---------------------------------|--------|--|------|------|-----------------------|------|
| Transfer rate ^{Note 1} | | | | | fмск/12 | bps |
| | | Theoretical value of the maximum transfer rate fcLk = 32 MHz, fMck = fcLk | | | 2.6 ^{Note 2} | Mbps |

- Notes 1. Transfer rate in the SNOOZE mode is 4800 bps.
 - 2. The following conditions are required for low-voltage interface when $EV_{DD0} < V_{DD}$. 2.4 V $\leq EV_{DD0} < 2.7$ V : MAX. 1.3 Mbps
- Caution Select the normal input buffer for the RxDq pin and the normal output mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg).

UART mode connection diagram (during communication at same potential)



UART mode bit width (during communication at same potential) (reference)



Remarks 1. q: UART number (q = 0 to 2), g: PIM and POM number (g = 0, 1)

2. fmck: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

n: Channel number (mn = 00 to 03, 10, 11))

(2) During communication at same potential (CSI mode) (master mode, SCKp... internal clock output) (T_A = -40 to +105°C, 2.4 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

| Parameter | Symbol | Condition | Conditions | | TYP. | MAX. | Unit |
|--|--------------|---|----------------|--------------|------|------|------|
| SCKp cycle time | tkCY1 | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | tkcy1 ≥ 4/fcLk | 250 | | | ns |
| | | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | tĸcyı ≥ 4/fc∟ĸ | 500 | | | ns |
| SCKp high-/low-level width | tкнı, | 2.7 V ≤ EV _{DD0} ≤ 3.6 V tkcy1 | | tkcy1/2 - 36 | | | ns |
| | t ĸ∟1 | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | tксү1/2 – 76 | | | ns |
| SIp setup time (to SCKp↑) ^{Note 1} | tsik1 | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | 66 | | | ns |
| | | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | 113 | | | ns |
| SIp hold time (from SCKp↑) ^{Note 1} | tksi1 | | | 38 | | | ns |
| Delay time from SCKp↓ to SOp output ^{Note 2} | tkso1 | C = 30 p ^{Note 3} | | | | 50 | ns |

- Notes 1. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
 - 2. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
 - **3.** C is the load capacitance of the SCKp and SOp output lines.
- Caution Select the normal input buffer for the SIp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).
- **Remark** p: CSI number (p = 00, 01, 10, 11, 20, 21), m: Unit number (m = 0, 1), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 1)



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(3) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input) ($T_A = -40$ to +105°C, 2.4 V $\leq EV_{DD0} \leq V_{DD} \leq 3.6$ V, Vss = EVsso = 0 V)

| Parameter | Symbol | Cond | ditions | MIN. | TYP. | MAX. | Unit |
|-----------------------------------|--------------------|--|---|---------------------------------|------|------------|------|
| SCKp cycle time ^{Note 1} | t ксү2 | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 16 MHz < fмск | 16/f мск | | | ns |
| | | | fмск ≤ 16 MHz | 12/f мск | | | ns |
| | | $2.4 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}$ | | 12/f _{мск} and 1000 | | | ns |
| SCKp high-/low-level width | t _{кн2} , | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | tксү2/2–14 | | | ns | |
| | tĸ∟2 | $2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | | tксү2/2–16 | | | ns |
| SIp setup time | tsik2 | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 1/fмск + 40 | | | ns | |
| (to SCKp↑) ^{Note 2} | | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 1 | 1/fмск + 60 | | | ns |
| SIp hold time | tKSI2 | $2.7 \text{ V} \leq EV_{\text{DD0}} \leq 3.6 \text{ V}$ | , | 1/fмск+62 | | | ns |
| (from SCKp↑) ^{Note 2} | | $2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}$ | 1 | 1/fмск+62 | | | ns |
| Delay time from SCKp↓ to | tkso2 | C = 30 pF ^{Note 4} | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | 2/fмск+66 | ns |
| SOp output ^{Note 3} | | | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | 2/fмск+113 | ns |

Notes 1. Transfer rate in the SNOOZE mode : MAX. 1 Mbps

- When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- **3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- **4.** C is the load capacitance of the SOp output lines.

Caution Select the normal input buffer for the SIp pin and SCKp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

Remarks 1. p: CSI number (p = 00, 01, 10, 11, 20, 21), m: Unit number (m = 0, 1), n: Channel number (n = 0 to 3),

g: PIM number (g = 0, 1)

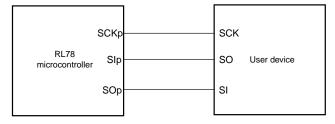
2. fMCK: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

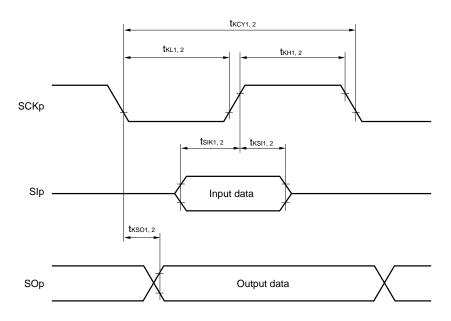
n: Channel number (mn = 00 to 03, 10, 11))



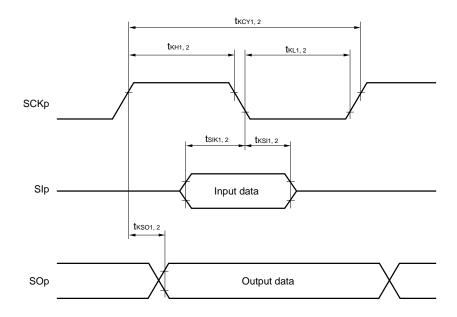
CSI mode connection diagram (during communication at same potential)

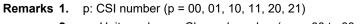


CSI mode serial transfer timing (during communication at same potential) (When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)



CSI mode serial transfer timing (during communication at same potential) (When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)





2. m: Unit number, n: Channel number (mn = 00 to 03, 10, 11)

| Parameter | Symbol | Conditions | MIN. | MAX. | Unit |
|-------------------------------|---------|---|---|-----------------------|------|
| SCLr clock frequency | fsc∟ | $\begin{array}{l} 2.7 \ \text{V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \ \text{V}, \\ C_{\text{b}} = 50 \ \text{pF}, \ \text{R}_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$ | | 400 ^{Note 1} | kHz |
| | | $\label{eq:linear} \begin{array}{l} 2.4 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 3 k\Omega \end{array}$ | | 100 ^{Note 1} | kHz |
| Hold time when SCLr = "L" | tLow | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ C_{b} = 50 \ pF, \ R_{b} = 2.7 \ k\Omega \end{array}$ | 1200 | | ns |
| | | $\label{eq:linear} \begin{array}{l} 2.4 \mbox{ V} \leq EV_{\mbox{DD}0} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 3 k\Omega \end{array}$ | 4600 | | ns |
| Hold time when SCLr = "H" | tніgн | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ C_{b} = 50 \ pF, \ R_{b} = 2.7 \ k\Omega \end{array}$ | 1200 | | ns |
| | | $\label{eq:linear} \begin{array}{l} 2.4 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 3 k\Omega \end{array}$ | 4600 | | ns |
| Data setup time (reception) | tsu:dat | $\begin{array}{l} 2.7 \ \text{V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \ \text{V}, \\ C_{\text{b}} = 50 \ \text{pF}, \ \text{R}_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$ | 1/f _{мск} + 220 ^{Note 2} | | ns |
| | | $\label{eq:linear} \begin{array}{l} 2.4 \mbox{ V} \leq EV_{\mbox{DD}} \leq 3.6 \mbox{ V}, \\ C_{\mbox{\tiny b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{\tiny b}} = 3 k\Omega \end{array}$ | 1/f _{мск} + 580 ^{Note 2} | | ns |
| Data hold time (transmission) | thd:dat | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ C_{b} = 50 \ pF, \ R_{b} = 2.7 \ k\Omega \end{array}$ | 0 | 770 | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{\text{DD0}} \leq 3.6 \ V, \\ C_{\text{b}} = 100 \ \text{pF}, \ R_{\text{b}} = 3 \ \text{k}\Omega \end{array}$ | 0 | 1420 | ns |

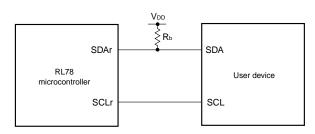
| (4) | During communication at same potential (simplified I ² C mode) |
|-----|--|
| | $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = 0 \text{ V})$ |

Notes 1. The value must also be fcLK/4 or lower.

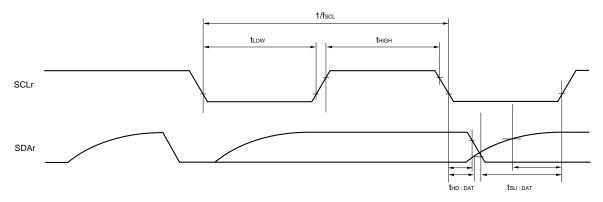
- 2. Set the fMCK value to keep the hold time of SCLr = "L" and SCLr = "H".
- Caution Select the normal input buffer and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SDAr pin and the normal output mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register h (POMh).



Simplified I²C mode mode connection diagram (during communication at same potential)



Simplified I²C mode serial transfer timing (during communication at same potential)



- **Remarks 1.** R_b[Ω]: Communication line (SDAr) pull-up resistance, C_b[F]: Communication line (SDAr, SCLr) load capacitance
 - **2.** r: IIC number (r = 00, 01, 10, 11, 20, 21), g: PIM number (g = 0, 1), h: POM number (h = 0, 1)
 - fMCK: Serial array unit operation clock frequency
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number, mn = 00 to 03, 10, 11)



(5) Communication at different potential (1.8 V, 2.5 V) (UART mode) (dedicated baud rate generator output) (1/2) ($T_A = -40$ to +105°C, 2.4 V $\leq EV_{DD0} \leq V_{DD} \leq 3.6$ V, Vss = EVsso = 0 V)

| Parameter | Symbol | | Conditions | | | TYP. | MAX. | Unit |
|---------------------------------|--------|-----------|--|---|--|------|-----------------------|------|
| Transfer rate ^{Note 1} | | Reception | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V,$ | | | | fмск/12 | bps |
| | | | | Theoretical value of the maximum transfer rate f _{CLK} = 32 MHz, f _{MCK} = f _{CLK} | | | 2.6 | Mbps |
| | | | $2.4~V \leq EV_{\text{DD0}} < 3.3~V,$ | | | | fмск/12 | bps |
| | | | $1.6~V \leq V_b \leq 2.0~V$ | Theoretical value of the maximum transfer rate f _{CLK} = 32 MHz, f _{MCK} = f _{CLK} | | | 2.6 ^{Note 2} | Mbps |

Notes 1. Transfer rate in the SNOOZE mode is 4800 bps.

The following conditions are required for low-voltage interface when EV_{DD0} < V_{DD}.
 2.4 V ≤ EV_{DD0} < 2.7 V : MAX. 1.3 Mbps

Caution Select the TTL input buffer for the RxDq pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

Remarks 1. V_b[V]: Communication line voltage

- **2.** q: UART number (q = 0 to 2), g: PIM and POM number (g = 0, 1)
- fMCK: Serial array unit operation clock frequency
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,
 n: Channel number (mn = 00 to 03, 10, 11)

<R>



(5) Communication at different potential (1.8 V, 2.5 V) (UART mode) (dedicated baud rate generator output) (2/2) (T_A = -40 to +105°C, 2.4 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

| Parameter | Symbol | | Cond | MIN. | TYP. | MAX. | Unit | |
|-----------|--------|---|--|--|------|-----------------------|------------------------|------|
| Transfer | | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V,$ | | | | Note 1 | bps | |
| rate | | $2.3 \text{ V} \leq \text{V}_b \leq 2.7 \text{ V}$ | Theoretical value of the maximum transfer rate $C_b = 50 \text{ pF}, R_b = 2.7 \text{ k}\Omega, V_b = 2.3 \text{ V}$ | | | 1.2 ^{Note 2} | Mbps | |
| | | $2.4 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V},$ | $V \leq EV_{DD0} < 3.3 V$, | | | Note 3 | bps | |
| | | | $1.6 \text{ V} \leq V_b \leq 2.0 \text{ V}$ | Theoretical value of the maximum transfer rate $C_b = 50 \text{ pF}, R_b = 5.5 \text{ k}\Omega, V_b = 1.6 \text{ V}$ | | | 0.43 ^{Note 4} | Mbps |

Notes 1. The smaller maximum transfer rate derived by using f_{MCK}/12 or the following expression is the valid maximum transfer rate.

Expression for calculating the transfer rate when 2.7 V \leq EV_{DD0} \leq 3.6 V and 2.3 V \leq V_b \leq 2.7 V

Maximum transfer rate =
$$\frac{1}{\{-C_b \times R_b \times \ln (1 - \frac{2.0}{V_b})\} \times 3}$$
 [bps]

Baud rate error (theoretical value) =

$$\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln (1 - \frac{2.0}{V_b})\} \times 100 [\%]$$

 $(\frac{1}{\text{Transfer rate}})$ × Number of transferred bits

- * This value is the theoretical value of the relative difference between the transmission and reception sides.
- This value as an example is calculated when the conditions described in the "Conditions" column are met. See Note 1 above to calculate the maximum transfer rate under conditions of the customer.
- **3.** The smaller maximum transfer rate derived by using fMCK/12 or the following expression is the valid maximum transfer rate.

Expression for calculating the transfer rate when 2.4 V \leq EV_{DD0} < 3.3 V and 1.6 V \leq V_b \leq 2.0 V

Maximum transfer rate =
$$\frac{1}{\{-C_b \times R_b \times \ln (1 - \frac{1.5}{V_b})\} \times 3}$$
 [bps]

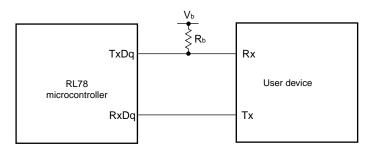
Baud rate error (theoretical value) = $\frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{1.5}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 [\%]$

* This value is the theoretical value of the relative difference between the transmission and reception sides.
4. This value as an example is calculated when the conditions described in the "Conditions" column are met. See Note 3 above to calculate the maximum transfer rate under conditions of the customer.

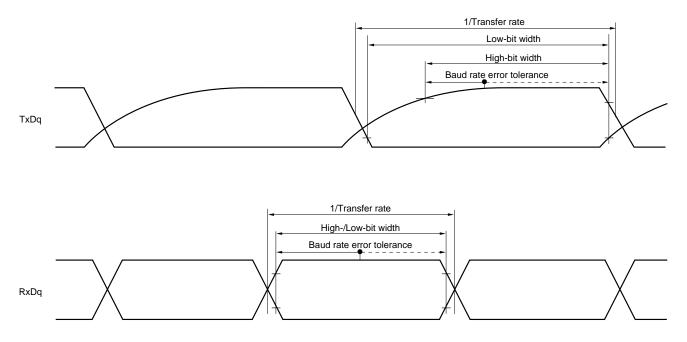
Caution Select the TTL input buffer for the RxDq pin and the N-ch open drain output (Vbb tolerance (When 25- to 48-pin products)/EVbb tolerance (When 64-pin products)) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For ViH and ViL, see the DC characteristics with TTL input buffer selected.

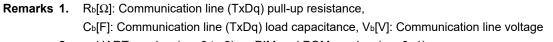
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UART mode connection diagram (during communication at different potential)



UART mode bit width (during communication at different potential) (reference)





2. q: UART number (q = 0 to 2), g: PIM and POM number (g = 0, 1)

3. fmck: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn).

m: Unit number, n: Channel number (mn = 00 to 03, 10, 11))



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(6) Communication at different potential (1.8 V, 2.5 V) (CSI mode) (master mode, SCKp... internal clock output) (1/2) $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS}} = 0 \text{ V})$

| Parameter | Symbol | Conditions | | MIN. | TYP. | MAX. | Unit |
|-----------------------|--------|--|-----------------------|---------------|------|------|------|
| SCKp cycle time | tксүı | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | tксү1 ≥ 4/fc∟к | 1000 | | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | tксү1 ≥ 4/fc∟к | 2300 | | | ns |
| SCKp high-level width | tкнı | $\begin{array}{l} 2.7 \ V \leq EV_{\text{DD0}} \leq 3.6 \ \text{V}, \ 2.3 \ \text{V} \leq V_{\text{b}} \leq 2.7 \ \text{V}, \\ C_{\text{b}} = 30 \ \text{pF}, \ R_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$ | | tксү1/2 – 340 | | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{\text{DD0}} < 3.3 \ V, \ 1.6 \ V \leq V_{\text{b}} \leq 2.0 \ V, \\ C_{\text{b}} = 30 \ pF, \ R_{\text{b}} = 5.5 \ k\Omega \end{array}$ | | tксү1/2 – 916 | | | ns |
| SCKp low-level width | tĸ∟1 | $\begin{array}{l} 2.7 \; V \leq EV_{\text{DD0}} \leq 3.6 \; V, \; 2.3 \; V \leq \\ C_{\text{b}} = 30 \; \text{pF}, \; R_{\text{b}} = 2.7 \; \text{k}\Omega \end{array}$ | $V_{b} \leq 2.7 \ V,$ | tксү1/2 – 36 | | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{\text{DD0}} < 3.3 \ V, \ 1.6 \ V \leq \\ C_{\text{b}} = 30 \ \text{pF}, \ R_{\text{b}} = 5.5 \ \text{k}\Omega \end{array}$ | $V_b \leq 2.0 V$, | tксү1/2 – 100 | | | ns |

Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

- **Remarks 1.** R_b[Ω]: Communication line (SCKp, SOp) pull-up resistance, C_b[F]: Communication line (SCKp, SOp) load capacitance, V_b[V]: Communication line voltage
 - p: CSI number (p = 00, 10, 20), m: Unit number , n: Channel number (mn = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - **3.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.



| Parameter Symbol | | Conditions | MIN. TYP. MAX. | | MAX. | Unit |
|--|-------|--|----------------|--|------|------|
| Slp setup time (to SCKp↑) ^{Note 1} | tsıkı | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 354 | | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | 958 | | | ns |
| Slp hold time (from SCKp↑) ^{Note 1} | tksi1 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 38 | | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | 38 | | | ns |
| Delay time from SCKp↓ to SOp output ^{Note 1} | tkso1 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | | | 390 | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | | | 966 | ns |
| SIp setup time (to SCKp↓) ^{Note 2} | tsıĸı | $\begin{array}{l} 2.7 \; V \leq EV_{\text{DD0}} \leq 3.6 \; \text{V}, \; 2.3 \; V \leq V_{b} \leq 2.7 \; \text{V}, \\ C_{b} = 30 \; p\text{F}, \; R_{b} = 2.7 \; \text{k}\Omega \end{array}$ | 88 | | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | 220 | | | ns |
| SIp hold time (from SCKp↓) ^{Note 2} | tksi1 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 38 | | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | 38 | | | ns |
| Delay time from SCKp↑ to SOp output ^{Note 2} | tkso1 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | | | 50 | ns |
| | | 2.4 V \leq EV _{DD0} < 3.3 V, 1.6 V \leq V _b \leq 2.0 V, C _b = 30 pF, R _b = 5.5 k Ω | | | 50 | ns |

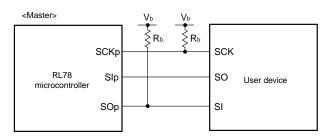
| (6) | Communication at different potential (1.8 V, 2.5 V) (CSI mode) (master mode, SCKp internal clock output) (2/2) |
|-----|--|
| | (T _A = -40 to +105°C, 2.4 V ≤ EV _{DD0} ≤ V _{DD} ≤ 3.6 V, Vss = EV _{SS0} = 0 V) |

Notes 1. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.

2. When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

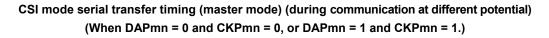
Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

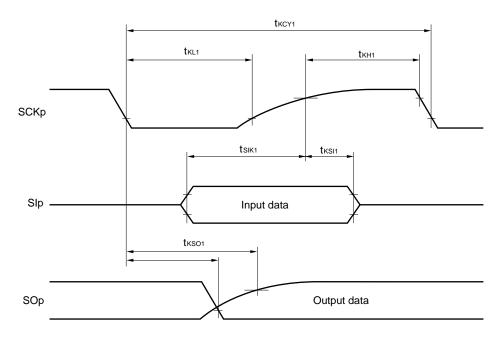
CSI mode connection diagram (during communication at different potential)



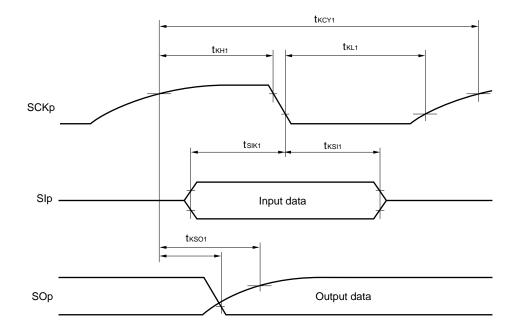
- **Remarks 1.** R_b[Ω]: Communication line (SCKp, SOp) pull-up resistance, C_b[F]: Communication line (SCKp, SOp) load capacitance, V_b[V]: Communication line voltage
 - p: CSI number (p = 00, 10, 20), m: Unit number , n: Channel number (mn = 00, 02, 10),
 g: PIM and POM number (g = 0, 1)
 - **3.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.







CSI mode serial transfer timing (master mode) (during communication at different potential) (When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)



- **Remarks 1.** p: CSI number (p = 00, 10, 20), m: Unit number, n: Channel number (m = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - **2.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

(7) Communication at different potential (1.8 V, 2.5 V) (CSI mode) (slave mode, SCKp... external clock input) ($T_A = -40$ to +105°C, 2.4 V $\leq EV_{DD0} \leq V_{DD} \leq 3.6$ V, Vss = EVsso = 0 V)

| Parameter | Symbol | Cor | MIN. | TYP. | MAX. | Unit | |
|--|---------------|--|-----------------------------|------------------|------|------------------------------|----|
| SCKp cycle time ^{Note 1} | tксү2 | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V \end{array}$ | 24 MHz < fмск | 40/f мск | | | ns |
| | | | 20 MHz < fмск ≤ 24 MHz | 32/f мск | | | ns |
| | | | 16 MHz < fмск ≤ 20 MHz | 28/ f мск | | | ns |
| | | | 8 MHz < fмск ≤ 16 MHz | 24/ f мск | | | ns |
| | | | 4 MHz < fмск ≤ 8 MHz | 16/ f мск | | | ns |
| | | | fмск≤4 MHz | 12/ f мск | | | ns |
| | | $1.6 V \le V_b \le 2.0 V$ 20 16 8 N 4 N | 24 MHz < fмск | 96/ f мск | | | ns |
| | | | 20 MHz < fмск ≤ 24 MHz | 72/fмск | | | ns |
| | | | 16 MHz < fмск ≤ 20 MHz | 64/ f мск | | | ns |
| | | | 8 MHz < fмск ≤ 16 MHz | 52/fмск | | | ns |
| | | | 4 MHz < fмск ≤ 8 MHz | 32/fмск | | | ns |
| | | | fмск≤4 MHz | 20/ f мск | | | ns |
| SCKp high-/low-level width | tĸн₂, tĸ∟₂ | $2.7~V \leq EV_{\text{DD0}} \leq 3.6~V,~2.3~V \leq V_{\text{b}} \leq 2.7~V$ | | tkcy2/2 – 36 | | | ns |
| | | $2.4 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V}, T$ | $1.6~V \leq V_b \leq 2.0~V$ | tксү2/2 – 100 | | | ns |
| SIp setup time | tsik2 | $2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 3.6 \text{ V}, 2$ | $2.3~V \leq V_b \leq 2.7~V$ | 1/fмск + 40 | | | ns |
| (to SCKp↑) ^{Note 2} | | $2.4~V \leq EV_{\text{DD0}} < 3.3~V,~1.6~V \leq V_b \leq 2.0~V$ | | 1/fмск + 60 | | | |
| SIp hold time (from SCKp↑) ^{Note 2} | tksi2 | | | 1/fмск + 62 | | | ns |
| Delay time from SCKp↓ to SOp output ^{Note 3} | tĸso2 | $2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 3.6 \text{ V}, 2$ C _b = 30 pF, R _b = 2.7 kΩ | | | | 2/f _{мск} + 428 | ns |
| | | $\label{eq:2.4} \begin{array}{l} 2.4 \ V \leq EV_{\text{DD0}} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | | | | 2/f _{мск} + 1146 | ns |

Notes 1. Transfer rate in the SNOOZE mode : MAX. 1 Mbps

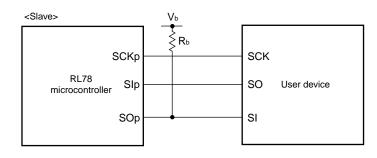
- When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- **3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- Caution Select the TTL input buffer for the SIp pin and SCKp pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the next page.)

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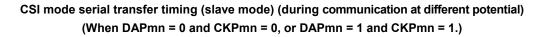


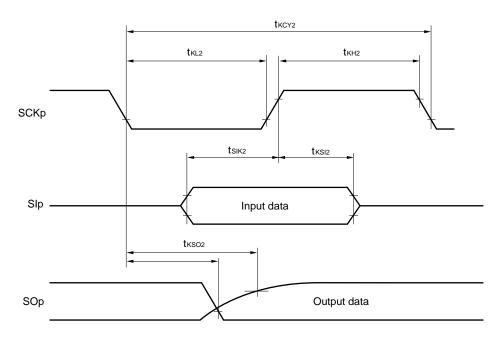
CSI mode connection diagram (during communication at different potential)

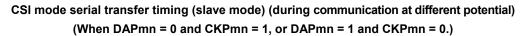


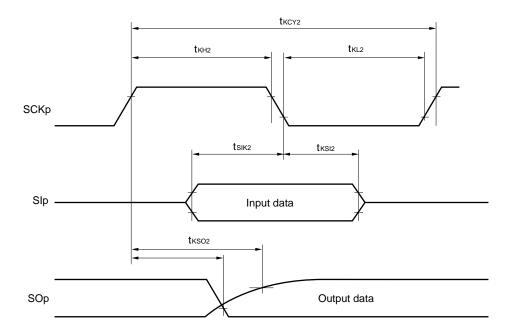
- **Remarks 1.** R_b[Ω]: Communication line (SOp) pull-up resistance, C_b[F]: Communication line (SOp) load capacitance, V_b[V]: Communication line voltage
 - p: CSI number (p = 00, 10, 20), m: Unit number (m = 0, 1), n: Channel number (n = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - fMCK: Serial array unit operation clock frequency
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn).
 m: Unit number, n: Channel number (mn = 00, 02, 10))
 - **4.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.











- **Remarks 1.** p: CSI number (p = 00, 10, 20), m: Unit number, n: Channel number (mn = 00, 02, 10), g: PIM and POM number (g = 0, 1)
 - **2.** CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

(8) Communication at different potential (1.8 V, 2.5 V) (simplified l^2C mode) (1/2)

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

| Parameter | Symbol | Conditions | MIN. | MAX. | Unit |
|---------------------------|--------|---|------|-----------------------|------|
| SCLr clock frequency | fscL | $\label{eq:2.7} \begin{split} & 2.7 \; V \leq E V_{DD0} \leq 3.6 \; V, \\ & 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ & C_{b} = 50 \; pF, \; R_{b} = 2.7 \; k \Omega \end{split}$ | | 400 ^{Note 1} | kHz |
| | | $\label{eq:2.7} \begin{split} & 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, \\ & 2.3 \; V \leq V_b \leq 2.7 \; V, \\ & C_b = 100 \; pF, \; R_b = 2.7 \; k\Omega \end{split}$ | | 100 ^{Note 1} | kHz |
| | | $\label{eq:2.4} \begin{split} & 2.4 \; V \leq EV_{DD0} < 3.3 \; V, \\ & 1.6 \; V \leq V_{b} \leq 2.0 \; V, \\ & C_{b} = 100 \; pF, \; R_{b} = 5.5 \; k\Omega \end{split}$ | | 100 ^{Note 1} | kHz |
| Hold time when SCLr = "L" | t∟ow | $\label{eq:2.7} \begin{split} 2.7 \ V &\leq E V_{DD0} \leq 3.6 \ V, \\ 2.3 \ V &\leq V_b \leq 2.7 \ V, \\ C_b &= 50 \ pF, \ R_b = 2.7 \ k\Omega \end{split}$ | 1200 | | ns |
| | | $\label{eq:2.7} \begin{split} & 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, \\ & 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ & C_{b} = 100 \; pF, \; R_{b} = 2.7 \; k\Omega \end{split}$ | 4600 | | ns |
| | | $\label{eq:2.4} \begin{array}{l} 2.4 \; V \leq E V_{DD0} < 3.3 \; V, \\ 1.6 \; V \leq V_b \leq 2.0 \; V, \\ C_b = 100 \; pF, \; R_b = 5.5 \; k\Omega \end{array}$ | 4650 | | ns |
| Hold time when SCLr = "H" | tніgн | $\label{eq:2.7} \begin{split} 2.7 \ V &\leq E V_{DD0} \leq 3.6 \ V, \\ 2.3 \ V &\leq V_b \leq 2.7 \ V, \\ C_b &= 50 \ pF, \ R_b = 2.7 \ k\Omega \end{split}$ | 500 | | ns |
| | | $\label{eq:2.7} \begin{split} & 2.7 \; V \leq EV_{DD0} \leq 3.6 \; V, \\ & 2.3 \; V \leq V_{b} \leq 2.7 \; V, \\ & C_{b} = 100 \; pF, \; R_{b} = 2.7 \; k\Omega \end{split}$ | 2400 | | ns |
| | | $\label{eq:2.4} \begin{array}{l} 2.4 \; V \leq E V_{DD0} < 3.3 \; V, \\ 1.6 \; V \leq V_b \leq 2.0 \; V, \\ C_b = 100 \; pF, \; R_b = 5.5 \; k\Omega \end{array}$ | 1830 | | ns |

(Notes, Caution and Remarks are listed on the next page.)



| Parameter | Symbol | Conditions | MIN. | MAX. | Unit |
|-------------------------------|---------|---|---|------|------|
| Data setup time (reception) | tsu:dat | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 50 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 1/f _{МСК} + 340 ^{Note 2} | | ns |
| | | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 100 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 1/f _{мск} + 760 ^{Note 2} | | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 100 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | 1/f _{МСК} + 570 ^{Note 2} | | ns |
| Data hold time (transmission) | thd:dat | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 50 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 0 | 770 | ns |
| | | $\begin{array}{l} 2.7 \ V \leq EV_{DD0} \leq 3.6 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 100 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$ | 0 | 1420 | ns |
| | | $\begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 100 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$ | 0 | 1215 | ns |

(8) Communication at different potential (1.8 V, 2.5 V) (simplified I²C mode) (2/2)

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

Notes 1. The value must also be $f_{\text{CLK}}/4$ or lower.

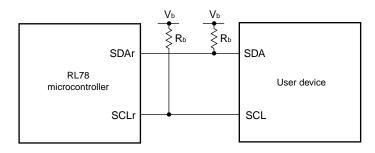
2. Set the fMCK value to keep the hold time of SCLr = "L" and SCLr = "H".

(**Remarks** are listed on the next page.)

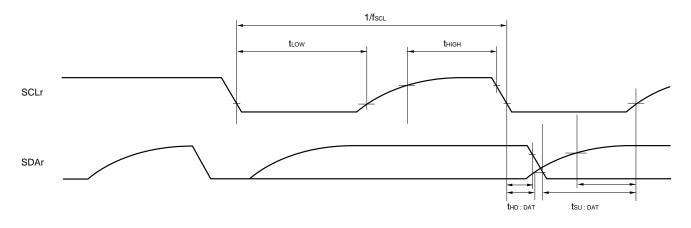
<R>

Caution Select the TTL input buffer and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SDAr pin and the N-ch open drain output (VDD tolerance (When 25- to 48-pin products)/EVDD tolerance (When 64-pin products)) mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

Simplified I²C mode connection diagram (during communication at different potential)



Simplified I²C mode serial transfer timing (during communication at different potential)



- **Remarks 1.** R_b[Ω]: Communication line (SDAr, SCLr) pull-up resistance, C_b[F]: Communication line (SDAr, SCLr) load capacitance, V_b[V]: Communication line voltage
 - **2.** r: IIC number (r = 00, 10, 20), g: PIM, POM number (g = 0, 1)
 - fmck: Serial array unit operation clock frequency
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00, 02, 10)
 - **4.** IIC01, IIC11, and IIC21 cannot communicate at different potential. Use IIC00, IIC10, or IIC20 for communication at different potential.



3.5.2 Serial interface IICA

(1) I^2C standard mode, fast mode

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

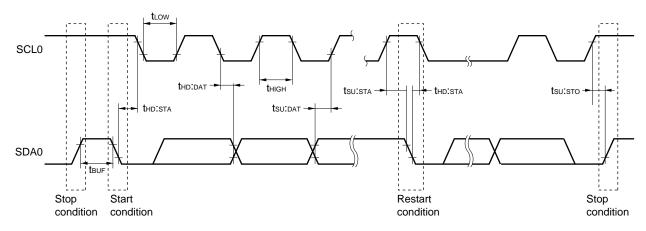
| Parameter | Symbol | Conditions | | Standard Mode | | Fast Mode | | Unit |
|---|--------------|---------------------------|---|------------------|------|-----------|------|------|
| | | | | MIN. | MAX. | MIN. | MAX. | |
| SCLA0 clock frequency | fscL | Fast mode: fc∟κ ≥ 3.5 MHz | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | | | 0 | 400 | kHz |
| | | Normal mode: fc∟ĸ ≥ 1 MHz | $2.4~V \leq EV_{\text{DD0}} \leq 3.6~V$ | 0 | 100 | | | kHz |
| Setup time of restart condition | tsu:sta | | | 4.7 | | 0.6 | | μs |
| Hold time ^{Note 1} | thd:sta | | | 4.0 | | 0.6 | | μs |
| Hold time when SCLA0 = "L" | tLOW | | | 4.7 | | 1.3 | | μs |
| Hold time when SCLA0 = "H" | tніgн | | | 4.0 | | 0.6 | | μs |
| Data setup time (reception) | tsu:dat | | | 250 | | 100 | | ns |
| Data hold time (transmission) ^{Note 2} | thd:dat | | | 0 | 3.45 | 0 | 0.9 | μs |
| Setup time of stop condition | tsu:sto | | | 4.0 | | 0.6 | | μs |
| Bus-free time | t BUF | | | 4.7 | | 1.3 | | μs |

Notes 1. The first clock pulse is generated after this period when the start/restart condition is detected.

- 2. The maximum value (MAX.) of the:DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.
- **Remark** The maximum value of C_b (communication line capacitance) and the value of R_b (communication line pull-up resistor) at that time in each mode are as follows.

 $\begin{array}{ll} \mbox{Standard mode:} & C_b = 400 \mbox{ pF}, \mbox{ } R_b = 2.7 \mbox{ } k\Omega \\ \mbox{Fast mode:} & C_b = 320 \mbox{ } pF, \mbox{ } R_b = 1.1 \mbox{ } k\Omega \\ \end{array}$

IICA serial transfer timing



3.6 Analog Characteristics

3.6.1 A/D converter characteristics

Division of A/D Converter Characteristics

| Reference voltag | Reference voltage (+) = AV _{REFP} Reference voltage (-) = AV _{REFM} | Reference voltage (+) = AV _{DD} Reference voltage (-) = AV _{SS} | Reference voltage (+) = Internal refrence voltage Reference voltage (-) = AVss |
|---|--|--|--|
| High-accuracy channel; ANI0 to ANI12 (input buffer power supply: AV _{DD}) | See 3.6.1 (1) | See 3.6.1 (2) | See 3.6.1 (5) |
| Standard channel; ANI16 to ANI30 (input buffer power supply: Vbb or EVbb0) | See 3.6.1 (3) | See 3.6.1 (4) | |
| Temperature sensor, internal reference voltage output | See 3.6.1 (3) | See 3.6.1 (4) | _ |

<R> (1) When reference voltage (+) = AV_{REFP}/ANI0 (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) = AV_{REFM}/ANI1 (ADREFM = 1), target for conversion: ANI2 to ANI12

 $(T_{A} = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{AV}_{\text{REFP}} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = 0 \text{ V}, \text{AV}_{\text{SS}} = 0 \text{ V}, \text{Reference voltage (+)} = \text{AV}_{\text{REFP}}, \text{Reference voltage (-)} = \text{AV}_{\text{REFM}} = 0 \text{ V})$

| Parameter | Symbol | | Conditions | MIN. | TYP. | MAX. | Unit |
|---|--------|---------------------------------|---|-------|------|--------|------|
| Resolution | Res | | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | 8. | | 12. | bit |
| Overall error ^{Note} | AINL | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±6.0 | LSB |
| Conversion time | tconv | ADTYP = 0, 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | 3.375 | | | μs |
| Zero-scale error ^{Note} | Ezs | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±4.5 | LSB |
| Full-scale error ^{Note} | Ers | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±4.5 | LSB |
| Integral linearity error ^{Note} | ILE | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | LSB |
| Differential linearity error ^{Note} | DLE | 12-bit resolution | $2.4 \text{ V} \le AV_{\text{REFP}} \le AV_{\text{DD}} \le 3.6 \text{ V}$ | | | ±1.5 | LSB |
| Analog input voltage | VAIN | | · | 0 | | AVREFP | V |

Note Excludes quantization error ($\pm 1/2$ LSB).



<R>

(2) When reference voltage (+) = AV_{DD} (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = AV_{ss} (ADREFM = 0), target for conversion: ANI0 to ANI12

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{ V}_{\text{SS}} = 0 \text{ V}, \text{ Reference voltage (+)} = \text{AV}_{\text{DD}}, \text{ Reference voltage (-)} = \text{AV}_{\text{SS}} = 0 \text{ V}$

| Parameter | Symbol | Co | nditions | MIN. | TYP. | MAX. | Unit |
|--|---------------|---------------------------------|--|-------|------|------|------|
| Resolution | Res | | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 8 | | 12 | bit |
| Overall error ^{Note} | AINL | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±7.5 | LSB |
| Conversion time | t CONV | ADTYP = 0, 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 3.375 | | | μs |
| Zero-scale error ^{Note} | Ezs | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±6.0 | LSB |
| Full-scale error ^{Note} | Ers | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±6.0 | LSB |
| Integral linearity error ^{Note} | ILE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.0 | LSB |
| Differential linearity error Note | DLE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | LSB |
| Analog input voltage | VAIN | | | 0 | | AVDD | V |

Note Excludes quantization error ($\pm 1/2$ LSB).



- <R>
- (3) When reference voltage (+) = AV_{REFP}/ANI0 (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) = AV_{REFM}/ANI1 (ADREFM = 1), target for conversion: ANI16 to ANI30, interanal reference voltage, temperature sensor output voltage

 $(T_{A} = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \leq \text{EV}_{\text{DD0}} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}, 2.4 \text{ V} \leq \text{AV}_{\text{REFP}} \leq \text{AV}_{\text{DD}} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V}, \text{AV}_{\text{SS}} = 0 \text{ V}, \text{AV}_{\text{SS}} = 0 \text{ V}, \text{Reference voltage (+)} = \text{AV}_{\text{REFP}}, \text{Reference voltage (-)} = \text{AV}_{\text{REFM}} = 0 \text{ V})$

| Parameter | Symbol | | Conditions | MIN. | TYP. | MAX. | Unit |
|--|---------------|---------------------------------|--|-------|------|----------------------------|------|
| Resolution | Res | | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | 8 | | 12 | bit |
| Overall error ^{Note 1} | AINL | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±7.0 | LSB |
| Conversion time | t CONV | ADTYP = 0, 12-bit resolution | $2.4 \text{ V} \leq \text{AV}_{\text{REFP}} \leq \text{AV}_{\text{DD}} \leq 3.6 \text{ V}$ | 4.125 | | | μs |
| Zero-scale error ^{Note 1} | Ezs | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±5.0 | LSB |
| Full-scale error ^{Note 1} | Ers | 12-bit resolution | $2.4 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±5.0 | LSB |
| Integral linearity error ^{Note 1} | ILE | 12-bit resolution | $2.4 \text{ V} \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6 \text{ V}$ | | | ±3.0 | LSB |
| Differential linearity error ^{Note 1} | DLE | 12-bit resolution | $2.4~V \leq AV_{\text{REFP}} \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.0 | LSB |
| Analog input voltage | Vain | | | 0. | | AVREFP and EVDD0 | V |
| | | | Interanal reference voltage (2.4 V \leq V _{DD} \leq 3.6 V, HS (high-speed main) mode) Temperature sensor output voltage (2.4 V \leq V _{DD} \leq 3.6 V, HS (high-speed main) mode) | | | | V |
| | | • | | | | V _{TMPS25} Note 2 | |

Notes 1. Excludes quantization error (±1/2 LSB).

2. See 3.6.2 Temperature sensor, internal reference voltage output characteristics.



- <R>
- (4) When reference voltage (+) = AV_{DD} (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = AV_{SS} (ADREFM = 0), target for conversion: ANI16 to ANI30, interanal reference voltage, temperature sensor output voltage

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le \text{V}_{\text{DD0}} \le 3.6 \text{ V}, 2.4 \text{ V} \le \text{AV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS0}} = 0 \text{ V}, \text{AV}_{\text{SS}} = 0 \text{ V}, \text{Reference voltage (+)} = \text{AV}_{\text{DD}}, \text{Reference voltage (-)} = \text{AV}_{\text{SS}} = 0 \text{ V})$

| Parameter | Symbol | C | conditions | MIN. | TYP. | MAX. | Unit |
|--|--------|--|--|-------------------------|-------------------------|-------------------|------|
| Resolution | Res | | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 8 | | 12 | bit |
| Overall error ^{Note 1} | AINL | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±8.5 | LSB |
| Conversion time | tconv | ADTYP = 0, 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | 4.125 | | | μs |
| Zero-scale error ^{Note 1} | Ezs | 12-bit resolution | $2.4~\text{V} \leq AV_{\text{DD}} \leq 3.6~\text{V}$ | | | ±8.0 | LSB |
| Full-scale error ^{Note 1} | Ers | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±8.0 | LSB |
| Integral linearity error ^{Note 1} | ILE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±3.5 | LSB |
| Differential linearity error ^{Note 1} | DLE | 12-bit resolution | $2.4~V \leq AV_{\text{DD}} \leq 3.6~V$ | | | ±2.5 | LSB |
| Analog input voltage | Vain | | | 0 | | AVDD and EVDD0 | V |
| | | Interanal reference voltage (2.4 V \leq V _{DD} \leq 3.6 V, HS (high-speed main) mode) | | V _{BGR} Note 2 | | | V |
| | | Temperature sensor (2.4 V \leq V _{DD} \leq 3.6 V, H | output voltage IS (high-speed main) mode) | , | VTMPS25 ^{Note} | 2 | V |

Notes 1. Excludes quantization error ($\pm 1/2$ LSB).

2. See 3.6.2 Temperature sensor, internal reference voltage output characteristics.



<R>

(5) When reference voltage (+) = Internal reference voltage (1.45 V) (ADREFP1 = 1, ADREFP0 = 0), reference voltage (-) = AVss (ADREFM = 0), target for conversion: ANI0 to ANI12, ANI16 to ANI30

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}, 2.4 \text{ V} \le \text{EV}_{DD} \le \text{V}_{DD}, 2.4 \text{ V} \le \text{AV}_{DD} \le \text{V}_{DD}, \text{V}_{SS} = \text{EV}_{SS0} = 0 \text{ V}, \text{AV}_{SS} = 0 \text{ V}, \text{Reference voltage (+) = Internal reference voltage, Reference voltage (-) = AV}_{SS} = 0 \text{ V}, \text{HS (high-speed main) mode)}$

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|--|----------------------|--|------|------|------|------|
| Resolution | Res | | | 8 | | |
| Conversion time | t CONV | 8-bit resolution | 16.0 | | | μs |
| Zero-scale error ^{Note} | Ezs | 8-bit resolution | | | ±4.0 | LSB |
| Integral linearity error ^{Note} | ILE | 8-bit resolution | | | ±2.0 | LSB |
| Differential linearity error ^{Note} | DLE | 8-bit resolution | | | ±2.5 | LSB |
| Reference voltage (+) | AV _{REF(+)} | = Internal reference voltage (V _{BGR}) | 1.38 | 1.45 | 1.50 | V |
| Analog input voltage | VAIN | | 0 | | Vbgr | V |

Note Excludes quantization error ($\pm 1/2$ LSB).

3.6.2 Temperature sensor, internal reference voltage output characteristics

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|-----------------------------------|---------|---|------|------|------|-------|
| Temperature sensor output voltage | VTMPS25 | Setting ADS register = 80H, T _A = +25°C | | 1.05 | | V |
| Internal reference voltage | VBGR | Setting ADS register = 81H | 1.38 | 1.45 | 1.5 | V |
| Temperature coefficient | FVTMPS | Temperature sensor output voltage that depends on the temperature | | -3.6 | | mV/°C |
| Operation stabilization wait time | tamp | | 10 | | | μs |

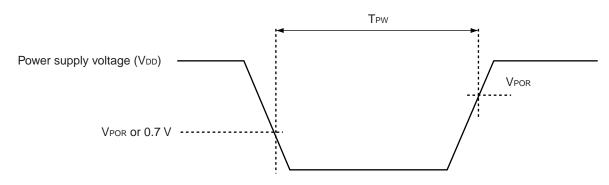
(TA = -40 to +105°C, 2.4 V \leq VDD \leq 3.6 V, Vss = 0 V, HS (high-speed main) mode)

3.6.3 POR circuit characteristics

(T_A = -40 to +105°C, Vss = 0 V)

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|-------------------------------------|--------|------------------------|------|------|------|------|
| Detection voltage | VPOR | Power supply rise time | | 1.51 | 1.57 | V |
| | VPDR | Power supply fall time | 1.44 | 1.50 | 1.56 | V |
| Minimum pulse width ^{Note} | TPW | | 300 | | | μs |

Note This is the time required for the POR circuit to execute a reset when V_{DD} falls below V_{PDR}. When the microcontroller enters STOP mode or if the main system clock (f_{MAIN}) has been stopped by setting bit 0 (HIOSTOP) and bit 7 (MSTOP) of the clock operation status control register (CSC), this is the time required for the POR circuit to execute a reset before V_{DD} rises to V_{POR} after having fallen below 0.7 V.





3.6.4 LVD circuit characteristics

| | Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---------------------|----------------------|--------|------------------------|------|------|------|------|
| Detection | Supply voltage level | VLVD2 | Power supply rise time | 3.01 | 3.13 | 3.25 | V |
| voltage | | | Power supply fall time | 2.94 | 3.06 | 3.18 | V |
| | | VLVD3 | Power supply rise time | 2.90 | 3.02 | 3.14 | V |
| | | | Power supply fall time | 2.85 | 2.96 | 3.07 | V |
| | | VLVD4 | Power supply rise time | 2.81 | 2.92 | 3.03 | V |
| | | | Power supply fall time | 2.75 | 2.86 | 2.97 | V |
| | | VLVD5 | Power supply rise time | 2.70 | 2.81 | 2.92 | V |
| | | | Power supply fall time | 2.64 | 2.75 | 2.86 | V |
| | | VLVD6 | Power supply rise time | 2.61 | 2.71 | 2.81 | V |
| | | | Power supply fall time | 2.55 | 2.65 | 2.75 | V |
| | | VLVD7 | Power supply rise time | 2.51 | 2.61 | 2.71 | V |
| | | | Power supply fall time | 2.45 | 2.55 | 2.65 | V |
| Minimum pulse width | | t∟w | | 300 | | | μs |
| Detection d | elay time | | | | | 300 | μs |

LVD Detection Voltage of Reset Mode and Interrupt Mode (TA = -40 to +105°C, VPDR \leq VDD \leq 3.6 V, Vss = 0 V)

Remark $V_{LVD (n-1)} > V_{LVDn}$: n = 3 to 7

LVD Detection Voltage of Interrupt & Reset Mode

(TA = -40 to +105°C, VPDR \leq VDD \leq 3.6 V, Vss = 0 V)

| Parameter | Symbol | | Cond | ditions | MIN. | TYP. | MAX. | Unit |
|-------------------|--------|------|---------------------|------------------------------|------|------|------|------|
| Interrupt & reset | VLVD5 | VPOC | 2, VPOC1, VPOC0 = 0 | 2.64 | 2.75 | 2.86 | V | |
| mode | VLVD4 | | LVIS1, LVIS0 = 1, 0 | Rising release reset voltage | 2.81 | 2.92 | 3.03 | V |
| | | | | Falling interrupt voltage | 2.75 | 2.86 | 2.97 | V |
| | VLVD3 | | LVIS1, LVIS0 = 0, 1 | Rising release reset voltage | 2.90 | 3.02 | 3.14 | V |
| | | | | Falling interrupt voltage | 2.85 | 2.96 | 3.07 | V |

Caution Set the detection voltage (VLVD) to be within the operating voltage range. The operating voltage range depends on the setting of the user option byte (000C2H/010C2H). The following shows the operating voltage range.

HS (high-speed main) mode: VDD = 2.7 to 3.6 V@1 MHz to 32 MHz

VDD = 2.4 to 3.6 V@1 MHz to 16 MHz

3.6.5 Supply voltage rise slope characteristics

(T_A = -40 to +105°C, Vss = 0 V)

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---------------------|--------|------------|------|------|------|------|
| Supply voltage rise | SVDD | | | | 54 | V/ms |

Caution Be sure to maintain the internal reset state until VDD reaches the operating voltage range specified in 3.4 AC Characteristics, by using the LVD circuit or external reset pin.

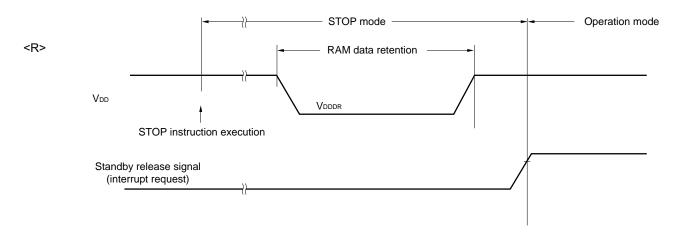


<R> 3.7 RAM Data Retention Characteristics

<R> (T_A = -40 to +105°C, Vss = 0 V)

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|-------------------------------|--------|------------|----------------------|------|------|------|
| Data retention supply voltage | VDDDR | | 1.44 ^{Note} | | 3.6 | V |

<R> Note This depends on the POR detection voltage. For a falling voltage, data in RAM are retained until the voltage reaches the level that triggers a POR reset but not once it reaches the level at which a POR reset is generated.



3.8 Flash Memory Programming Characteristics

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|--|--------|--|---------|-----------|------|-------|
| CPU/peripheral hardware clock frequency | fськ | $2.4~V \leq V_{\text{DD}} \leq 3.6~V$ | 1 | | 32 | MHz |
| Number of code flash rewrites ^{Notes 1, 2, 3} | Cerwr | Retained for 20 years T _A = 85°C | 1,000 | | | Times |
| Number of data flash rewrites ^{Notes 1, 2, 3} | | Retained for 1 years T _A = 25°C | | 1,000,000 | | |
| | | Retained for 5 years T _A = 85°C | 100,000 | | | |
| | | Retained for 20 years T _A = 85°C | 10,000 | | | |

$(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}, \text{V}_{SS} = 0 \text{ V})$

Notes 1. 1 erase + 1 write after the erase is regarded as 1 rewrite.

The retaining years are until next rewrite after the rewrite.

- 2. When using flash memory programmer and Renesas Electronics self programming library
- **3.** These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.
- 4. This temperature is the average value at which data are retained.

<R>

R01DS0151EJ0210 Rev.2.10 Nov 30, 2016

3.9 Dedicated Flash Memory Programmer Communication (UART)

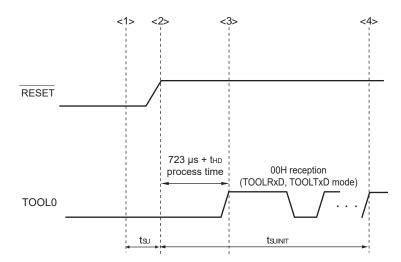
| (| $T_{A} = -40$ to +105°C | 24V <fv000<< th=""><th>$V_{DD} < 3.6 V$</th><th>Vss = EVsso = 0 V)</th></fv000<<> | $V_{DD} < 3.6 V$ | Vss = EVsso = 0 V) |
|---|-------------------------|---|---------------------|------------------------------|
| | 1A = -40 10 + 103 0 | , 2.4 V > L V D D V > | vuu <u>5</u> 5.0 v, | $v_{33} - Lv_{330} - Uv_{j}$ |

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD}} \le \text{V}_{\text{DD}} \le 3.6 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = 0 \text{ V})$

| Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---------------|--------|---------------------------------|---------|------|------|------|
| Transfer rate | | During flash memory programming | 115.2 k | | 1 M | bps |

3.10 Timing Specs for Switching Flash Memory Programming Modes

| | Parameter | Symbol | Conditions | MIN. | TYP. | MAX. | Unit |
|---------|---|---------|--|------|------|------|------|
| | How long from when an external reset ends until the initial communication settings are specified | tsuinit | POR and LVD reset must end before the external reset ends. | | | 100 | ms |
| | How long from when the TOOL0 pin is placed at the low level until a external reset ends | ts∪ | POR and LVD reset must end before the external reset ends. | 10 | | | μs |
| <r></r> | How long the TOOL0 pin must be kept at the low level after an external reset ends (except flash firmware processing time) | tно | POR and LVD reset must end before the external reset ends. | 1 | | | ms |



<R>

- <1> The low level is input to the TOOL0 pin.
- <2> The pins reset ends (POR and LVD reset must end before the external reset ends.).
- <3> The TOOL0 pin is set to the high level.
- <4> Setting of the flash memory programming mode by UART reception and complete the baud rate setting.

Remark tsuinit: The segment shows that it is necessary to finish specifying the initial communication settings within 100 ms from when the resets end.

 t_{SU} : How long from when the TOOL0 pin is placed at the low level until a external reset ends

t_{HD}: How long to keep the TOOL0 pin at the low level from when the external resets end (except flash firmware processing time)

<R>

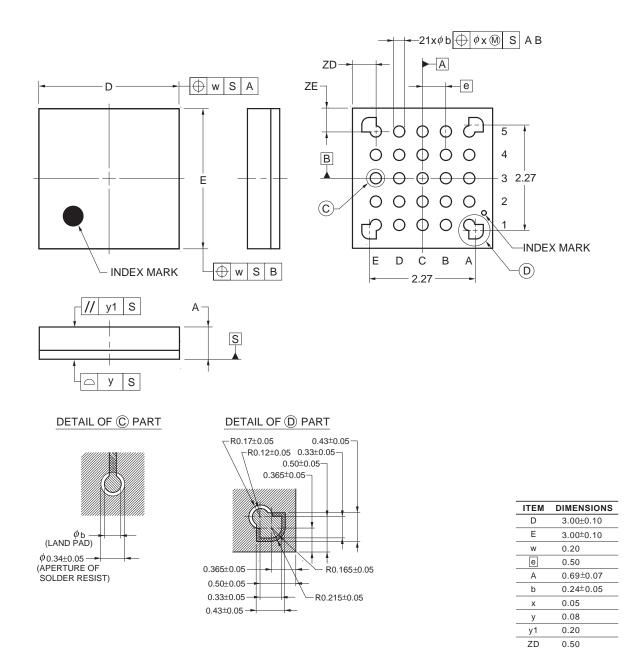
4. PACKAGE DRAWINGS

4.1 25-pin products

R5F10E8AALA, R5F10E8CALA, R5F10E8DALA, R5F10E8EALA

| <r></r> | JEITA Package Code | RENESAS Code | Previous Code | MASS (Typ) [g] |
|---------|--------------------|--------------|----------------|----------------|
| | P-WFLGA25-3x3-0.50 | PWLG0025KA-A | P25FC-50-2N2-3 | 0.01 |

Unit: mm



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ZE

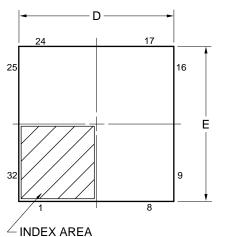
0.50



4.2 32-pin products

R5F10EBAANA, R5F10EBCANA, R5F10EBDANA, R5F10EBEANA R5F10EBAGNA, R5F10EBCGNA, R5F10EBDGNA, R5F10EBEGNA

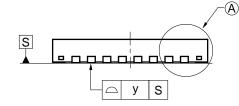
| JEITA Package code | RENESAS code | Previous code | MASS(TYP.)[g] |
|--------------------|--------------|----------------|---------------|
| P-HWQFN32-5x5-0.50 | PWQN0032KB-A | P32K8-50-3B4-5 | 0.06 |

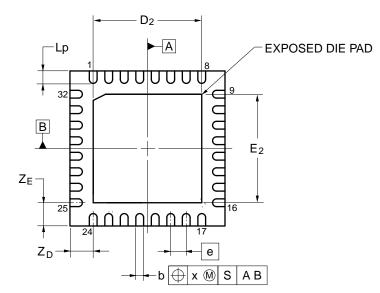




C₂

A₁





| Referance | Dimens | sion in Mil | limeters |
|----------------|--------|-------------|----------|
| Symbol | Min | Nom | Max |
| D | 4.95 | 5.00 | 5.05 |
| E | 4.95 | 5.00 | 5.05 |
| A | | _ | 0.80 |
| A ₁ | 0.00 | _ | _ |
| b | 0.18 | 0.25 | 0.30 |
| е | | 0.50 | |
| Lp | 0.30 | 0.40 | 0.50 |
| х | | | 0.05 |
| у | | | 0.05 |
| Z _D | | 0.75 | |
| Z _E | | 0.75 | |
| c ₂ | 0.15 | 0.20 | 0.25 |
| D ₂ | | 3.50 | |
| E ₂ | | 3.50 | |

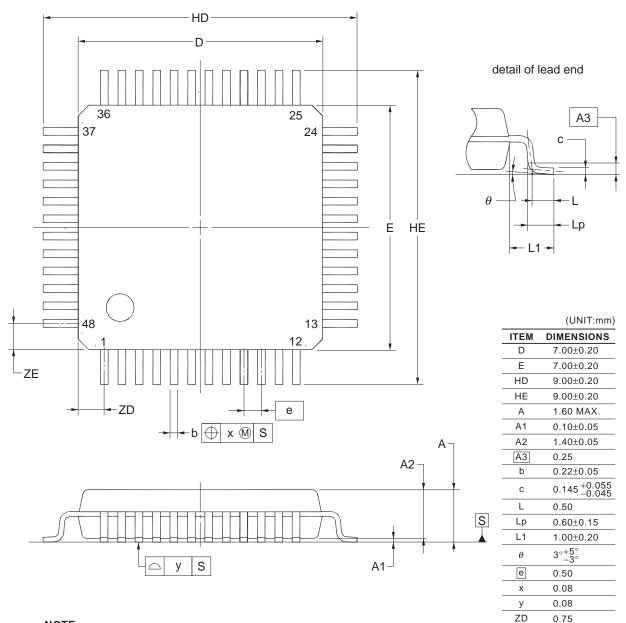
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4.3 48-pin products

R5F10EGAAFB, R5F10EGCAFB, R5F10EGDAFB, R5F10EGEAFB R5F10EGAGFB, R5F10EGCGFB, R5F10EGDGFB, R5F10EGEGFB

| JEITA Package Code | RENESAS Code | Previous Code | MASS (TYP.) [g] |
|--------------------|--------------|----------------|-----------------|
| P-LFQFP48-7x7-0.50 | PLQP0048KF-A | P48GA-50-8EU-1 | 0.16 |



NOTE

Each lead centerline is located within 0.08 mm of its true position at maximum material condition.

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ZE

0.75



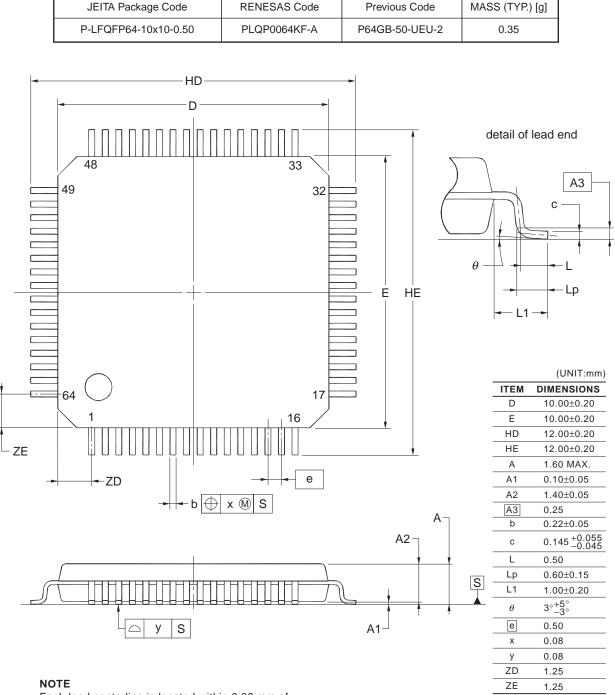
R5F10EGAANA, R5F10EGCANA, R5F10EGDANA, R5F10EGEANA R5F10EGAGNA, R5F10EGCGNA, R5F10EGDGNA, R5F10EGEGNA

| JEITA Package Code | RENESAS Code | Previous Code | | SS (Typ) [|
|---|--------------|---------------------------|---|------------|
| P-HWQFN48-7x7-0.50 | PWQN0048KB-A | 48PJN-A P48K8-50-5B4-7 | 7 | 0.13 |
| 36 25 37 48 1 12 INDEX AREA | | DETAIL C | | Unit: |
| | | | | |
| S ennnnnnnnn y s | | | | |

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4.4 64-pin products

R5F10ELCAFB, R5F10ELDAFB, R5F10ELEAFB R5F10ELCGFB, R5F10ELDGFB, R5F10ELEGFB

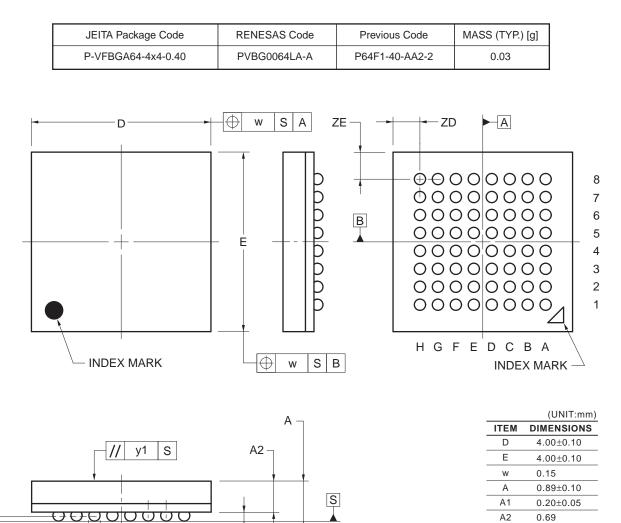


Each lead centerline is located within 0.08 mm of its true position at maximum material condition.

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R5F10ELCABG, R5F10ELDABG, R5F10ELEABG





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0.05

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0.60

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- A1



Revision History

RL78/G1A Data Sheet

| | | Description | | | |
|------|--------------|------------------------------|--|--|--|
| Rev. | Date | Page | Summary | | |
| 0.01 | Dec 26, 2011 | - | First Edition issued | | |
| 1.00 | Sep 25, 2013 | p.1 | Modification of 1.1 Features | | |
| | | p.4 | Modification of Table 1-1. List of Ordering Part Numbers | | |
| | | | Modification of Remark 3 to 1.3.2 32-pin products. | | |
| | | | Modification of 1.5.2 32-pin products. | | |
| | | p.14 | Modification of 1.5.3 48-pin products. | | |
| | | p.16 | Modification of 1.6 Outline of Functions | | |
| | | p.21 | Modification of 2.2.1 X1, XT1 oscillator characteristics | | |
| | | p.31, 32 | Modification of Note 1 in 2.3.2 Supply current characteristics | | |
| | | p.34, 35 | Modification of Minimum Instruction Execution Time during Main System Clock Operation | | |
| | | p.37 | Modification of AC Timing Test Points in 2.5 Peripheral Functions Characteristics | | |
| | | p.46 to 58 | Modification of Caution to 2.5.1 Serial array unit. | | |
| | | p.63 to 68 | Modification of 2.6.1 A/D converter characteristics | | |
| | | p.71 | Modification of 2.7 Data Memory STOP Mode Low Supply Voltage Data Retention Characteristics | | |
| | | p.71 | Modification of 2.8 Flash Memory Programming Characteristics | | |
| | | p.72 | Modification of 2.10 Timing Specs for Switching Flash Memory Programming Modes | | |
| | | p.73 to | Addition of 3 ELECTRICAL SPECIFICATIONS (G: INDUSTRIAL | | |
| | | 117 | APPLICATIONS TA = -40 to $+105^{\circ}$ C) | | |
| | | p.118 to 123 | Modification of 4. PACKAGE DRAWINGS | | |
| 2.10 | Nov 30, 2016 | p.4 | Modification of Table 1-1. List of Ordering Part Numbers | | |
| | | p.5 to 10 | Modification of the position of the index mark in 1.3.1 25-pin products to 1.3.4 64-pin products | | |
| | | p.6 | Modification of Remark 3 | | |
| | | p.13 | Modification of 1.5.2 32-pin products | | |
| | | p.14 | Modification of 1.5.3 48-pin products | | |
| | | p.16 | Modification of description in 1.6 Outline of Functions | | |
| | | p.21 | Modification of 2.2.1 X1, XT1 oscillator characteristics | | |
| | | p.31, 32 | Modification of Note 1 in 2.3.2 Supply current characteristics | | |
| | | p.34, 35 | Modification of Minimum Instruction Execution Time during Main System Clock Operation | | |
| | | p.36 | Modification of AC Timing Test Points and TI/TO Timing | | |
| | | p.38 | Modification of AC Timing Test Points in 2.5 Peripheral Functions Characteristics | | |
| | | p.48, 50 to 52, 55, 59 | Modification of Caution in 2.5.1 Serial array unit | | |
| | | p.64 to 69 | Modification of conditions of 2.6.1 A/D converter characteristics | | |
| | | p.72 | Renamed to 2.7 RAM Data Retention Characteristics, and modification of note and figure | | |
| | | p.72 | Modification of 2.8 Flash Memory Programming Characteristics | | |

| | | | Description |
|------|--------------|-----------------------|--|
| Rev. | Date | Page | Summary |
| 2.10 | Nov 30, 2016 | p.73 | Modification of 2.10 Timing Specs for Switching Flash Memory Programming Modes |
| | | p.77 | Modification of 3.2.1 X1, XT1 oscillator characteristics |
| | | p.78, 79 | Modification of 3.3.1 Pin characteristics |
| | | p.88 | Modification of 3.3.2 Supply current characteristics |
| | | p.90 | Modification of Minimum Instruction Execution Time during Main System Clock Operation |
| | | p.91 | Modification of AC Timing Test Points and TI/TO Timing |
| | | p.93 | Modification of AC Timing Test Points in 3.5 Peripheral Functions Characteristics |
| | | p.95 | Modification of 3.5.1 Serial array unit |
| | | p.99, 100, 102, | Modification of Caution in 2.5.1 Serial array unit |
| | | 103, 105, 109 | |
| | | p.112 to 116 | Modification of 3.6.1 (1) to (5) |
| | | p.118 | Renamed to 3.7 RAM Data Retention Characteristics, and modification of note and figure |
| | | p.118 | Addition of note 4 to 3.8 Flash Memory Programming Characteristics |
| | | p.119 | Modification of 3.10 Timing Specs for Switching Flash Memory Programming Modes |
| | | p.120 | Modification of 4.1 25-pin products |
| | | p.123 | Modification of 4.3 48-pin products |

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NOTES FOR CMOS DEVICES

- (1) VOLTAGE APPLICATION WAVEFORM AT INPUT PIN: Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between VIL (MAX) and VIH (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between VIL (MAX) and VIH (MIN).
- (2) HANDLING OF UNUSED INPUT PINS: Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.
- (3) PRECAUTION AGAINST ESD: A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.
- (4) STATUS BEFORE INITIALIZATION: Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.
- (5) POWER ON/OFF SEQUENCE: In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current. The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.
- (6) INPUT OF SIGNAL DURING POWER OFF STATE : Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

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